



# Integrated, Dual RF Transceiver with Observation Path

## Data Sheet

**AD9375**

### FEATURES

- Dual differential Tx
- Dual differential Rx
- Observation receiver with 2 inputs
- Fully integrated, ultralow power DPD actuator and adaptation engine for PA linearization
- Sniffer receiver with 3 inputs
- Tunable range: 300 MHz to 6000 MHz
- Linearization signal BW to 40 MHz
- Tx synthesis BW to 250 MHz
- Rx BW: 8 MHz to 100 MHz
- Supports FDD and TDD operation
- Fully integrated independent fractional-N RF synthesizers for Tx, Rx, ORx, and clock generation
- JESD204B digital interface

### APPLICATIONS

- 3G/4G small cell base transceiver station (BTS)
- 3G/4G massive MIMO/active antenna systems

### GENERAL DESCRIPTION

The **AD9375** is a highly integrated, wideband radio frequency (RF) transceiver offering dual-channel transmitters (Tx) and receivers (Rx), integrated synthesizers, a fully integrated digital predistortion (DPD) actuator and adaptation engine, and digital signal processing functions. The IC delivers a versatile combination of high performance and low power consumption required by 3G/4G small cell and massive multiple input, multiple output (MIMO) equipment in both frequency division duplex (FDD) and time division duplex (TDD) applications. The **AD9375** operates from 300 MHz to 6000 MHz, covering most of the licensed and unlicensed cellular bands. The DPD algorithm supports linearization on signal bandwidths up to 40 MHz depending on the power amplifier (PA) characteristics (for example, two adjacent 20 MHz carriers). The IC supports Rx bandwidths up to 100 MHz. It also supports observation receiver (ORx) and Tx synthesis bandwidths up to 250 MHz to accommodate digital correction algorithms.

The transceiver consists of wideband direct conversion signal paths with state-of-the-art noise figure and linearity. Each complete Rx and Tx subsystem includes dc offset correction, quadrature error correction (QEC), and programmable digital filters, eliminating the need for these functions in the digital baseband. Several auxiliary functions such as an auxiliary analog-to-digital converter (ADC), auxiliary digital-to-analog converters (DACs), and general-purpose input/output (GPIOs) are integrated to provide additional monitoring and control capability.

An ORx channel with two inputs is included to monitor each Tx output and implement calibration applications. This channel also connects to three sniffer receiver (SnRx) inputs that can monitor radio activity in different bands.

The high speed JESD204B interface supports lane rates up to 6144 Mbps. Four lanes are dedicated to the transmitters and four lanes are dedicated to the receiver and observation receiver channels.

The fully integrated phase-locked loops (PLLs) provide high performance, low power, fractional-N frequency synthesis for the Tx, the Rx, the ORx, and the clock sections. Careful design and layout techniques provide the isolation demanded in high performance base station applications. All voltage controlled oscillator (VCO) and loop filter components are integrated to minimize the external component count.

The device contains a fully integrated, low power DPD actuator and adaptation engine for use in PA linearization. The DPD feature enables use of high efficiency PAs, significantly reducing the power consumption of small cell base station radios while also reducing the number of JESD204B lanes necessary to interface with baseband processors.

A 1.3 V supply is required to power the **AD9375** core, and a standard 4-wire serial port controls it. Other voltage supplies provide proper digital interface levels and optimize transmitter and auxiliary converter performance. The **AD9375** is packaged in a 12 mm × 12 mm, 196-ball chip scale ball grid array (CSP\_BGA).

Rev. 0

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## TABLE OF CONTENTS

Features .....	1	Theory of Operation .....	56
Applications.....	1	Transmitter (Tx) .....	56
General Description .....	1	Receiver (Rx).....	56
Revision History .....	2	Observation Receiver (ORx).....	56
Functional Block Diagram .....	3	Sniffer Receiver (SnRx) .....	56
Specifications.....	4	Clock Input.....	56
Current and Power Consumption Specifications.....	10	Synthesizers.....	57
Timing Specifications .....	12	Serial Peripheral Interface (SPI).....	57
Absolute Maximum Ratings.....	14	GPIO_x AND GPIO_3P3_x Pins .....	57
Reflow Profile.....	14	Auxiliary Converters.....	57
Thermal Resistance .....	14	JESD204B Data Interface .....	58
ESD Caution.....	14	Power Supply Sequence .....	58
Pin Configuration and Function Descriptions.....	15	Digital Predistortion (DPD) .....	59
Typical Performance Characteristics .....	18	JTAG Boundary Scan.....	60
700 MHz Band .....	18	Outline Dimensions .....	61
2.6 GHz Band .....	28	Ordering Guide .....	61
3.5 GHz Band .....	38		
5.5 GHz Band .....	48		

## REVISION HISTORY

3/2017—Revision 0: Initial Version

## FUNCTIONAL BLOCK DIAGRAM

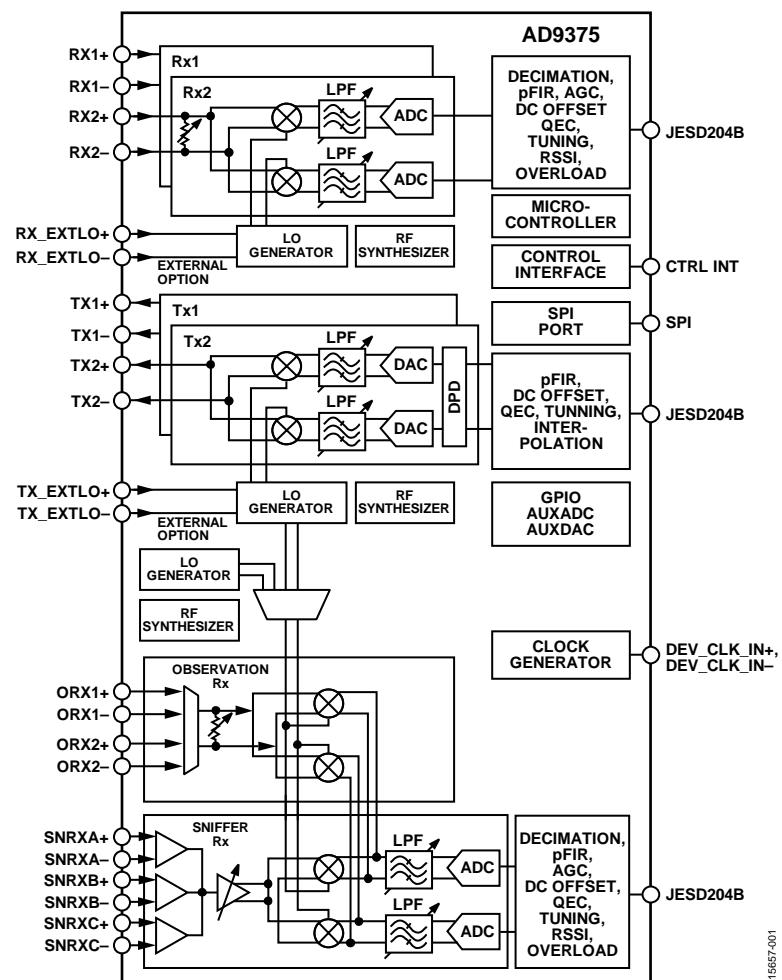


Figure 1.

## SPECIFICATIONS

Electrical characteristics at ambient temperature range, VDDA\_SER = 1.3 V, VDDA\_DES = 1.3 V, JESD\_VTT\_DES = 1.3 V, VDDA\_1P3<sup>1</sup> = 1.3 V, VDIG = 1.3 V, VDDA\_1P8 = 1.8 V, VDD\_IF = 2.5 V, and VDDA\_3P3 = 3.3 V; all RF specifications based on measurements that include printed circuit board (PCB) and matching circuit losses, unless otherwise noted.

Table 1.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
TRANSMITTERS (Tx)						
Center Frequency		300		6000	MHz	
Tx Large Signal Bandwidth (BW)						
Normal Operation				100	MHz	
DPD Activated				40	MHz	
Tx Synthesis BW <sup>2</sup>				250	MHz	
BW Flatness			±0.5		dB	Wider bandwidth for use in digital processing algorithms
			±0.15		dB	250 MHz BW, compensated by programmable finite impulse response (pFIR) filter
Deviation from Linear Phase		0	10		Degrees	Any 20 MHz BW span, compensated by pFIR filter
Power Control Range				42	dB	250 MHz BW
Power Control Resolution			0.05		dB	Increased calibration time, reduced QEC <sup>3</sup> , LOL <sup>4</sup> performance beyond 20 dB
ACLR <sup>5</sup> (Four Universal Mobile Telecommunications System (UMTS) Carriers)						–11.2 dBFS rms, 0 dB RF attenuation
700 MHz Local Oscillator (LO)			–64		dB	
2600 MHz LO			–64		dB	
3500 MHz LO			–63		dB	
5500 MHz LO			–61		dB	
In Band Noise			–155		dBFS <sup>6</sup> /Hz	
Tx to Tx Isolation						
700 MHz LO			70		dB	
2600 MHz LO			65		dB	
3500 MHz LO			65		dB	
5500 MHz LO			50		dB	
Image Rejection						Up to 20 dB RF attenuation, within large signal BW, QEC <sup>3</sup> active
700 MHz LO			65		dB	
2600 MHz LO			65		dB	
3500 MHz LO			65		dB	
5500 MHz LO			50		dB	
Maximum Output Power						0 dBFS, 1 MHz signal input, 50 Ω load, 0 dB RF attenuation
700 MHz LO			7		dBm	
2600 MHz LO			7		dBm	
3500 MHz LO			6		dBm	
5500 MHz LO			4		dBm	
Output Third-Order Intercept Point	OIP3					–5 dBFS rms, 0 dB RF attenuation
700 MHz LO			27		dBm	
2600 MHz LO			27		dBm	
3500 MHz LO			25		dBm	
5500 MHz LO			25		dBm	

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
Carrier Leakage						After calibration, LOL correction active, CW <sup>7</sup> input signal, 3 dB RF and 3 dB digital attenuation, 40 kHz measurement BW
700 MHz LO			-81		dBFS <sup>6</sup>	
2600 MHz LO			-81		dBFS <sup>6</sup>	
3500 MHz LO			-81		dBFS <sup>6</sup>	
5500 MHz LO			-75		dBFS <sup>6</sup>	
Error Vector Magnitude (3GPP Test Signals)	EVM					Long-term evolution (LTE) 20 MHz downlink, 5 dB RF attenuation
700 MHz LO			-45		dB	
2600 MHz LO			-39		dB	
3500 MHz LO			-38.5		dB	
5500 MHz LO			-37.5		dB	
Output Impedance			50		Ω	Differential
RECEIVERS (Rx)						
Center Frequency		300		6000	MHz	
Gain Range		0		30	dB	
Analog Gain Step			0.5		dB	
BW Ripple			±0.5		dB	100 MHz BW, compensated by programmable FIR filter
				±0.2	dB	Any 20 MHz span, compensated by programmable FIR filter
Rx Bandwidth		8		100	MHz	Analog low-pass filter (LPF) BW is 20 MHz minimum, programmable FIR BW configurable over the entire range
Rx Alias Band Rejection		75			dB	
Maximum Recommended Input Power <sup>8</sup>			-14		dBm	Due to digital filters Input is a CW <sup>7</sup> signal at a 0 dB attenuation setting; this level increases decibel for decibel with attenuation
Noise Figure	NF					Maximum Rx gain, at Rx port, matching losses de-embedded
700 MHz LO			12		dB	
2600 MHz LO			13.5		dB	
3500 MHz LO			14		dB	
5500 MHz LO			18		dB	
Input Third-Order Intercept Point	IIP3					Maximum Rx gain, third- order intermodulation (IM3) 1 MHz offset from LO
700 MHz LO			22		dBm	
2600 MHz LO			22		dBm	
3500 MHz LO			20		dBm	
5500 MHz LO			20		dBm	
Input Second-Order Intercept Point	IIP2					Maximum Rx gain, second- order intermodulation (IM2) 1 MHz offset from LO
700 MHz LO			65		dBm	
2600 MHz LO			65		dBm	
3500 MHz LO			65		dBm	
5500 MHz LO			57		dBm	

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
Image Rejection						QEC <sup>3</sup> active, within Rx BW
700 MHz LO			75		dB	
2600 MHz LO			75		dB	
3500 MHz LO			75		dB	
5500 MHz LO			75		dB	
Input Impedance			200		Ω	Differential
Tx1 to Rx1 Signal Isolation and Tx2 to Rx2 Signal Isolation						
700 MHz LO			68		dB	
2600 MHz LO			68		dB	
3500 MHz LO			62		dB	
5500 MHz LO			60		dB	
Tx1 to Rx2 Signal Isolation and Tx2 to Rx1 Signal Isolation						
700 MHz LO			70		dB	
2600 MHz LO			70		dB	
3500 MHz LO			62		dB	
5500 MHz LO			60		dB	
Rx1 to Rx2 Signal Isolation						
700 MHz LO			60		dB	
2600 MHz LO			60		dB	
3500 MHz LO			60		dB	
5500 MHz LO			60		dB	
Rx Band Spurs Referenced to RF Input at Maximum Gain			–95		dBm	No more than one spur at this level per 10 MHz of Rx BW; excludes harmonics of the reference clock
Rx LO Leakage at Rx Input at Maximum Gain						Leakage decreases decibel for decibel with attenuation for first 12 dB
700 MHz LO			–65		dBm	
2600 MHz LO			–65		dBm	
3500 MHz LO			–62		dBm	
5500 MHz LO			–62		dBm	
OBSERVATION RECEIVER (ORx)						
Center Frequency		300		6000	MHz	
Gain Range		0		18	dB	
Analog Gain Step			1		dB	
BW Ripple			±0.5		dB	250 MHz RF BW, compensated by programmable FIR filter
Deviation from Linear Phase			10		Degrees	250 MHz RF BW
ORx Bandwidth				250	MHz	
ORx Alias Band Rejection		60			dB	Due to digital filters
Maximum Recommended Input Power <sup>8</sup>			–13		dBm	Input is a CW <sup>7</sup> signal at 0 dB attenuation setting; this level increases decibel for decibel with attenuation
Signal-to-Noise Ratio <sup>9</sup>	SNR					Maximum gain at ORx port
700 MHz LO			60		dB	
2600 MHz LO			60		dB	
3500 MHz LO			60		dB	
5500 MHz LO			59		dB	200 MHz BW, 245.76 MSPS

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
Input Third-Order Intercept Point	IIP3					Maximum ORx gain, IM3 1 MHz offset from LO
700 MHz LO			22		dBm	
2600 MHz LO			22		dBm	
3500 MHz LO			18		dBm	
5500 MHz LO			18		dBm	
Input Second-Order Intercept Point	IIP2					Maximum ORx gain, IM2 1 MHz offset from LO
700 MHz LO			65		dBm	
2600 MHz LO			65		dBm	
3500 MHz LO			65		dBm	
5500 MHz LO			60		dBm	
Image Rejection						After online tone calibration
700 MHz LO			65		dB	
2600 MHz LO			65		dB	
3500 MHz LO			65		dB	
5500 MHz LO			65		dB	
Input Impedance			200		Ω	Differential
Tx1 to ORx1 Signal and Tx2 to ORx2 Signal Isolation						
700 MHz LO			70		dB	
2600 MHz LO			70		dB	
3500 MHz LO			70		dB	
5500 MHz LO			70		dB	
Tx1 to ORx2 Signal and Tx2 to ORx1 Signal Isolation						
700 MHz LO			70		dB	
2600 MHz LO			70		dB	
3500 MHz LO			70		dB	
5500 MHz LO			70		dB	
SNIFFER RECEIVER (SnRx)						
Center Frequency		300		6000	MHz	
Gain Range		0		52	dB	
Analog Gain Step			1		dB	
BW Ripple			±0.5		dB	20 MHz RF BW, compensated by programmable FIR filter
Rx Bandwidth				20	MHz	
Rx Alias Band Rejection		60			dB	Due to digital filters
Maximum Recommended Input Power <sup>8</sup>			-26		dBm	Input is a CW <sup>7</sup> signal at 0 dB attenuation setting
Noise Figure	NF					Maximum gain at SnRx port, matching losses de-embedded
700 MHz LO			5		dB	
2600 MHz LO			5		dB	
3500 MHz LO			7		dB	
Input Third-Order Intercept Point	IIP3					Maximum gain, IM3 1 MHz offset from LO, gain control limited to the first 20 steps
700 MHz LO			1		dBm	
2600 MHz LO			1		dBm	
3500 MHz LO			1		dBm	

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
Input Second-Order Intercept Point	IIP2					Maximum gain, IM2 1 MHz offset from LO, gain control limited to the first 20 steps
700 MHz LO			45		dBm	
2600 MHz LO			45		dBm	
3500 MHz LO			45		dBm	
Image Rejection						After online tone calibration
700 MHz LO			75		dB	
2600 MHz LO			75		dB	
3500 MHz LO			75		dB	
Input Impedance			400		$\Omega$	Differential
Tx1 to SnRx Signal and Tx2 to SnRx Signal Isolation						Applies to each SnRx input
700 MHz LO			60		dB	
2600 MHz LO			60		dB	
3500 MHz LO			60		dB	
LO SYNTHESIZER						
LO Frequency Step			2.3		Hz	1.5 GHz to 3 GHz, 76.8 MHz phase frequency detector (PFD) frequency
LO Spur			−80		dBc	Excludes integer boundary spurs 1 kHz to 100 MHz
Spot Phase Noise						
700 MHz LO						
10 kHz			−104		dBc	
100 kHz			−107		dBc	
1 MHz			−133		dBc	
2600 MHz LO						
10 kHz			−93		dBc	
100 kHz			−97		dBc	
1 MHz			−123		dBc	
3500 MHz LO						
10 kHz			−91		dBc	
100 kHz			−97		dBc	
1 MHz			−123		dBc	
5500 MHz LO						
10 kHz			−98		dBc	
100 kHz			−100		dBc	
1 MHz			−110		dBc	
Integrated Phase Noise						Integrated from 1 kHz to 100 MHz
700 MHz LO			0.20		$^{\circ}$ rms	
2600 MHz LO			0.49		$^{\circ}$ rms	
3500 MHz LO			0.55		$^{\circ}$ rms	
5500 MHz LO			0.75		$^{\circ}$ rms	
EXTERNAL LO INPUT						
Input Frequency	$f_{EXTLO}$	600		8000	MHz	Input frequency must be 2x the desired LO frequency
Input Signal Power		0	3	6	dBm	50 $\Omega$ matching at the source

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
REFERENCE CLOCK (DEV_CLK_IN SIGNAL) Frequency Range Signal Level		10 0.3		320 2.0	MHz V p-p	AC-coupled, common-mode voltage ( $V_{CM}$ ) = 618 mV; for best spurious performance, use a <1 V p-p input clock
AUXILIARY CONVERTERS ADC ADC Resolution Input Voltage Minimum Maximum DAC DAC Resolution Output Voltage Minimum Maximum Drive Capability			12 0.25 3.05 10 0.5 3.0 10		Bits V V Bits V V mA	Includes four offset levels Reference voltage ( $V_{REF}$ ) = 1 V $V_{REF} = 2.5$ V
DIGITAL SPECIFICATIONS (CMOS), GPIO_x, RX1_ENABLE, RX2_ENABLE, TX1_ENABLE, TX2_ENABLE, SYNCINBx+, SYNCOUTB0+, GP_INTERRUPT, SDIO, SDO, SCLK, CSB, RESET Logic Inputs Input Voltage High Level Low Level Input Current High Level Low Level Logic Outputs Output Voltage High Level Low Level Drive Capability			VDD_IF × 0.8 0 –10 –10 VDD_IF × 0.8	VDD_IF VDD_IF × 0.2 +10 +10 VDD_IF × 0.2	V V μA μA V V mA	
DIGITAL SPECIFICATIONS (LVDS), SYSREF_INx±, SYNCOUTB0±, SYNCINBx± PAIRS Logic Inputs Input Voltage Range Input Differential Voltage Threshold Receiver Differential Input Impedance Logic Outputs Output Voltage High Low Differential Offset		825 –100 100 1025 225 1200	1675 +100 100 1375 mV mV Ω mV mV mV	mV mV Ω mV mV mV	Each differential input in the pair Internal termination enabled	

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
DIGITAL SPECIFICATIONS (CMOS), GPIO_3P3_x SIGNALS						
Logic Inputs						
Input Voltage						
High Level	VDDA_3P3 × 0.8			VDDA_3P3	V	
Low Level	0			VDDA_3P3 × 0.2	V	
Input Current						
High Level	-10			+10	µA	
Low Level	-10			+10	µA	
Logic Outputs						
Output Voltage						
High Level	VDDA_3P3 × 0.8				V	
Low Level				VDDA_3P3 × 0.2	V	
Drive Capability		4			mA	

<sup>1</sup> VDDA\_1P3 refers to all analog 1.3 V supplies including the following: VDDA\_BB, VDDA\_CLKSYNTH, VDDA\_TXLO, VDDA\_RXRF, VDDA\_RXSYNTH, VDDA\_RXVCO, VDDA\_RXTX, VDDA\_TXSYNTH, VDDA\_TXVCO, VDDA\_CALPLL, VDDA\_SNRXSYNTH, VDDA\_SNRXVCO, VDDA\_CLK, and VDDA\_RXLO.

<sup>2</sup> Synthesis BW is the extended bandwidth used by digital correction algorithms to measure conditions and generate compensation.

<sup>3</sup> Quadrature error correction (QEC) is the system for minimizing quadrature images of a desired signal.

<sup>4</sup> Local oscillator leakage (LOL) is a measure of the amount of the LO signal that is passed from a mixer with the desired signal.

<sup>5</sup> Adjacent channel level reduction (ACLR) is a measure of the amount of power from the desired signal leaking into an adjacent channel.

<sup>6</sup> dBFS represents the ratio of the actual output signal to the maximum possible output level for a continuous wave output signal at the given RF attenuation setting.

<sup>7</sup> Continuous wave (CW) is a single frequency signal.

<sup>8</sup> Note that the input signal power limit does not correspond to 0 dBFS at the digital output because of the nature of the continuous time Σ-Δ ADCs. Unlike the hard clipping characteristic of pipeline ADCs, these converters exhibit a soft overload behavior when the input approaches the maximum level.

<sup>9</sup> Signal-to-noise ratio is limited by the baseband quantization noise.

## CURRENT AND POWER CONSUMPTION SPECIFICATIONS

Table 2.

Parameter	Min	Typ	Max	Unit	Test Conditions / Comments
<b>SUPPLY CHARACTERISTICS</b>					
VDDA_1P3 Analog Supplies <sup>1</sup>	1.267	1.3	1.33	V	
VDIG Supply	1.267	1.3	1.33	V	
VDDA_1P8 Supply	1.71	1.8	1.89	V	
VDD_IF Supply	1.71	1.8	2.625	V	CMOS and LVDS supply, 1.8 V to 2.5 V nominal range
VDDA_3P3 Supply	3.135	3.3	3.465	V	
VDDA_SER, VDDADES, JESD_VTT_DES Supplies	1.14	1.3	1.365	V	
<b>POSITIVE SUPPLY CURRENT (Rx MODE)</b>					
VDDA_1P3 Analog Supplies <sup>1</sup>	1055			mA	Two Rx channels enabled, Tx upconverter disabled, 100 MHz Rx BW, 122.88 MSPS data rate
VDIG Supply	625			mA	Rx QEC <sup>2</sup> enabled, QEC <sup>2</sup> engine active
VDD_IF Supply (CMOS and LVDS)	8			mA	
VDDA_3P3 Supply	1			mA	No auxiliary DACs or auxiliary ADCs enabled; if enabled, the auxiliary ADC adds 2.7 mA, and each auxiliary ADC adds 1.5 mA
VDDA_SER, VDDADES, JESD_VTT_DES Supplies	375			mA	
Total Power Dissipation	2.70			W	

Parameter	Min	Typ	Max	Unit	Test Conditions / Comments
POSITIVE SUPPLY CURRENT (Tx MODE)					Two Tx channels enabled, Rx downconverter disabled, 200 MHz Tx BW, 245.76 MSPS data rate (ORx disabled)
VDDA_1P3 Analog Supplies <sup>1</sup>	1000	mA			
VDIG Supply	410	mA			Tx QEC <sup>2</sup> active
VDDA_1P8 Supply	405	mA			Full-scale CW <sup>3</sup>
	80	mA			Tx RF attenuation = 0 dB,
	8	mA			Tx RF attenuation = 15 dB
VDD_IF Supply					
VDDA_3P3 Supply	1	mA			No auxiliary DACs or auxiliary ADCs enabled; if enabled, the auxiliary ADC adds 2.7 mA, and each auxiliary ADC adds 1.5 mA
VDDA_SER, VDDA_DES, JESD_VTT_DES Supplies	375	mA			
Total Power Dissipation	3.70	W			Typical supply voltages, Tx QEC <sup>2</sup> active
	3.11	W			Tx RF attenuation = 0 dB
					Tx RF attenuation = 15 dB
POSITIVE SUPPLY CURRENT (FDD MODE), 2x Rx, 2x Tx, ORx ACTIVE					100 MHz Rx BW, 122.88 MSPS data rate; 200 MHz Tx BW, 245.76 MSPS data rate; 200 MHz ORx BW, 245.76 MSPS data rate
VDDA_1P3 Analog Supplies <sup>1</sup>	1700	mA			
VDIG Supply	1080	mA			Tx QEC <sup>2</sup> active
VDDA_1P8 Supply	405	mA			Full scale CW <sup>3</sup>
	80	mA			Tx RF attenuation = 0 dB
	8	mA			Tx RF attenuation = 15 dB
VDD_IF Supply					
VDDA_3P3 Supply	2	mA			No auxiliary DACs or auxiliary ADCs enabled; if enabled, the auxiliary ADC adds 2.7 mA, and each auxiliary ADC adds 1.5 mA
VDDA_SER, VDDA_DES, JESD_VTT_DES Supplies	375	mA			
Total Power Dissipation	4.86	W			Typical supply voltages, Tx QEC <sup>2</sup> active
	4.27	W			Tx RF attenuation = 0 dB
					Tx RF attenuation = 15 dB
MAXIMUM OPERATING JUNCTION TEMPERATURE	110	°C			Device designed for 10-year lifetime when operating at maximum junction temperature

<sup>1</sup> VDDA\_1P3 refers to all analog 1.3 V supplies including the following: VDDA\_BB, VDDA\_CLKSYNTH, VDDA\_TXLO, VDDA\_RXRF, VDDA\_RXSYNTH, VDDA\_RXVCO, VDDA\_RXTX, VDDA\_TXSYNTH, VDDA\_TXVCO, VDDA\_CALPLL, VDDA\_SNRXSYNTH, VDDA\_SNRXVCO, VDDA\_CLK, and VDDA\_RXLO.

<sup>2</sup> QEC is the system for minimizing quadrature images of a desired signal.

<sup>3</sup> CW is a single frequency signal.

## TIMING SPECIFICATIONS

Table 3.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
SERIAL PERIPHERAL INTERFACE (SPI) TIMING						
SCLK Period	$t_{CP}$	20			ns	
SCLK Pulse Width	$t_{MP}$	10			ns	
CSB Setup to First SCLK Rising Edge	$t_{SC}$	3			ns	
Last SCLK Falling Edge to CSB Hold	$t_{HC}$	0			ns	
SDIO Data Input Setup to SCLK	$t_S$	2			ns	
SDIO Data Input Hold to SCLK	$t_H$	0			ns	
SCLK Falling Edge to Output Data Delay (3- or 4-Wire Mode)	$t_{CO}$	3	8		ns	
Bus Turnaround Time After Baseband Processor (BBP) Drives Last Address Bit	$t_{HZM}$	$t_H$	$t_{CO}$		ns	
Bus Turnaround Time After AD9375 Drives Last Address Bit	$t_{H2S}$	0	$t_{CO}$		ns	
DIGITAL TIMING						
TXx_ENABLE Pulse Width		10			$\mu$ s	
RXx_ENABLE Pulse Width		10			$\mu$ s	
JESD204B DATA OUTPUT TIMING						
Unit Interval	UI	162.76	1627.6		ps	
Data Rate per Channel (Nonreturn to Zero (NRZ))		614.4	6144		Mbps	
Rise Time	$t_R$	24	35		ps	20% to 80% in 100 $\Omega$ load
Fall Time	$t_F$	24	35		ps	20% to 80% in 100 $\Omega$ load
Output Common-Mode Voltage	$V_{CM}$	0	1.8		V	AC-coupled
Termination Voltage ( $V_{TT}$ ) = 1.2 V		735	1135		mV	DC-coupled
Differential Output Voltage	$V_{DIFF}$	360	466	770	mV	
Short-Circuit Current	$I_{DSHORT}$	-100		+100	mA	
Differential Termination Impedance	$Z_{RDIF}$	80	100	120	$\Omega$	
Total Jitter			17	48.8	ps	Bit error rate (BER) = $10^{-15}$
Uncorrelated Bounded High Probability Jitter	UBHPJ		1.2	24.4	ps	
Duty Cycle Distortion	DCD		3	8.1	ps	
SYSREF_IN Signal Setup Time to DEV_CLK_IN Signal	$t_S$	2.5			ns	See Figure 2 and Figure 3
SYSREF_IN Signal Hold Time to DEV_CLK_IN Signal	$t_H$	-1.5			ns	See Figure 2 and Figure 3
JESD204B DATA INPUT TIMING						
Unit Interval	UI	162.76	1627.6		ps	
Data Rate per Channel (NRZ)		614.4	6144		Mbps	
Input Common-Mode Voltage	$V_{CM}$	0.05	1.85		V	AC-coupled
$V_{TT}$ = 1.2 V		720	1200		mV	DC-coupled
Differential Input Voltage	$V_{DIFF}$	125	750		mV	
$V_{TT}$ Source Impedance	$Z_{TT}$		1.2	30	$\Omega$	
Differential Termination Impedance	$Z_{RDIF}$	80	106	120	$\Omega$	
$V_{TT}$			1.27	1.33	V	
AC-Coupled			1.14	1.26	V	
DC-Coupled						

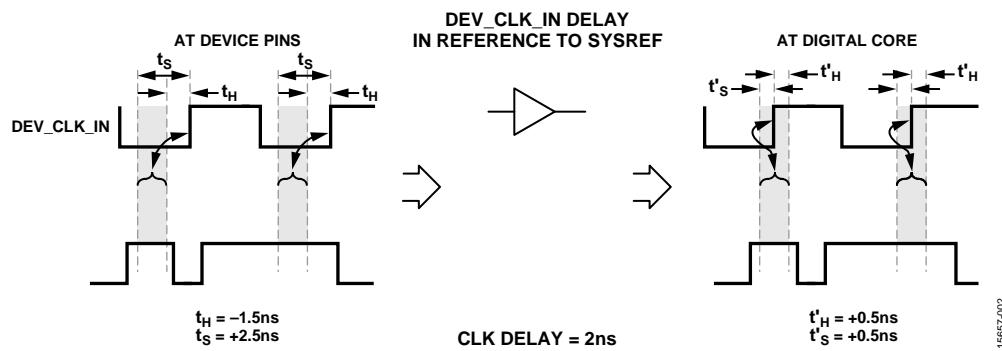
**Timing Diagrams**

Figure 2. SYSREF\_IN Signal Setup and Hold Timing

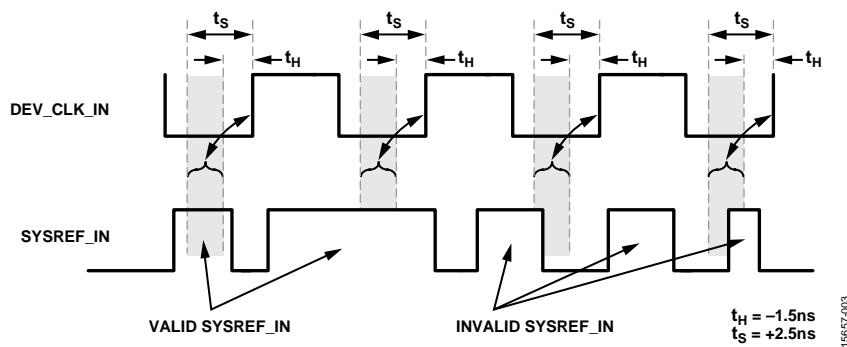


Figure 3. SYSREF\_IN Signal Setup and Hold Timing Examples Relative to DEV\_CLK\_IN Signal

## ABSOLUTE MAXIMUM RATINGS

Table 4.

Parameter	Rating
VDDA_1P3 <sup>1</sup> to VSSA	-0.3 V to +1.4 V
VDDA_SER, VDDA_DES, and JESD_VTT_DES to VSSA	-0.3 V to +1.4 V
VDIG to VSSD	-0.3 V to +1.4 V
VDDA_1P8 to VSSA	-0.3 V to +2.0 V
VDD_IF to VSSA	-0.3 V to +3.0 V
VDDA_3P3 to VSSA	-0.3 V to +3.9 V
Logic Inputs and Outputs to VSSD	-0.3 V to VDD_IF + 0.3 V
JESD204B Logic Outputs to VSSA	-0.3 V to VDDA_SER
JESD204B Logic Inputs to VSSA	-0.3 V to VDDA_DES
Input Current to Any Pin Except Supplies	±10 mA
Maximum Input Power into RF Ports (Excluding Sniffer Receiver Inputs)	23 dBm (peak)
Maximum Input Power into SNRXA $\pm$ , SNRXB $\pm$ , and SNRXC $\pm$	2 dBm (peak)
Maximum Junction Temperature ( $T_{J,\text{MAX}}$ )	110°C
Operating Temperature Range	-40°C to +85°C
Storage Temperature Range	-65°C to +150°C

<sup>1</sup> VDDA\_1P3 refers to all analog 1.3 V supplies: VDDA\_BB, VDDA\_CLKSYNTH, VDDA\_TXLO, VDDA\_RXSYNTH, VDDA\_RXVCO, VDDA\_RXTX, VDDA\_RXRF, VDDA\_TKSYNTH, VDDA\_TKVCO, VDDA\_CALPLL, VDDA\_SNRXSYNTH, VDDA\_SNRXVCO, VDDA\_CLK, and VDDA\_RXLO.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

## REFLOW PROFILE

The AD9375 reflow profile is in accordance with the JEDEC JESD20 criteria for Pb-free devices. The maximum reflow temperature is 260°C.

## THERMAL RESISTANCE

Thermal performance is directly linked to PCB design and operating environment. Careful attention to PCB thermal design is required.

$\theta_{JA}$  is the natural convection junction-to-ambient thermal resistance measured in a one cubic foot sealed enclosure.  $\theta_{JC}$  is the junction-to-case thermal resistance.

Table 5. Thermal Resistance

Package	Airflow Velocity <sup>1</sup> (m/sec)	$\theta_{JA}^{2,3}$ (°C/W)	$\theta_{JC}^{2,4}$ (°C/W)
BC-196-12 JEDEC <sup>5</sup>	0.0	20.5	0.05
	1.0	18.5	N/A <sup>6</sup>
	2.5	17.2	N/A <sup>6</sup>
	0.0	14.1	0.05
	1.0	12.4	N/A <sup>6</sup>
	2.5	11.6	N/A <sup>6</sup>

<sup>1</sup> Power dissipation is 3.0 W for all test cases.

<sup>2</sup> Per JEDEC JESD51-7 for JEDEC JESD51-5 2S2P test board.

<sup>3</sup> Per JEDEC JESD51-2 (still air) or JEDEC JESD51-6 (moving air).

<sup>4</sup> Per MIL-STD 883, Method 1012.1.

<sup>5</sup> JEDEC entries refer to the JEDEC JESD51-9 (high-K thermal test board).

<sup>6</sup> N/A means not applicable.

## ESD CAUTION



### ESD (electrostatic discharge) sensitive device.

Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

## PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

AD9375  
TOP VIEW  
(Not to Scale)

	1	2	3	4	5	6	7	8	9	10	11	12	13	14
A	VSSA	ORX2+	ORX2-	VSSA	RX2+	RX2-	VSSA	VSSA	RX1+	RX1-	VSSA	ORX1+	ORX1-	VSSA
B	VDDA_RXRF	VSSA	VSSA	VSSA	VSSA	VSSA	RX_EXTLO-	RX_EXTLO+	VSSA	VSSA	VSSA	VSSA	VSSA	VDDA_3P3
C	GPIO_3P3_0	GPIO_3P3_1	VSNRX_VCO_LDO	VDDA_SRNXVCO	VSSA	VDDA_RXLO	VDDA_RXVCO	VRX_VCO_LDO	VSSA	VSSA	AUXADC_1	AUXADC_2	GPIO_3P3_9	RBIAS
D	GPIO_3P3_3	SNRXC-	SNRXB-	SNRXA-	GPIO_3P3_5	VSSA	VSSA	VSSA	VSSA	VDDA_1P8	AUXADC_3	GPIO_3P3_7	GPIO_3P3_8	GPIO_3P3_10
E	GPIO_3P3_4	SNRXC+	SNRXB+	SNRXA+	VDDA_BB	VSSA	DEV_CLK_IN+	DEV_CLK_IN-	VSSA	VSSA	TX_EXTLO-	TX_EXTLO+	AUXADC_0	GPIO_3P3_6
F	GPIO_3P3_2	VDDA_RXTX	VSSA	VSSA	VSSA	VSSA	VSSA	VSSA	VSSA	VDDA_TXCO	VDDA_TXLO	VTX_VCO_LDO	VSSA	GPIO_3P3_11
G	VSSA	VSSA	VSSA	VDDA_CALPLL	VSSA	VDDA_CLKSYNTH	VDDA_SRNXSYNTH	VDDA_TXSYNTH	VDDA_RXSYNTH	VSSA	VSSA	VSSA	VSSA	VSSA
H	TX2-	VSSA	VSSA	VSSA	VSSA	VSSA	VSSA	VSSA	VSSA	VSSA	GPIO_12	GPIO_11	VSSA	TX1+
J	TX2+	VSSA	GPIO_18	RESET	GP_INTERRUPT	TEST	GPIO_2	GPIO_1	SDIO	SDO	GPIO_13	GPIO_10	VSSA	TX1-
K	VSSA	VSSA	SYSREF_IN+	SYSREF_IN-	GPIO_5	GPIO_4	GPIO_3	GPIO_0	SCLK	CSB	GPIO_14	GPIO_9	VSSA	VSSA
L	VSSA	VSSA	SYNCINB1-	SYNCINB1+	GPIO_6	GPIO_7	VSSD	VDIG	VDIG	VSSD	GPIO_15	GPIO_8	VSSA	VSSA
M	VCLK_VCO_LDO	VSSA	SYNCINB0-	SYNCINB0+	RX1_ENABLE	TX1_ENABLE	RX2_ENABLE	TX2_ENABLE	VSSA	GPIO_17	GPIO_16	VDD_IF	SYNCOUTB0+	SYNCOUTB0-
N	VDDA_CLK	VSSA	SERDOUT3-	SERDOUT3+	SERDOUT2-	SERDOUT2+	VSSA	VDDA_SER	VDDA_DES	SERDIN2-	SERDIN2+	SERDIN3-	SERDIN3+	VSSA
P	VSSA	VSSA	VSSA	SERDOUT1-	SERDOUT1+	SERDOUT0-	SERDOUT0+	VDDA_SER	JESD_VTT_DES	VSSA	SERDINO-	SERDINO+	SERDIN1-	SERDIN1+

■ ANALOG INPUT/OUTPUT ■ DIGITAL INPUT/OUTPUT ■ DC POWER ■ GROUND

Figure 4. Pin Configuration

15857-004

Table 6. Pin Function Descriptions

Pin No.	Type <sup>1</sup>	Mnemonic	Description
A1, A4, A7, A8, A11, A14, B2 to B6, B9 to B13, C5, C9, C10, D6 to D9, E6, E9, E10, F3 to F10, G1 to G3, G5, G10 to G14, H2 to H10, H13, J2, J13, K1, K2, K13, K14, L1, L2, L13, L14, M2, M9, N2, N7, N14, P1, P2, P3, P10	I	VSSA	Analog ground.
A2, A3	I	ORX2+, ORX2-	Differential Input for Observation Receiver 2. Do not connect if these pins are unused.
A5, A6	I	RX2+, RX2-	Differential Input for Receiver 2. Do not connect if these pins are unused.
A9, A10	I	RX1+, RX1-	Differential Input for Receiver 1. Do not connect if these pins are unused.
A12, A13	I	ORX1+, ORX1-	Differential Input for Observation Receiver 1. Do not connect if these pins are unused.
B1	I	VDDA_RXRF	1.3 V Supply Input.

Pin No.	Type <sup>1</sup>	Mnemonic	Description
B7, B8	I/O	RX_EXTLO-, RX_EXTLO+	Differential Rx External LO Input/Output. If used for the external LO, the input frequency must be 2x the desired carrier frequency. Do not connect if these pins are unused.
B14	I	VDDA_3P3	Supply Voltage for GPIO_3P3_x.
C1, C2, C13, D1, D5, D12 to D14, E1, E14, F1, F14	I/O	GPIO_3P3_0 to GPIO_3P3_11	General-Purpose Inputs and Outputs Referenced to 3.3 V Supply. See Figure 4 to match the ball location to the GPIO_3P3_x signal name. Some GPIO_3P3_x pins can also function as auxiliary DAC outputs.
C3	O	VSNRX_VCO_LDO	Sniffer VCO LDO 1.1 V Output. Bypass this pin with a 1 $\mu$ F capacitor.
C4	I	VDDA_SNRXVCO	1.3 V Supply Input for Sniffer VCO Low Dropout (LDO) Regulator.
C6	I	VDDA_RXLO	1.3 V Supply for the Rx Synthesizer LO Generator. This pin is sensitive to aggressors.
C7	I	VDDA_RXVCO	1.3 V Supply Input for Receiver VCO LDO Regulator.
C8	O	VRX_VCO_LDO	Receiver VCO LDO 1.1 V Output. Bypass this pin with a 1 $\mu$ F capacitor.
C11	I	AUXADC_1	Auxiliary ADC 1 Input.
C12	I	AUXADC_2	Auxiliary ADC 2 Input.
C14	N/A	RBIAS	Bias Resistor Connection. This pin generates an internal current based on an external 1% resistor. Connect a 14.3 k $\Omega$ resistor between this pin and ground (VSSA).
D2, E2	I	SNRXC-, SNRXC+	Differential Input for Sniffer Receiver Input C. If these pins are unused, connect to VSSA with a short or with a 1 k $\Omega$ resistor.
D3, E3	I	SNRXB-, SNRXB+	Differential Input for Sniffer Receiver Input B. If these pins are unused, connect to VSSA with a short or with a 1 k $\Omega$ resistor.
D4, E4	I	SNRXA-, SNRXA+	Differential Input for Sniffer Receiver Input A. If these pins are unused, connect to VSSA with a short or with a 1 k $\Omega$ resistor.
D10	I	VDDA_1P8	1.8 VTx Supply.
D11	I	AUXADC_3	Auxiliary ADC 3 Input.
E5	I	VDDA_BB	1.3 V Supply Input for ADCs, DACs, and Auxiliary ADCs.
E7, E8	I	DEV_CLK_IN+, DEV_CLK_IN-	Device Clock Differential Input.
E11, E12	I/O	TX_EXTLO-, TX_EXTLO+	Differential Tx External LO Input/Output. If these pins are used for the external LO, the input frequency must be 2x the desired carrier frequency. Do not connect if these pins are unused.
E13	I	AUXADC_0	Auxiliary ADC 0 Input.
F2	I	VDDA_RXTX	1.3 V Supply Input for Tx/Rx Baseband Circuits, Transimpedance Amplifier (TIA), Tx Transconductance ( $G_m$ ), Baseband Filters, and Auxiliary DACs.
F11	I	VDDA_TXVCO	1.3 V Supply Input for Transmitter VCO LDO Regulator.
F12	I	VDDA_TXLO	1.3 V Supply for the Tx Synthesizer LO Generator. This pin is sensitive to aggressors.
F13	O	VTX_VCO_LDO	Transmitter VCO LDO 1.1 V Output. Bypass this pin with a 1 $\mu$ F capacitor.
G4	I	VDDA_CALPLL	1.3 V Supply Input for Calibration PLL Circuits. Use a separate trace on the PCB back to a common supply point.
G6	I	VDDA_CLKSYNTH	1.3 V Clock Synthesizer Supply Input. This pin is sensitive to aggressors.
G7	I	VDDA_SNRXSYNTH	1.3 V Sniffer Rx Synthesizer Supply Input. This pin is sensitive to aggressors.
G8	I	VDDA_TXSYNTH	1.3 VTx Synthesizer Supply Input. This pin is sensitive to aggressors.
G9	I	VDDA_RXSYNTH	1.3 V Rx Synthesizer Supply Input. This pin is sensitive to aggressors.
H1, J1	O	TX2-, TX2+	Differential Output for Transmitter 2.

Pin No.	Type <sup>1</sup>	Mnemonic	Description
H11, H12, J3, J7, J8, J11, J12, K5 to K8, K11, K12, L5, L6, L11, L12, M10, M11	I/O	GPIO_0 to GPIO_18	General-Purpose Inputs and Outputs Referenced to VDD_IF. See Figure 4 to match the ball location to the GPIO_x signal name.
H14, J14	O	TX1+, TX1-	Differential Output for Transmitter 1.
J4	I	RESET	Active Low Chip Reset.
J5	O	GP_INTERRUPT	General-Purpose Interrupt Signal.
J6	I	TEST	Test Pin Used for JTAG Boundary Scan. Ground this pin if unused.
J9	I/O	SDIO	Serial Data Input in 4-Wire Mode or Input/Output in 3-Wire Mode.
J10	O	SDO	Serial Data Output.
K3, K4	I	SYSREF_IN+, SYSREF_IN-	LVDS System Reference Clock Inputs for the JESD204B Interface.
K9	I	SCLK	Serial Data Bus Clock.
K10	I	CSB	Serial Data Bus Chip Select. Active low.
L3, L4	I	SYNCINB1-, SYNCINB1+	LVDS Sync Signal Associated with ORx/Sniffer Channel Data on the JESD204B Interface. Alternatively, these pins can be set to a CMOS input using SYNCINB1+ as the input and connecting SYNCINB1- with a 1 kΩ resistor to GND.
L7, L10	I	VSSD	Digital Ground.
L8, L9	I	VDIG	1.3 V Digital Core Supply. Use a separate trace on the PCB back to a common supply point.
M1	O	VCLK_VCO_LDO	Clock VCO LDO 1.1 V Output. Bypass this pin with a 1 μF capacitor.
M3, M4	I	SYNCINB0-, SYNCINB0+	LVDS Sync Signal Associated with Rx Channel Data on the JESD204B Interface. Alternatively, these pins can be set to a CMOS input using SYNCINB0+ as the input and connecting SYNCINB0- with a 1 kΩ resistor to GND.
M5	I	RX1_ENABLE	Enables Rx Channel 1 Signal Path.
M6	I	TX1_ENABLE	Enables Tx Channel 1 Signal Path.
M7	I	RX2_ENABLE	Enables Rx Channel 2 Signal Path.
M8	I	TX2_ENABLE	Enables Tx Channel 2 Signal Path.
M12	I	VDD_IF	CMOS/LVDS Interface Supply.
M13, M14	O	SYNCOUTB0+, SYNCOUTB0-	LVDS Sync Signal Associated with Transmitter Channel Data on the JESD204B Interface. Alternatively, these pins can be set to a CMOS output using SYNCOUTB0+ as the output while leaving SYNCOUTB0- floating.
N1	I	VDDA_CLK	1.3 V Clock Supply Input.
N3, N4	O	SERDOUT3-, SERDOUT3+	RF Current Mode Logic (CML) Differential Output 3. This JESD204B lane can be used by the receiver data or by the sniffer/observation receiver data.
N5, N6	O	SERDOUT2-, SERDOUT2+	RF CML Differential Output 2. This lane can be used by the receiver data or by the sniffer/observation receiver data.
N8, P8	I	VDDA_SER	JESD204B 1.3 V Serializer Supply Input.
N9	I	VDDA_DES	JESD204B 1.3 V Deserializer Supply Input.
N10, N11	I	SERDIN2-, SERDIN2+	RF CML Differential Input 2.
N12, N13	I	SERDIN3-, SERDIN3+	RF CML Differential Input 3.
P4, P5	O	SERDOUT1-, SERDOUT1+	RF CML Differential Output 1. This JESD204B lane can be used by receiver data or by sniffer/observation receiver data.
P6, P7	O	SERDOUT0-, SERDOUT0+	RF CML Differential Output 0. This JESD204B lane can be used by receiver data or by sniffer/observation receiver data.
P9	I	JESD_VTT_DES	JESD204B Deserializer Termination Supply Input.
P11, P12	I	SERDINO-, SERDINO+	RF CML Differential Input 0.
P13, P14	I	SERDIN1-, SERDIN1+	RF CML Differential Input 1.

<sup>1</sup> I is input, I/O is input/output, O is output, and N/A is not applicable.

## TYPICAL PERFORMANCE CHARACTERISTICS

Temperature settings refer to the die temperature. The die temperature is 40°C for single-trace plots.

### 700 MHz BAND

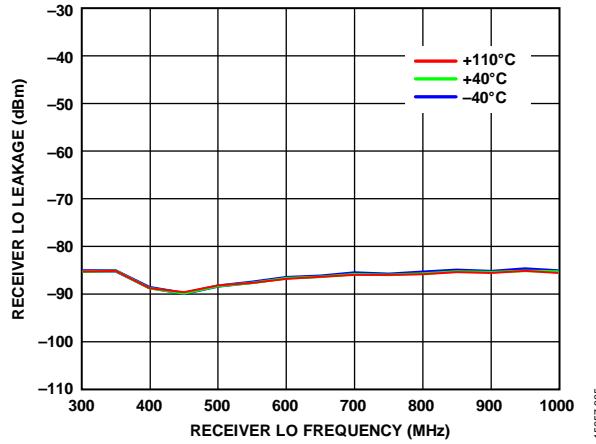


Figure 5. Receiver Local Oscillator (LO) Leakage vs. Receiver LO Frequency, 0 dB Receiver Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

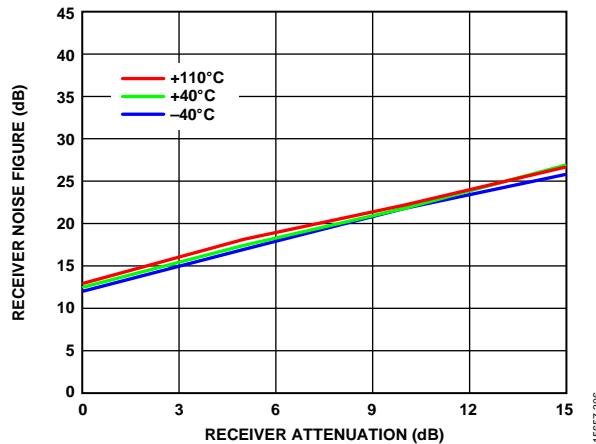


Figure 6. Receiver Noise Figure vs. Receiver Attenuation, 700 MHz LO, 20 MHz Bandwidth, 30.72 MSPS Sample Rate, 20 MHz Integration Bandwidth (Includes 1 dB Matching Circuit Loss)

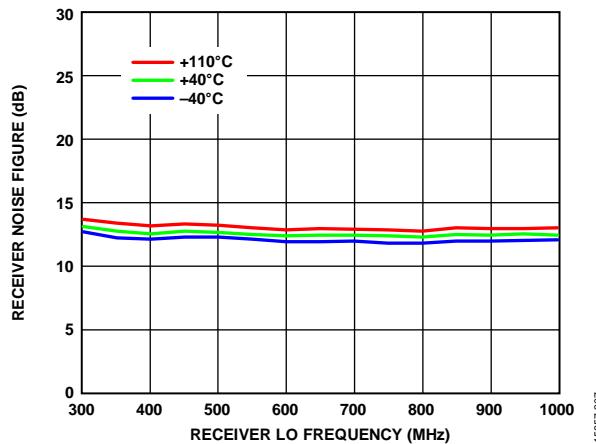


Figure 7. Receiver Noise Figure vs. Receiver LO Frequency, 0 dB Receiver Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate, 20 MHz Integration Bandwidth (Includes 1 dB Matching Circuit Loss)

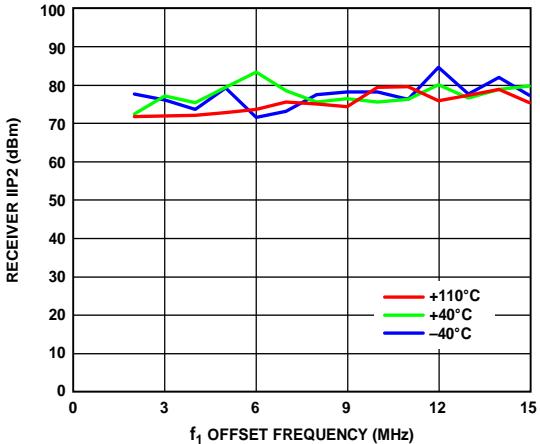


Figure 8. Receiver IIP2 vs.  $f_1$  Offset Frequency, 900 MHz LO, 0 dB Attenuation, 20 MHz RF Bandwidth,  $f_2 = f_1 + 1$  MHz, 30.72 MSPS Sample Rate

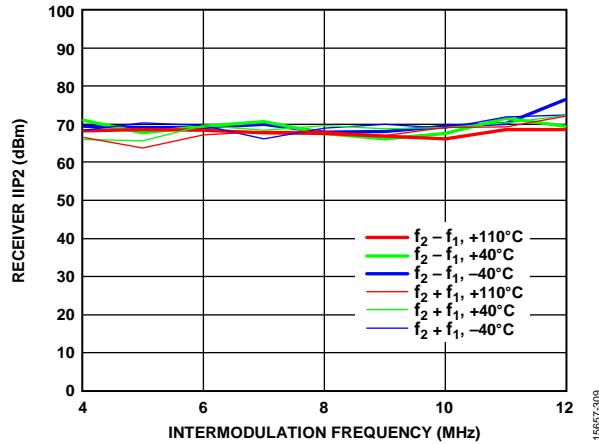


Figure 9. Receiver IIP2 vs. Intermodulation Frequency, 900 MHz LO, 0 dB Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

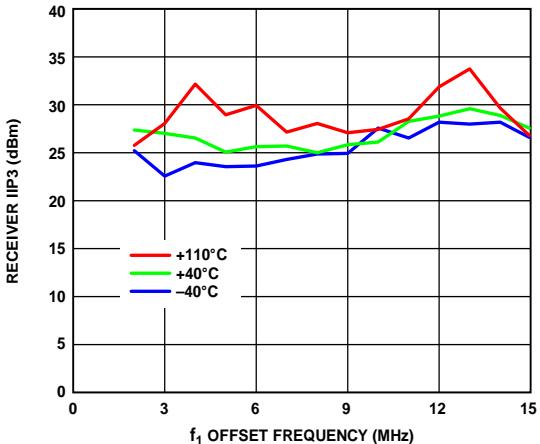
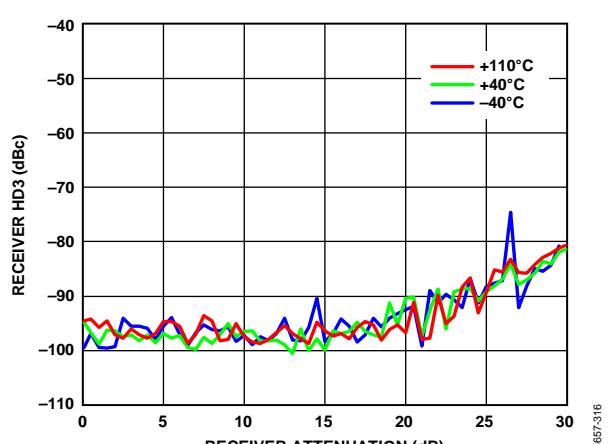
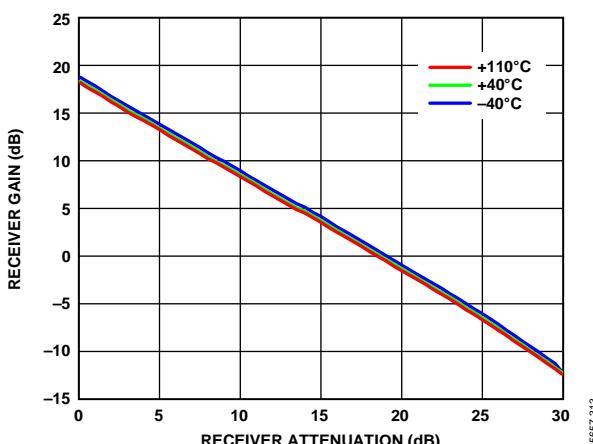
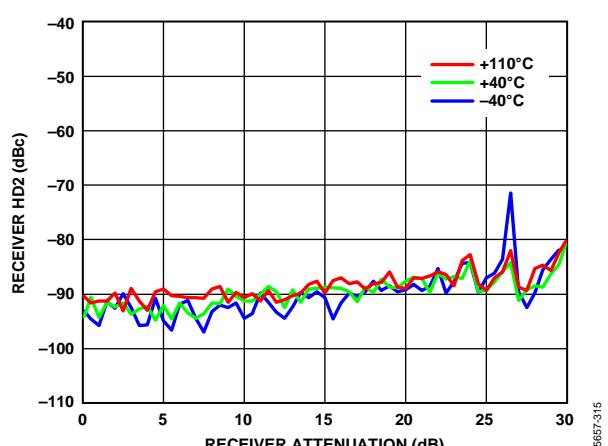
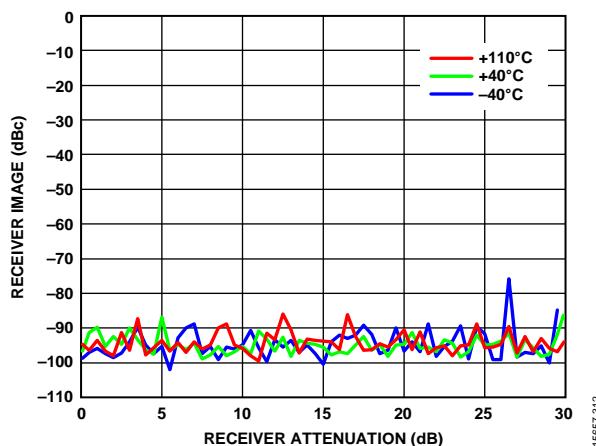
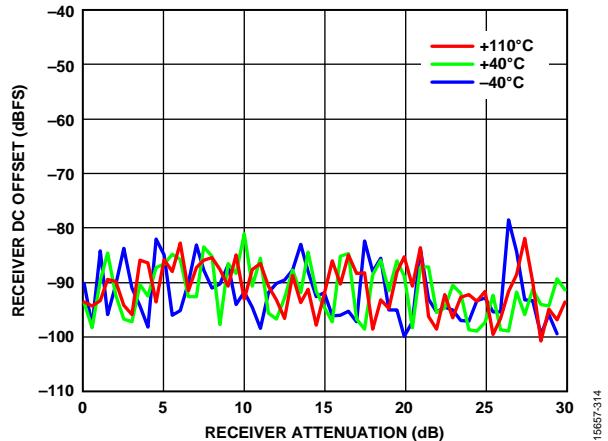
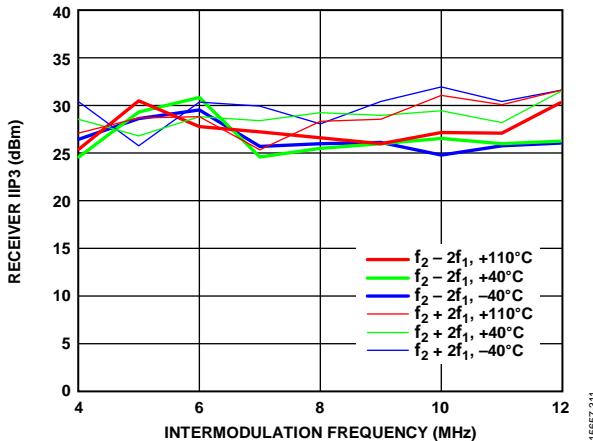


Figure 10. Receiver IIP3 vs.  $f_1$  Offset Frequency, 900 MHz LO, 0 dB Attenuation, 20 MHz RF Bandwidth,  $f_2 = 2f_1 + 1$  MHz, 30.72 MSPS Sample Rate



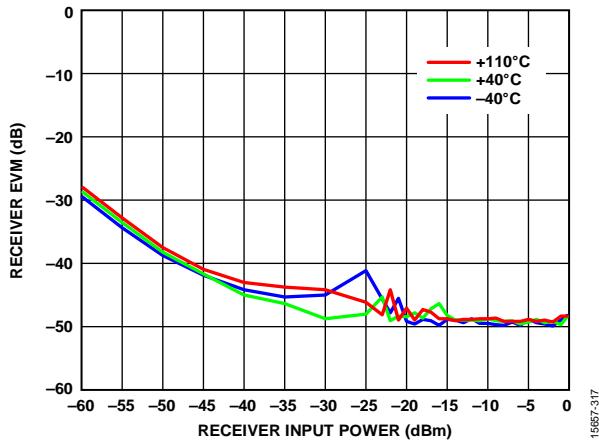


Figure 17. Receiver Error Vector Magnitude (EVM) vs. Receiver Input Power, 900 MHz LO, 20 MHz RF Bandwidth, LTE 20 MHz Uplink Centered at DC, BTC Active, 30.72 MSPS Sample Rate

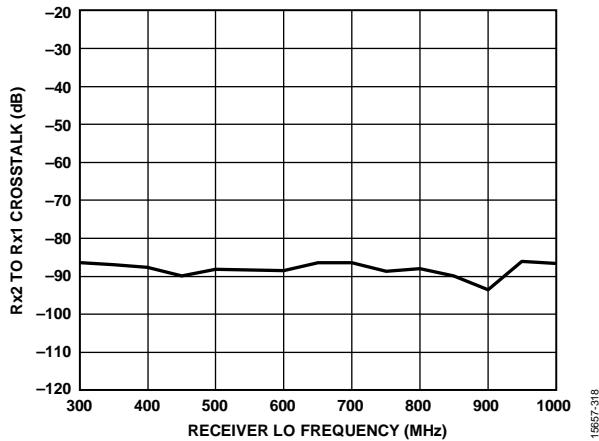


Figure 18. Rx2 to Rx1 Crosstalk vs. Receiver LO Frequency, 100 MHz RF Bandwidth, CW Tone 3 MHz Offset from LO

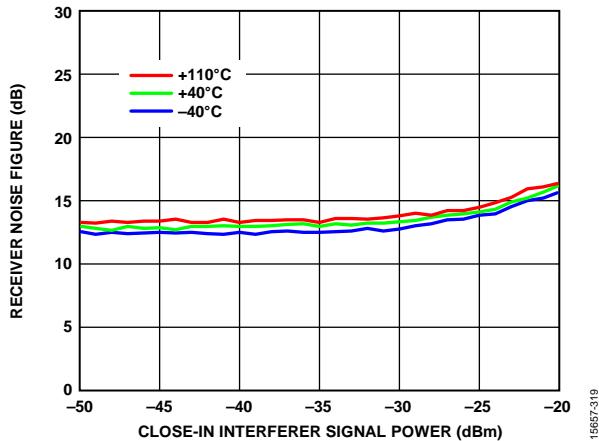


Figure 19. Receiver Noise Figure vs. Close-In Interferer Signal Power, 703 MHz LO, 709 MHz CW Interferer, NF Integrated over 7 MHz to 10 MHz, 20 MHz RF Bandwidth

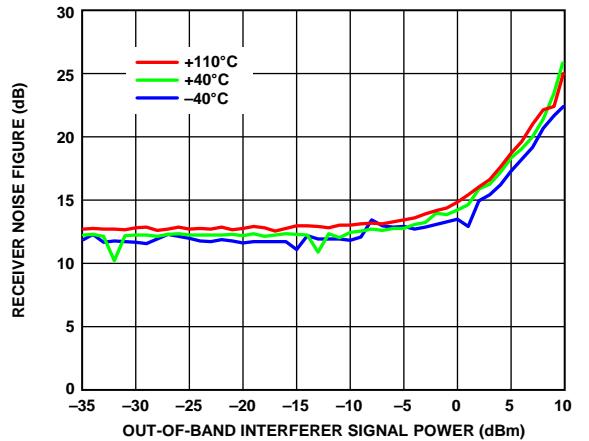


Figure 20. Receiver Noise Figure vs. Out-of-Band Interferer Signal Power, 703 MHz LO, 901 MHz CW Interferer, NF Integrated over 7 MHz to 10 MHz, 20 MHz RF Bandwidth

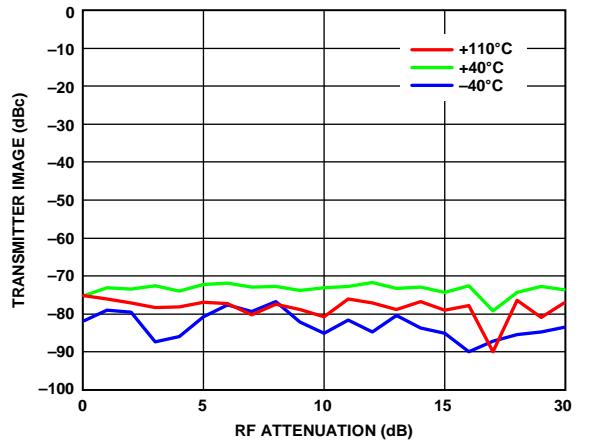


Figure 21. Transmitter Image vs. RF Attenuation, 20 MHz RF Bandwidth, 900 MHz LO, Transmitter Quadrature Error Correction (QEC) Tracking Run with Two 20 MHz LTE Downlink Carriers, Then Image Measured with CW 10 MHz Offset from LO, 3 dB Digital Backoff, 122.88 MSPS Sample Rate

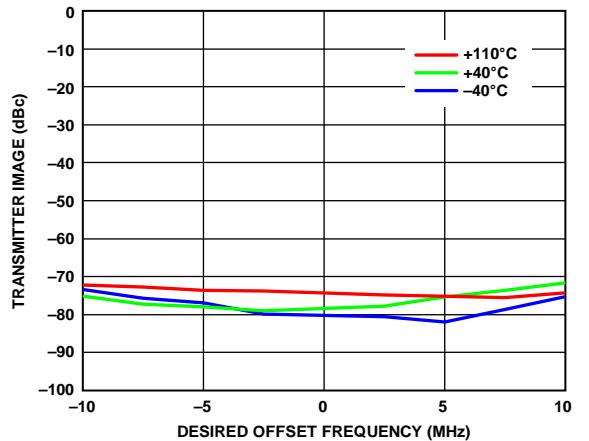


Figure 22. Transmitter Image vs. Desired Offset Frequency, 20 MHz RF Bandwidth, 900 MHz LO, 0 dB RF Attenuation, Transmitter QEC Tracking Run with Two 20 MHz LTE Downlink Carriers, Then Image Measured with CW Signal, 3 dB Digital Backoff, 122.88 MSPS Sample Rate

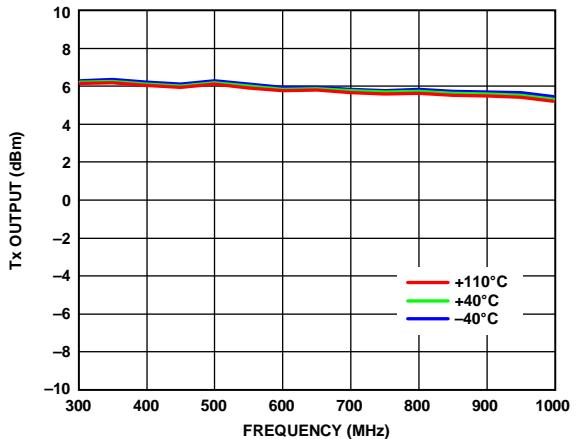


Figure 23. Tx Output Power, Transmitter QEC, and External LO Leakage Tracking Active, 10 MHz CW Offset Signal, 1 MHz Resolution Bandwidth, 122.88 MSPS Sample Rate

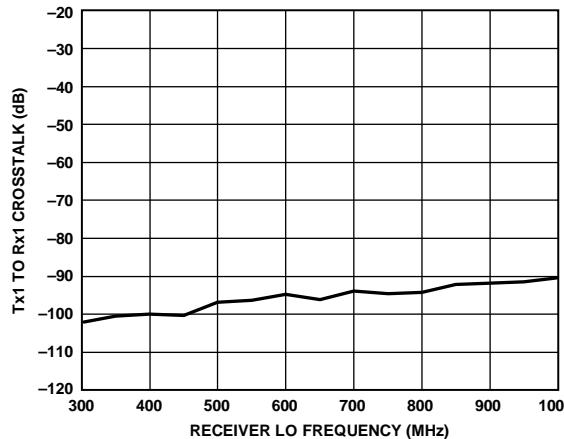


Figure 26. Tx1 to Rx1 Crosstalk vs. Receiver LO Frequency, 20 MHz Receiver RF Bandwidth, 20 MHz Transmitter RF Bandwidth, CW Signal 3 MHz Offset from LO

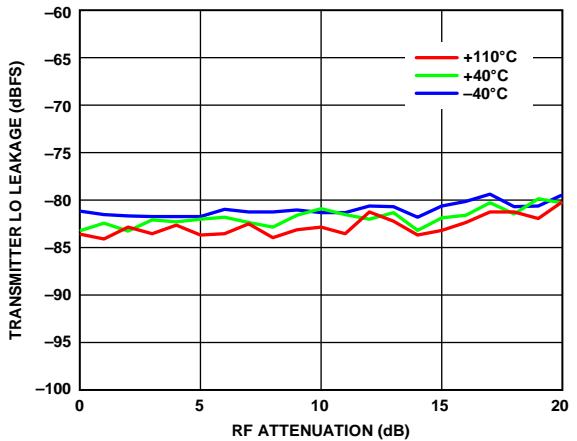


Figure 24. Transmitter LO Leakage vs. RF Attenuation, 900 MHz LO, Transmitter QEC and External LO Leakage Tracking Active, CW Signal 5 MHz Offset from LO, 6 dB Digital Backoff, 1 MHz Measurement Bandwidth (If Input Power to ORx Channel Is Not Held Constant, Performance Degrades As Shown in This Plot)

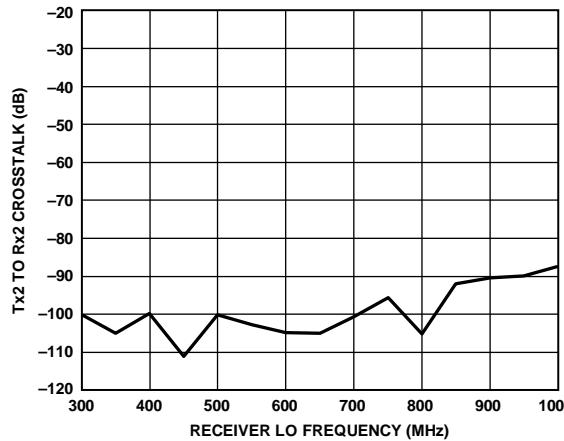


Figure 27. Tx2 to Rx2 Crosstalk vs. Receiver LO Frequency, 20 MHz Receiver RF Bandwidth, 20 MHz Transmitter RF Bandwidth, CW Signal 3 MHz Offset from LO

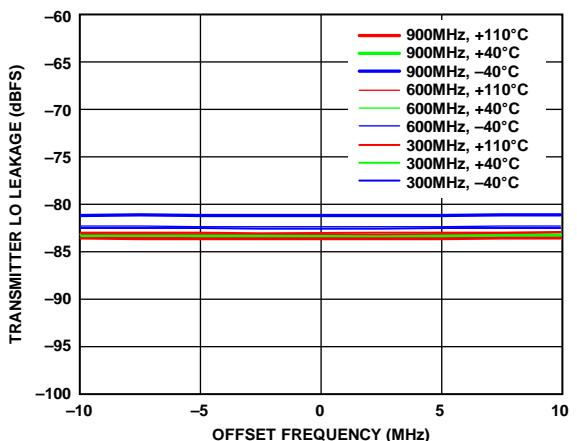


Figure 25. Transmitter LO Leakage vs. Offset Frequency, Transmitter QEC and External LO Leakage Tracking Active, 5 dB Digital Backoff, 1 MHz Measurement Bandwidth

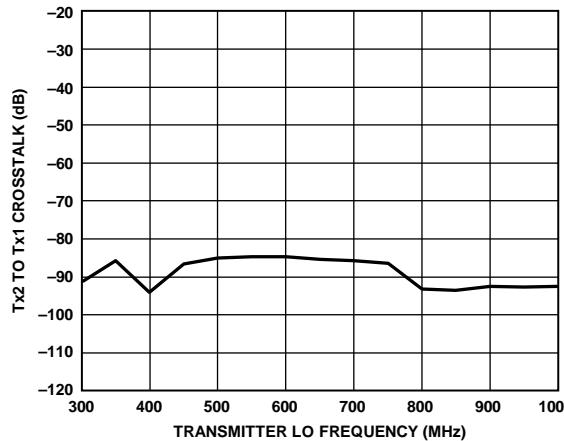
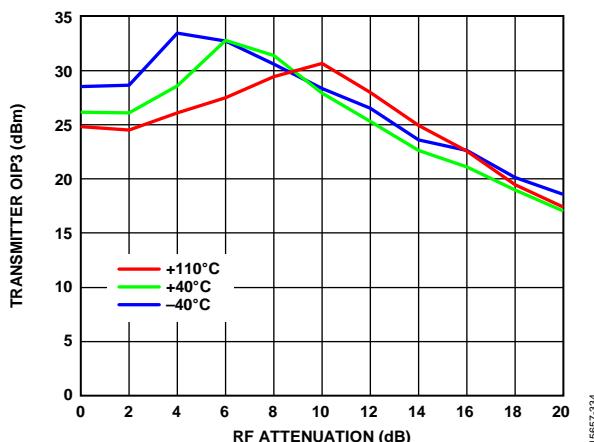
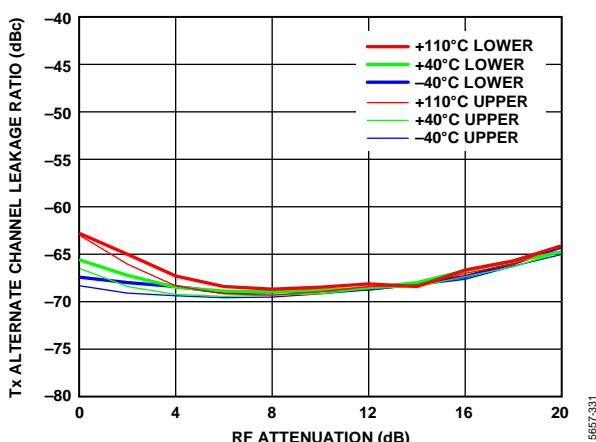
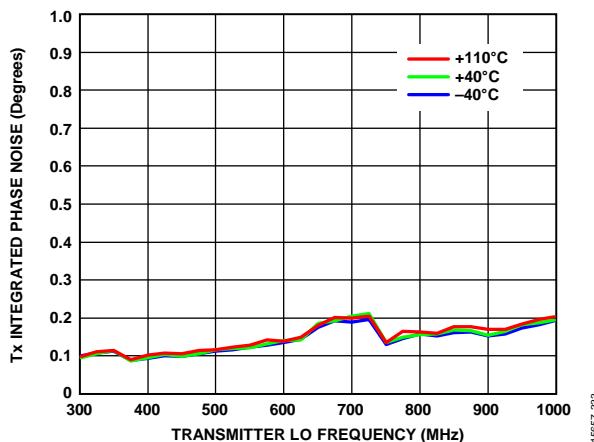
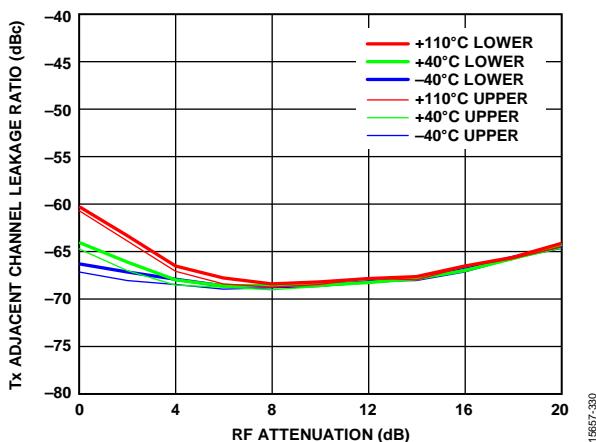
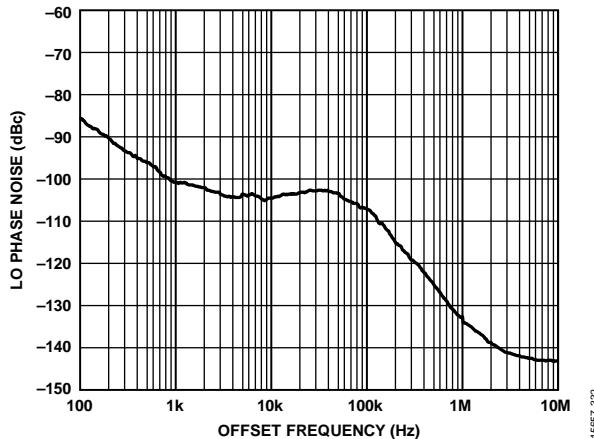
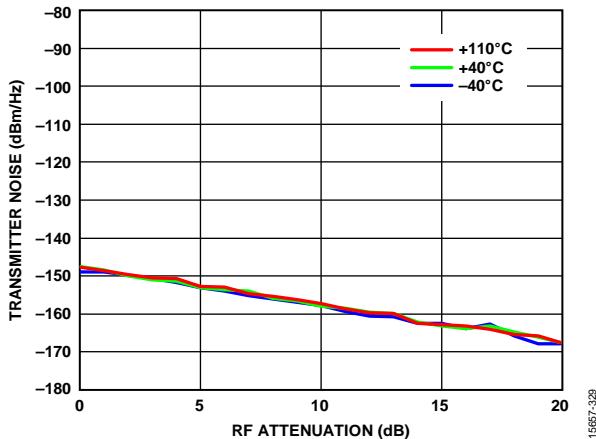
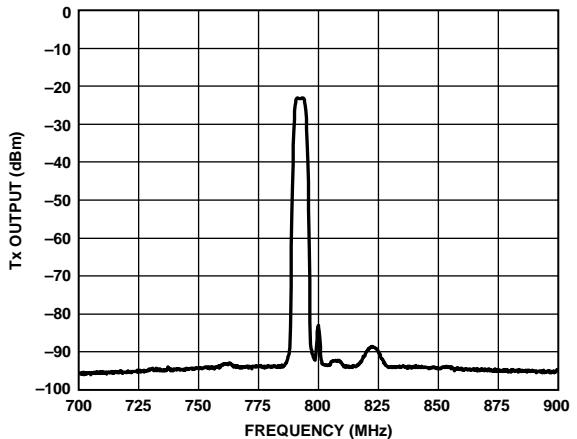
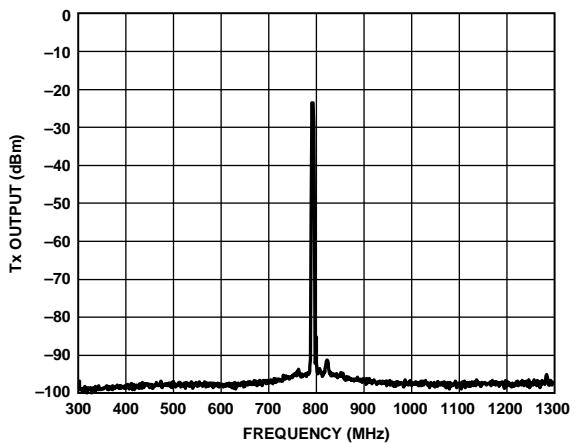


Figure 28. Tx2 to Tx1 Crosstalk vs. Transmitter LO Frequency, 20 MHz RF Bandwidth, CW Signal 3 MHz Offset from LO



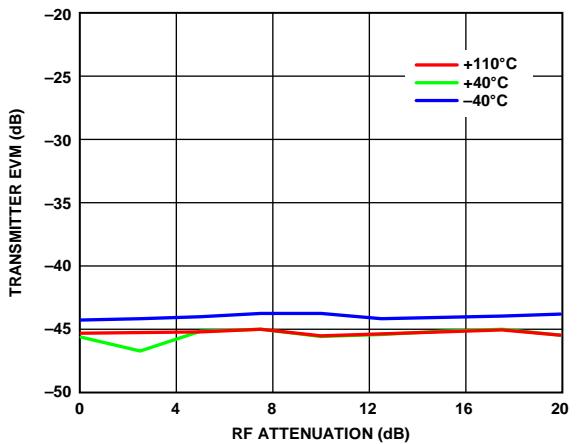


15657-335

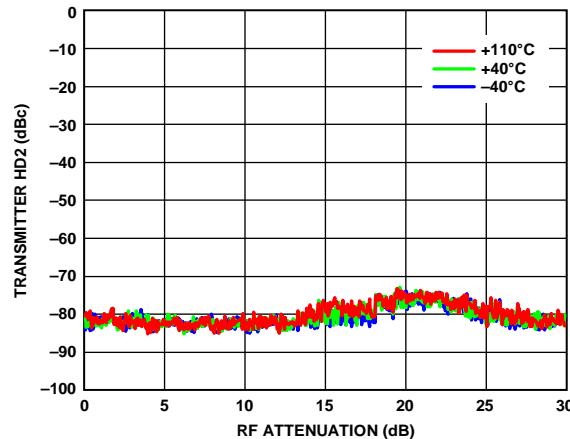


15657-336

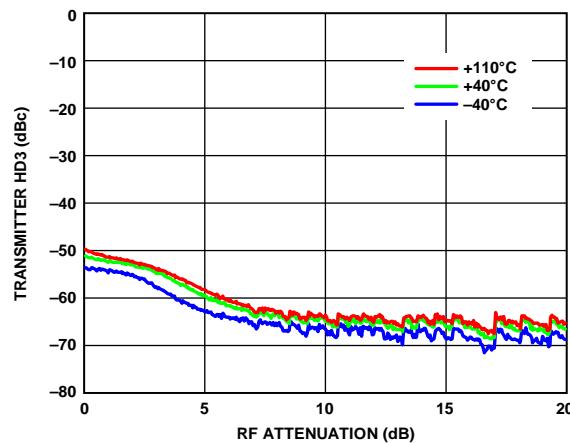
Figure 36. Tx Output Power Spectrum, 2 dB Digital and 3 dB RF Backoff, 20 MHz RF Bandwidth, Transmitter QEC, and Internal LO Leakage Active, LTE 10 MHz Signal, 800 MHz LO, 1 MHz Resolution Bandwidth, 122.88 MSPS Sample Rate, Expanded Frequency View, Test Equipment Noise Floor De-Embedded



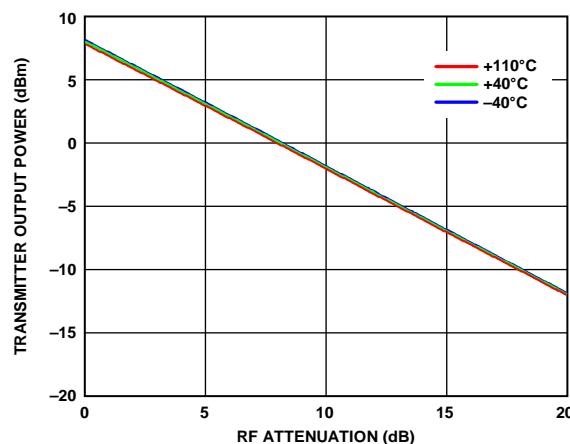
15657-337



15657-338



15657-339



15657-340

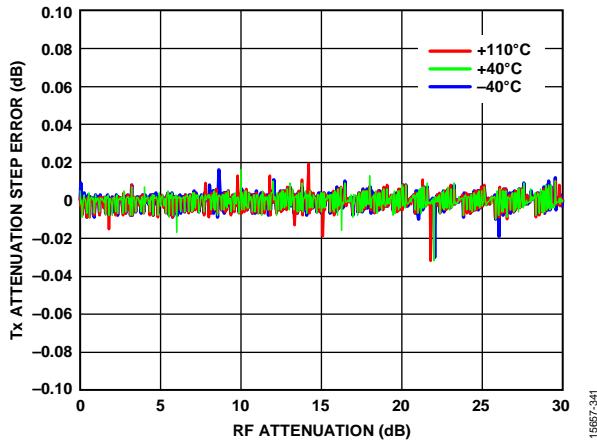


Figure 41. Tx Attenuation Step Error vs. RF Attenuation, 800 MHz LO, 810 MHz CW Desired Signal, 20 MHz RF Bandwidth, 122.88 MSPS Sample Rate

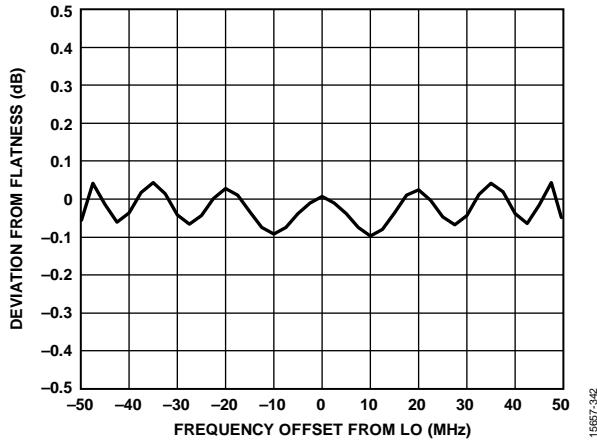


Figure 42. Transmitter Frequency Response Deviation from Flatness vs. Frequency Offset from LO, 800 MHz LO, 20 MHz RF Bandwidth, 6 dB Digital Backoff, 122.88 MSPS Sample Rate

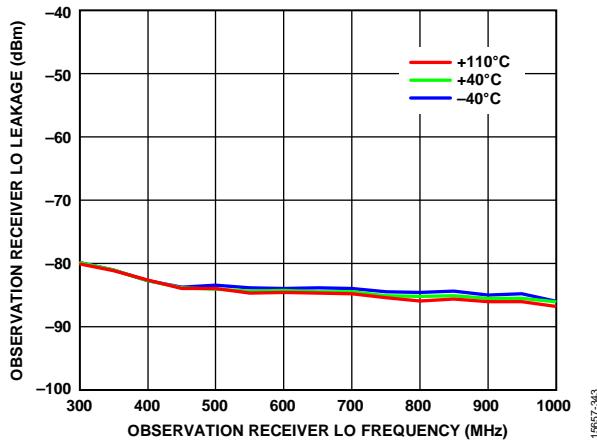


Figure 43. Observation Receiver LO Leakage vs. Observation Receiver LO Frequency, 0 dB Receiver Attenuation, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate

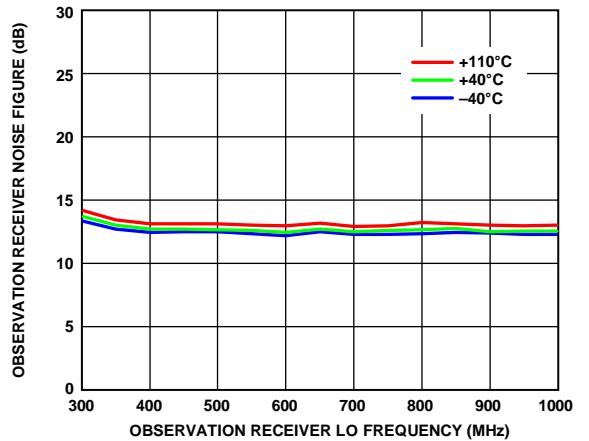


Figure 44. Observation Receiver Noise Figure vs. Observation Receiver LO Frequency, 0 dB Receiver Attenuation, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate, 100 MHz Integration Bandwidth

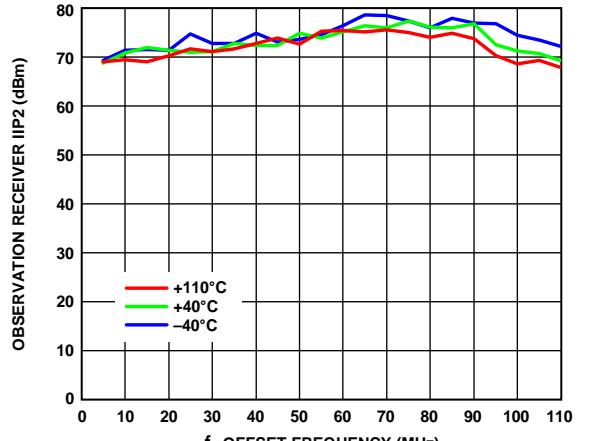


Figure 45. Observation Receiver IIP2 vs. f<sub>1</sub> Offset Frequency, 900 MHz LO, 0 dB Attenuation, 100 MHz RF Bandwidth, f<sub>2</sub> = f<sub>1</sub> + 1 MHz, 122.88 MSPS Sample Rate

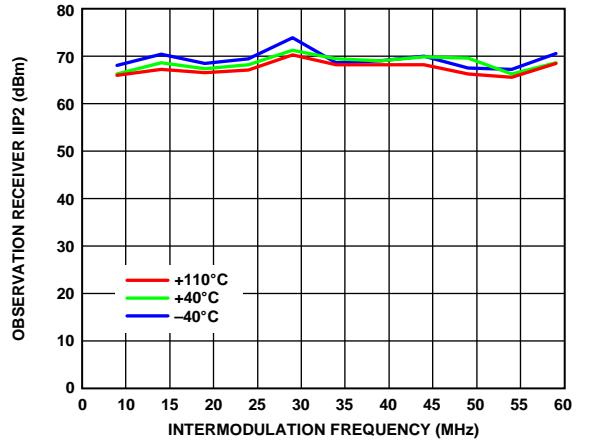


Figure 46. Observation Receiver IIP2 vs. Intermodulation Frequency (f<sub>2</sub> - f<sub>1</sub>), 900 MHz LO, 0 dB Attenuation, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate

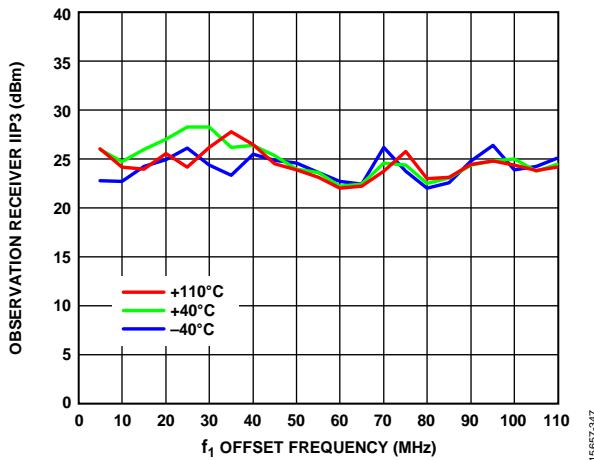


Figure 47. Observation Receiver IIP3 vs.  $f_1$  Offset Frequency, 900 MHz LO, 0 dB Attenuation, 100 MHz RF Bandwidth,  $f_2 = 2f_1 + 1$  MHz, 122.88 MSPS Sample Rate

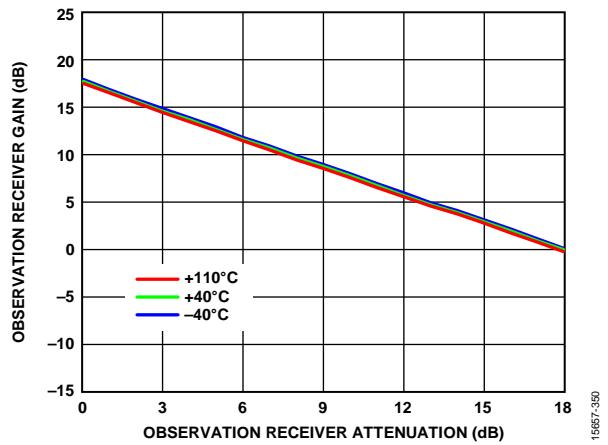


Figure 50. Observation Receiver Gain vs. Observation Receiver Attenuation, 800 MHz LO, CW Signal 16 MHz Offset, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate

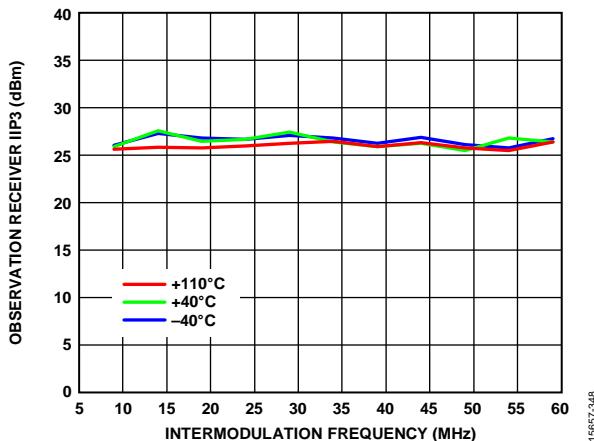


Figure 48. Observation Receiver IIP3 vs. Intermodulation Frequency ( $2f_2 - f_1$ ), 900 MHz LO, 0 dB Attenuation, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate

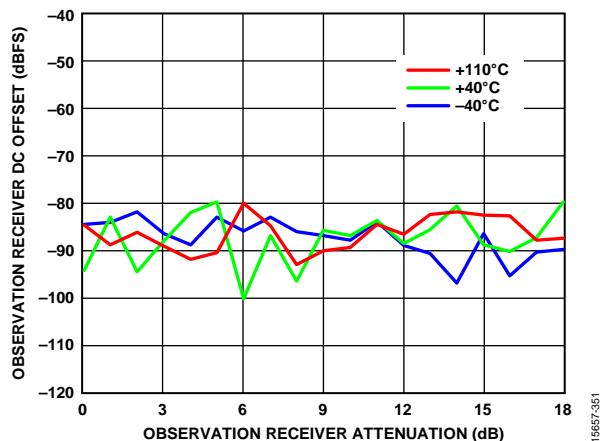


Figure 51. Observation Receiver DC Offset vs. Observation Receiver Attenuation, 800 MHz LO, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate

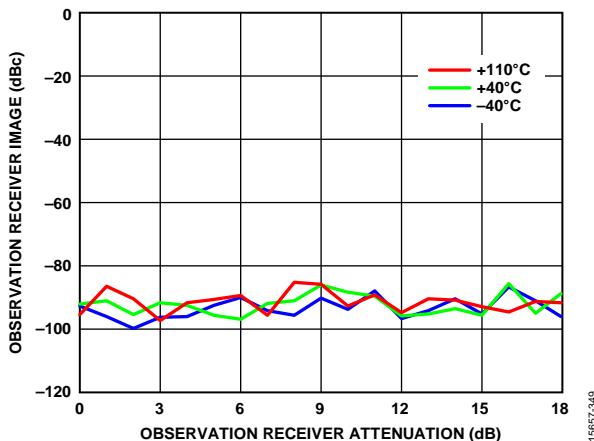


Figure 49. Observation Receiver Image vs. Observation Receiver Attenuation, 800 MHz LO, CW Signal 16 MHz Offset, 100 MHz RF Bandwidth, BTC Active, 122.88 MSPS Sample Rate

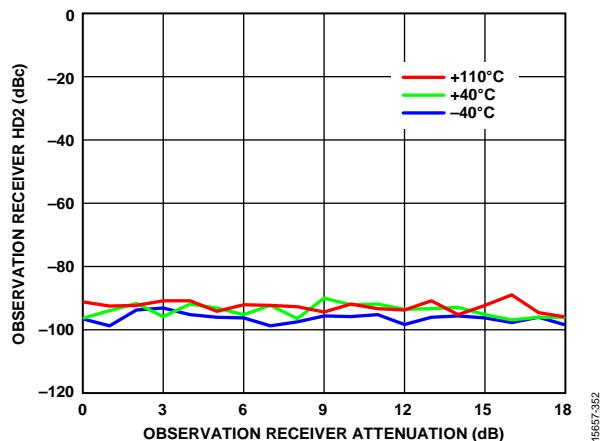


Figure 52. Observation Receiver HD2 vs. Observation Receiver Attenuation, 800 MHz LO, CW Signal 16 MHz Offset, -20 dBm at 0 dB Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate

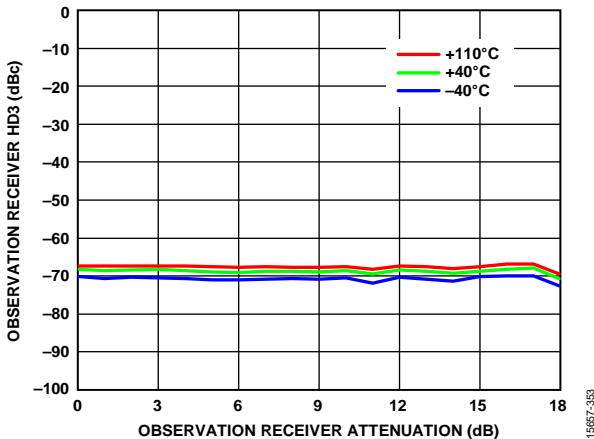


Figure 53. Observation Receiver HD3 vs. Observation Receiver Attenuation, 800 MHz LO, CW Signal 16 MHz Offset, -20 dBm at 0 dB Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate

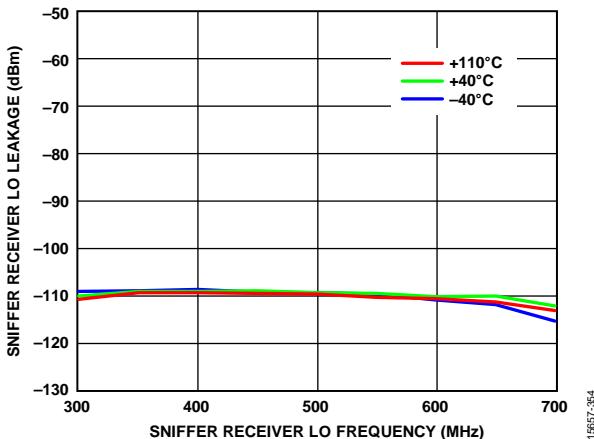


Figure 54. Sniffer Receiver LO Leakage vs. Sniffer Receiver LO Frequency, 0 dB Receiver Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

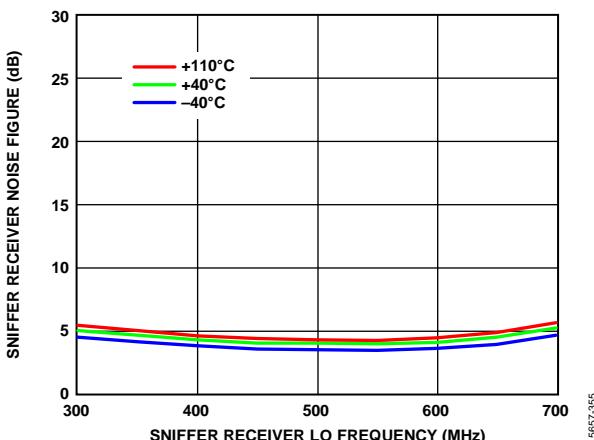


Figure 55. Sniffer Receiver Noise Figure vs. Sniffer Receiver LO Frequency, 0 dB Receiver Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate, 20 MHz Integration Bandwidth

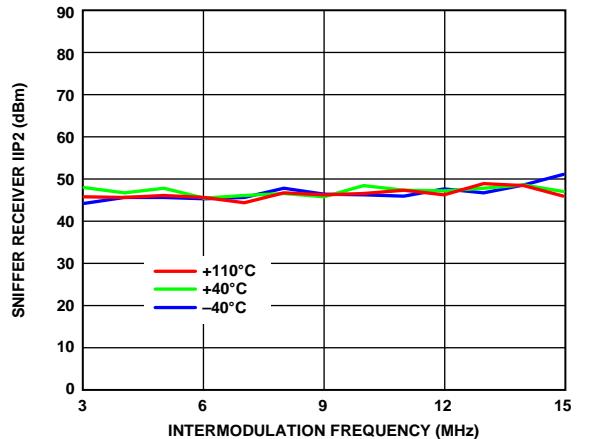


Figure 56. Sniffer Receiver IIP2 vs. Intermodulation Frequency ( $f_2 - f_1$ ), 600 MHz LO, 0 dB Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

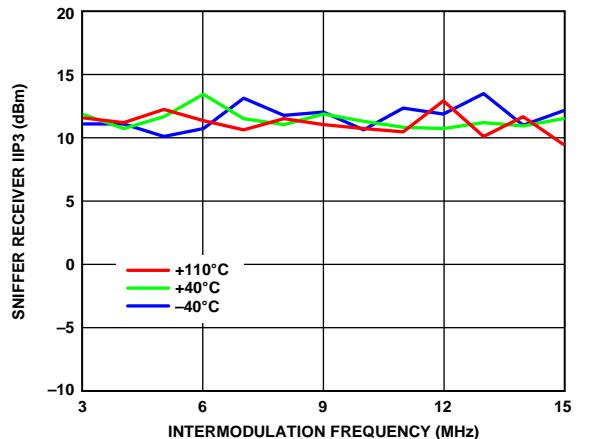


Figure 57. Sniffer Receiver IIP3 vs. Intermodulation Frequency ( $f_2 - 2f_1$ ), 600 MHz LO, 0 dB Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

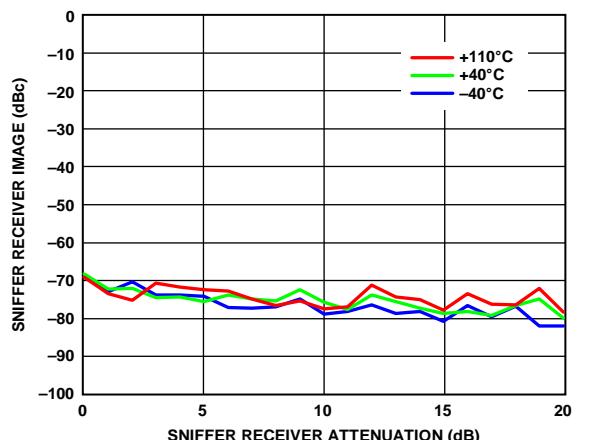


Figure 58. Sniffer Receiver Image vs. Sniffer Receiver Attenuation, 600 MHz LO, CW Signal 3 MHz Offset, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

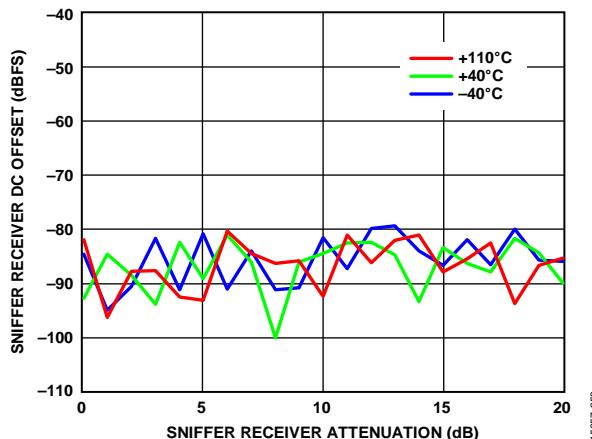


Figure 59. Sniffer Receiver DC Offset vs. Sniffer Receiver Attenuation, 600 MHz LO, CW Signal 3 MHz Offset,  $-35$  dBm at 0 dB Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

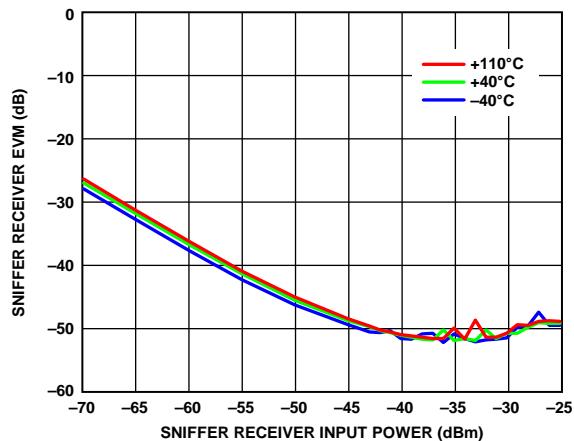


Figure 62. Sniffer Receiver EVM vs. Sniffer Receiver Input Power, 600 MHz LO, 20 MHz RF Bandwidth, LTE 20 MHz Uplink Centered at DC, BTC Active, 30.72 MSPS Sample Rate

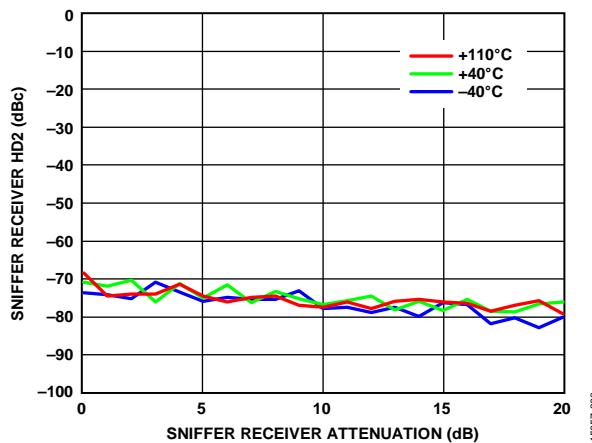


Figure 60. Sniffer Receiver HD2 vs. Sniffer Receiver Attenuation, 600 MHz LO, CW Signal 3 MHz Offset,  $-35$  dBm at 0 dB Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

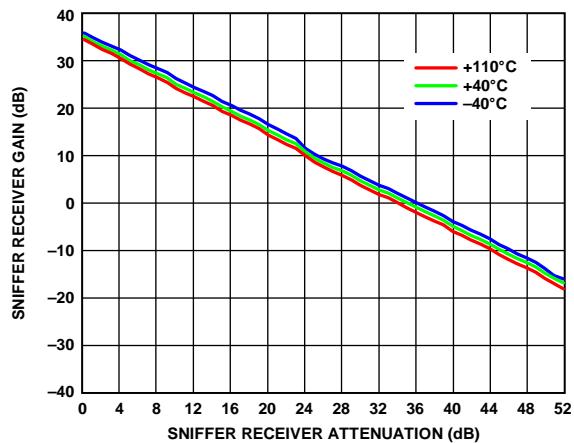


Figure 63. Sniffer Receiver Gain vs. Sniffer Receiver Attenuation, 600 MHz LO, CW Signal 3 MHz Offset, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

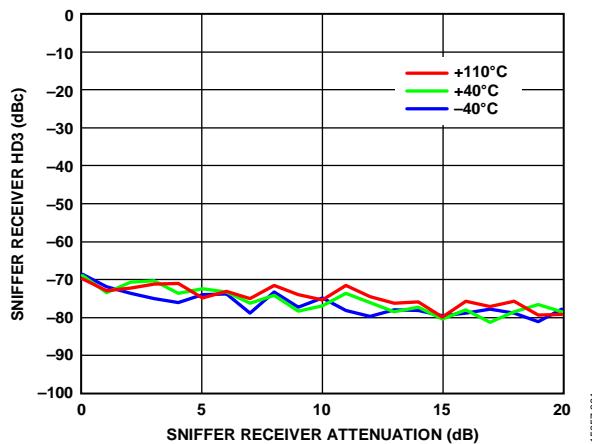


Figure 61. Sniffer Receiver HD3 vs. Sniffer Receiver Attenuation, 600 MHz LO, CW Signal 3 MHz Offset,  $-35$  dBm at 0 dB Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

## 2.6 GHz BAND

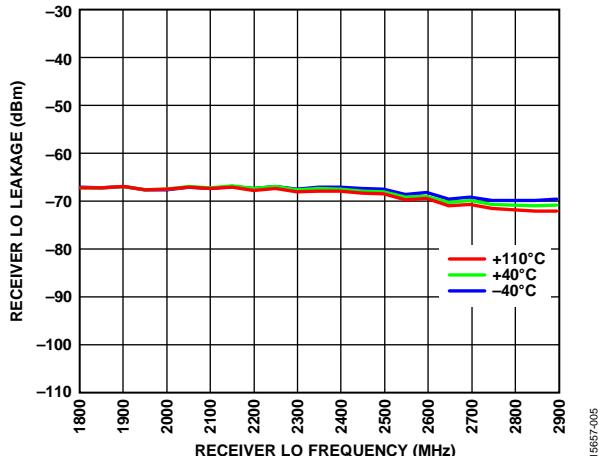


Figure 64. Receiver Local Oscillator (LO) Leakage vs. Receiver LO Frequency,  
0 dB Receiver Attenuation, 40 MHz RF Bandwidth, 122.88 MSPS Sample Rate

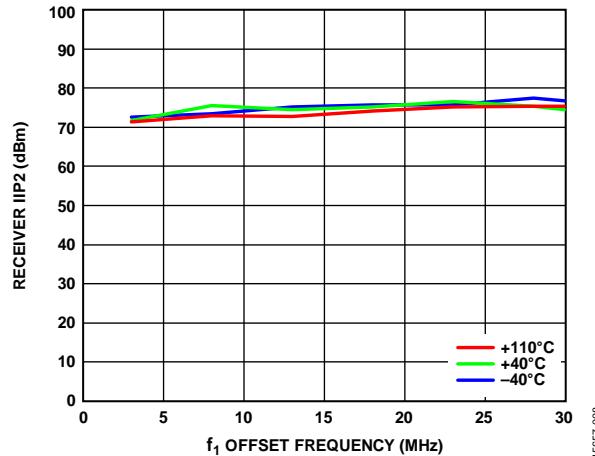


Figure 67. Receiver IIP2 vs.  $f_1$  Offset Frequency, 2600 MHz LO,  
0 dB Attenuation, 40 MHz RF Bandwidth,  $f_2 = f_1 + 1$  MHz,  
122.88 MSPS Sample Rate

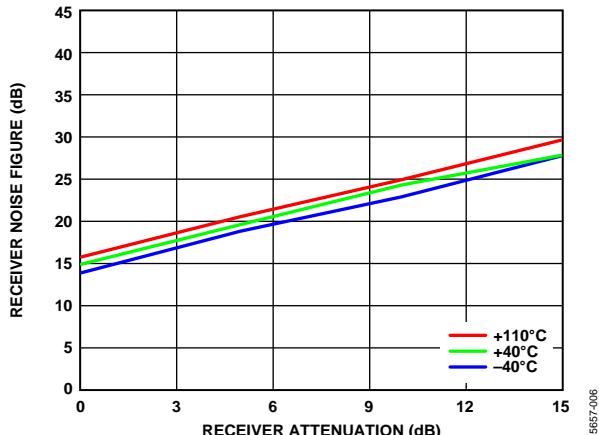


Figure 65. Receiver Noise Figure vs. Receiver Attenuation, 2600 MHz LO,  
40 MHz Bandwidth, 122.88 MSPS Sample Rate, 20 MHz Integration  
Bandwidth (Includes 1.4 dB Matching Circuit Loss)

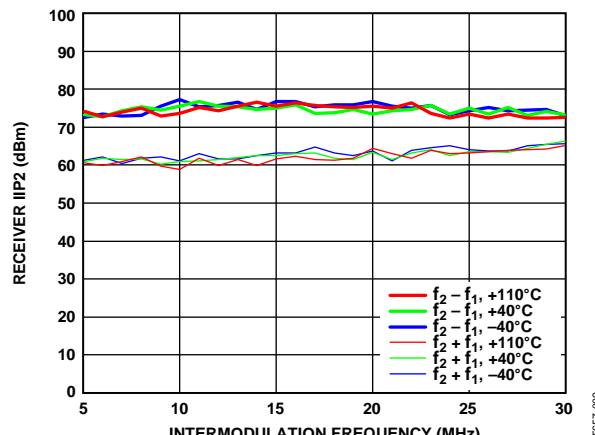


Figure 68. Receiver IIP2 vs. Intermodulation Frequency, 2600 MHz LO,  
0 dB Attenuation, 40 MHz RF Bandwidth, 122.88 MSPS Sample Rate

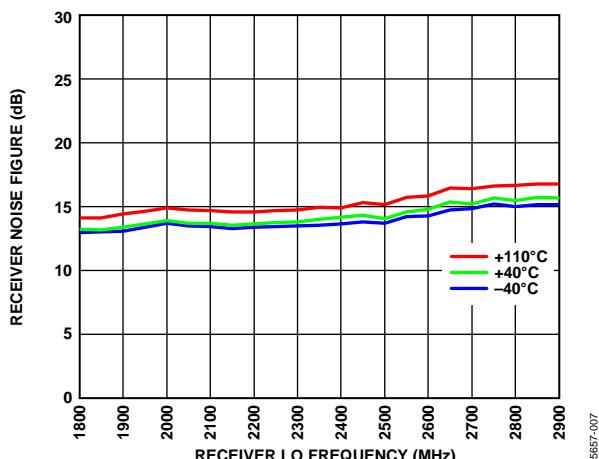


Figure 66. Receiver Noise Figure vs. Receiver LO Frequency,  
0 dB Receiver Attenuation, 40 MHz RF Bandwidth, 122.88 MSPS Sample Rate,  
20 MHz Integration Bandwidth (Includes 1.4 dB Matching Circuit Loss)

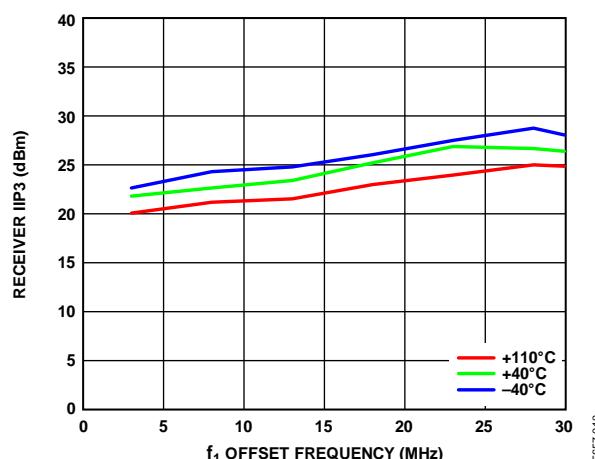
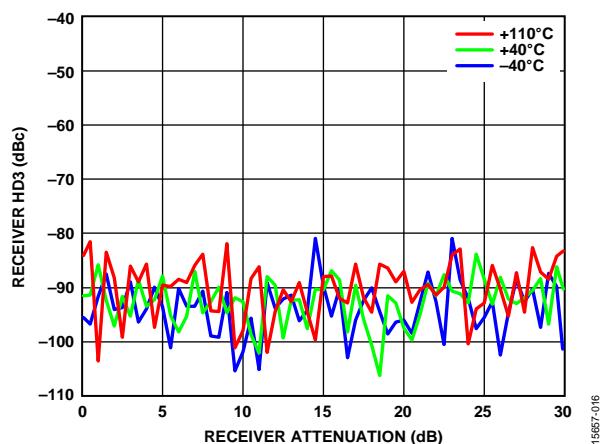
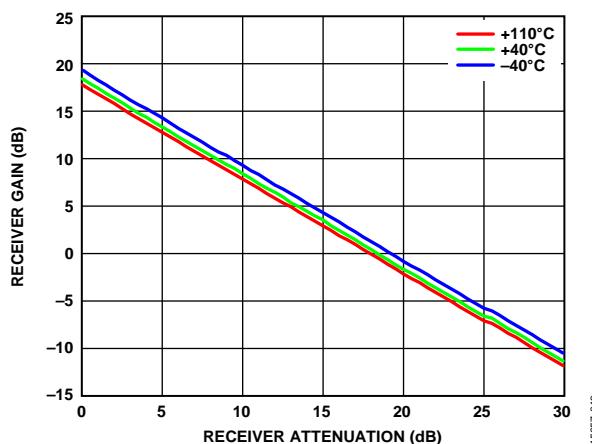
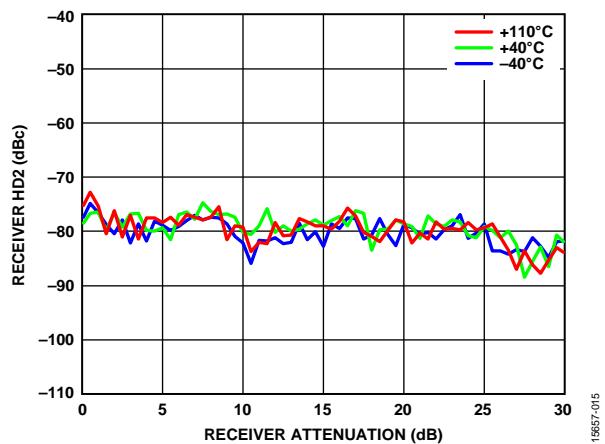
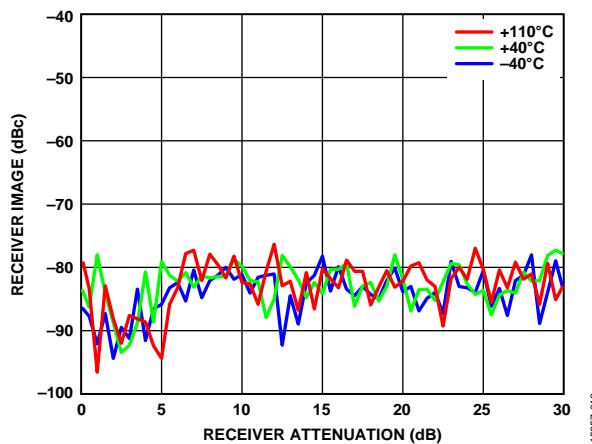
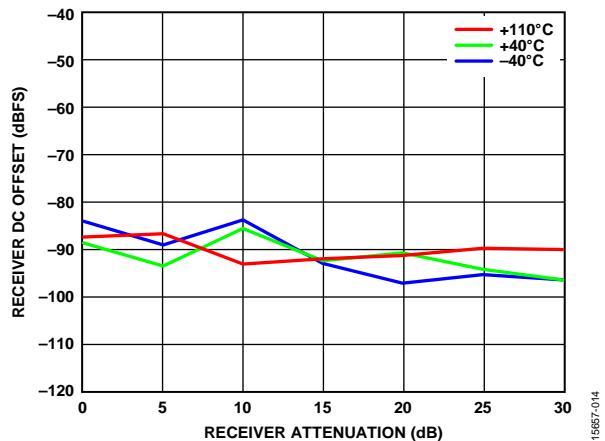
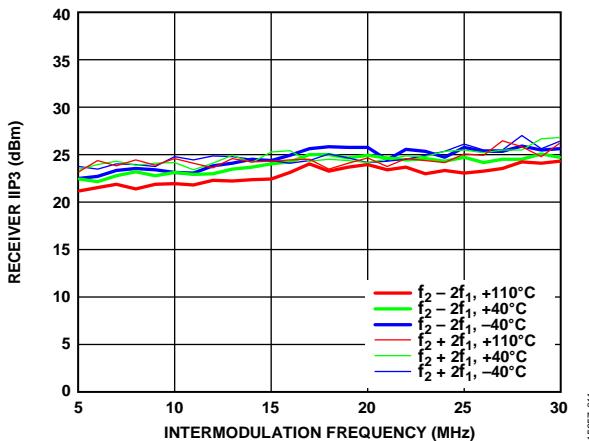


Figure 69. Receiver IIP3 vs.  $f_1$  Offset Frequency, 2600 MHz LO,  
0 dB Attenuation, 40 MHz RF Bandwidth,  $f_2 = 2f_1 + 2$  MHz,  
122.88 MSPS Sample Rate



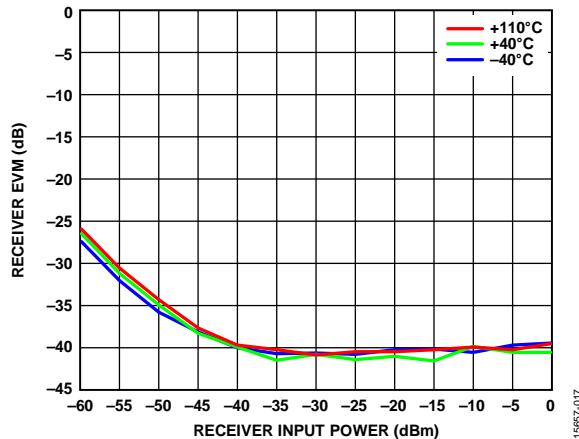


Figure 76. Receiver Error Vector Magnitude (EVM) vs. Receiver Input Power, 2600 MHz LO, 40 MHz RF Bandwidth, LTE 20 MHz Uplink Centered at DC, BTC Active, 122.88 MSPS Sample Rate

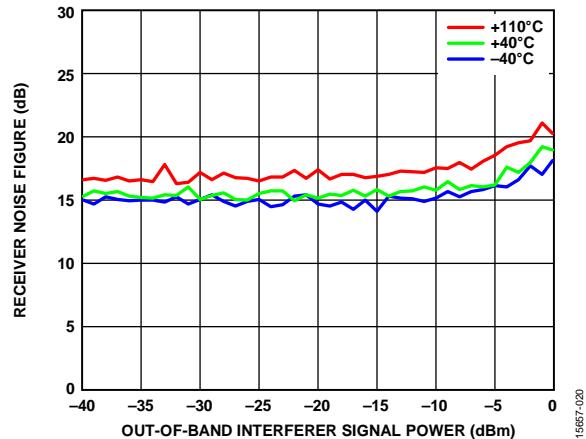


Figure 79. Receiver Noise Figure vs. Out-of-Band Interferer Signal Power, 2614 MHz LO, 2435 MHz CW Interferer, Noise Figure Integrated over 7 MHz to 10 MHz

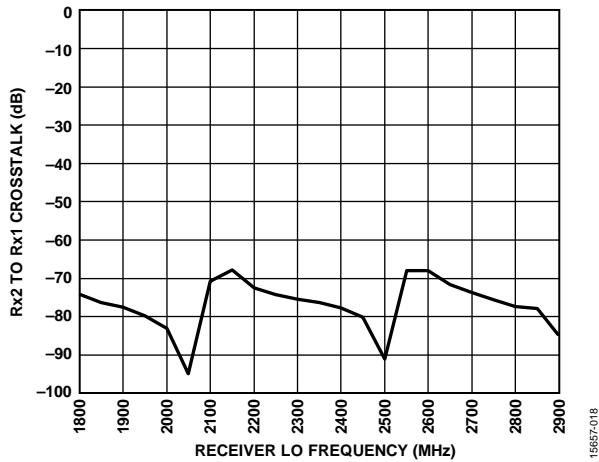


Figure 77. Rx2 to Rx1 Crosstalk vs. Receiver LO Frequency, 40 MHz RF Bandwidth, CW Tone 3 MHz Offset from LO

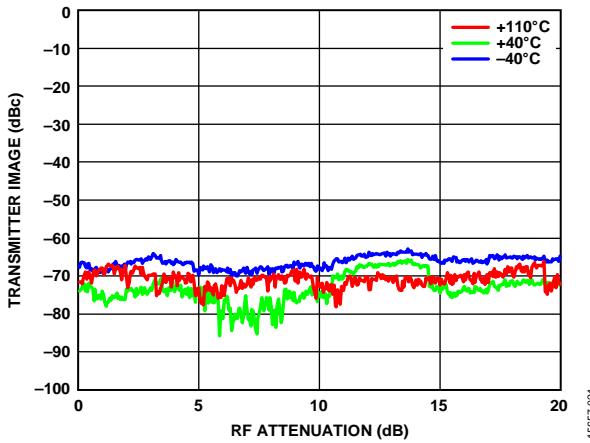


Figure 80. Transmitter Image vs. RF Attenuation, 40 MHz RF Bandwidth, 2600 MHz LO, Transmitter Quadrature Error Correction (QEC) Tracking Run with Two 20 MHz LTE Downlink Carriers, Then Image Measured with CW 10 MHz Offset from LO, 3 dB Digital Backoff, 245.76 MSPS Sample Rate

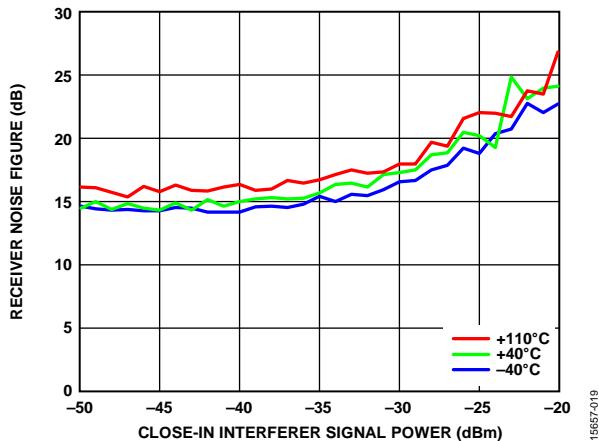


Figure 78. Receiver Noise Figure vs. Close-In Interferer Signal Power, 2614 MHz LO, 2625 MHz CW Interferer, Noise Figure Integrated over 7 MHz to 10 MHz, 40 MHz RF Bandwidth

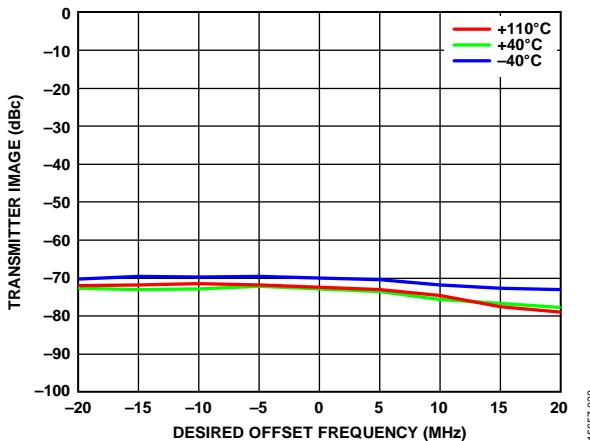


Figure 81. Transmitter Image vs. Desired Offset Frequency, 40 MHz RF Bandwidth, 2300 MHz LO, 0 dB RF Attenuation, Transmitter QEC Tracking Run with Two 20 MHz LTE Downlink Carriers, Then Image Measured with CW Signal, 3 dB Digital Backoff, 245.76 MSPS Sample Rate

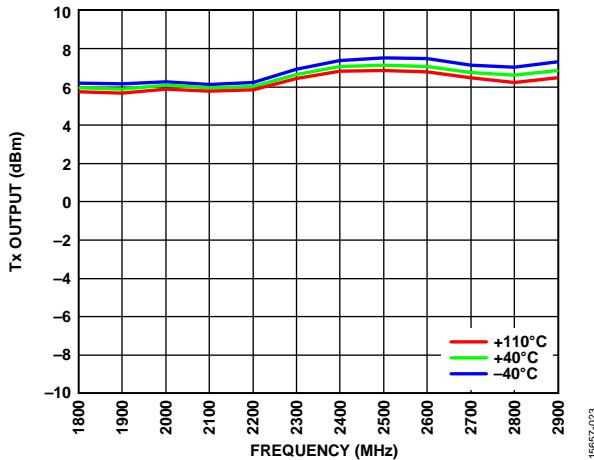


Figure 82. Tx Output Power, Transmitter QEC, and External LO Leakage Active, 5 MHz CW Offset Signal, 1 MHz Resolution Bandwidth, 245.76 MSPS Sample Rate

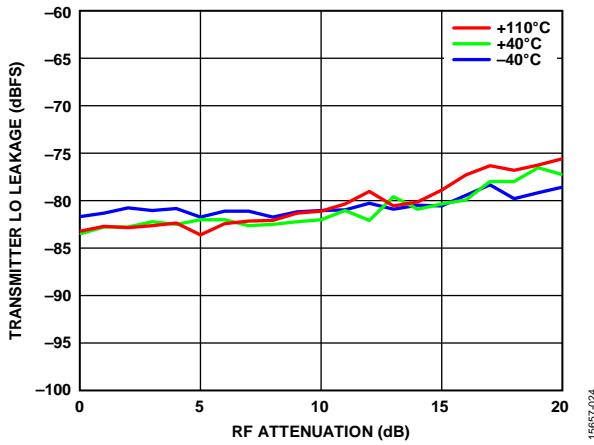


Figure 83. Transmitter LO Leakage vs. RF Attenuation, 2300 MHz LO, External Transmitter QEC and LO Leakage Tracking Active, CW Signal 10 MHz Offset from LO, 6 dB Digital Backoff, 1 MHz Measurement Bandwidth (If Input Power to the ORx Channel Is Not Held Constant, Device Performance Degrades as Shown in This Figure)

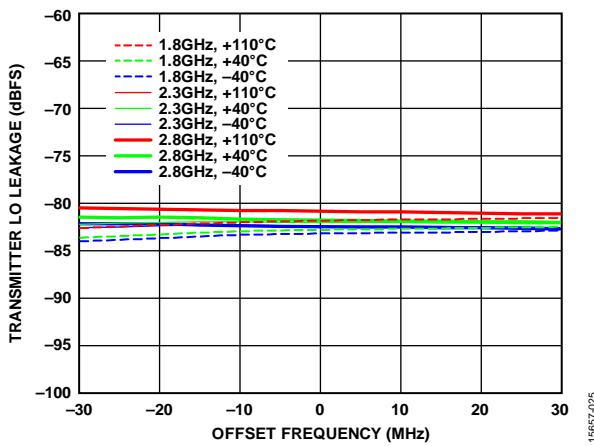


Figure 84. Transmitter LO Leakage vs. Offset Frequency, External Transmitter QEC and LO Leakage Tracking Active, 6 dB Digital Backoff, 1 MHz Measurement Bandwidth

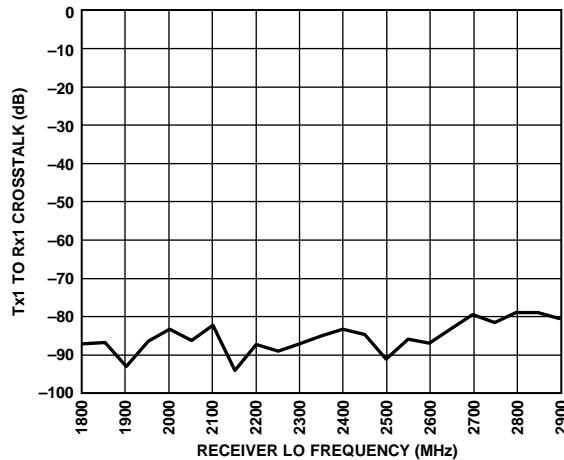


Figure 85. Tx1 to Rx1 Crosstalk vs. Receiver LO Frequency, 40 MHz Receiver RF Bandwidth, 40 MHz Transmitter RF Bandwidth, CW Signal 3 MHz Offset from LO

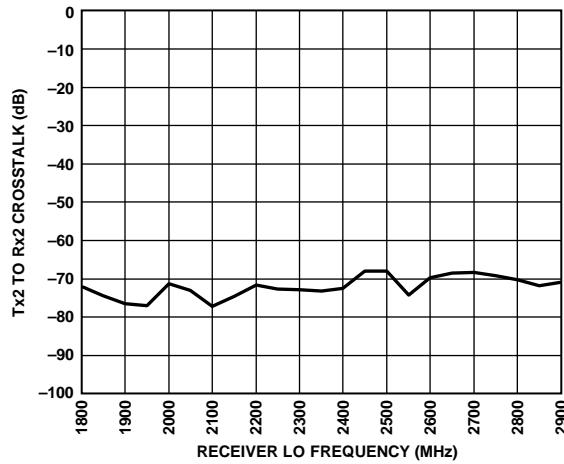


Figure 86. Tx2 to Rx2 Crosstalk vs. Receiver LO Frequency, 40 MHz Receiver RF Bandwidth, 40 MHz Transmitter RF Bandwidth, CW Signal 3 MHz Offset from LO

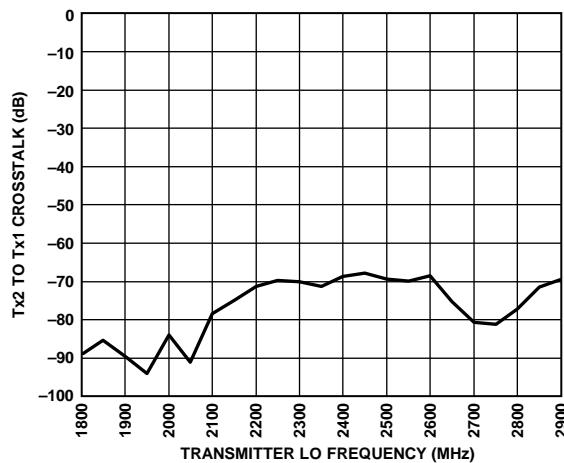
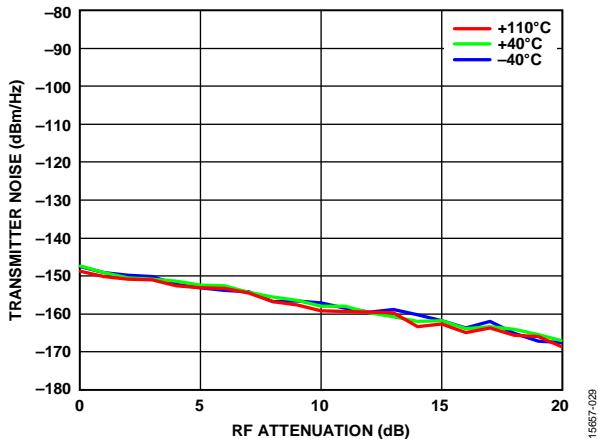
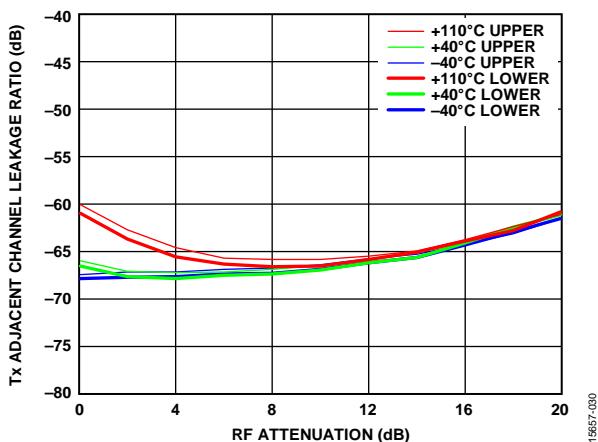


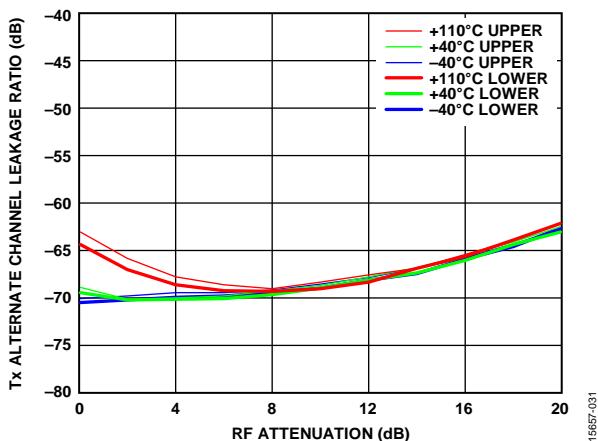
Figure 87. Tx2 to Tx1 Crosstalk vs. Transmitter LO Frequency, 40 MHz RF Bandwidth, CW Signal 3 MHz Offset from LO



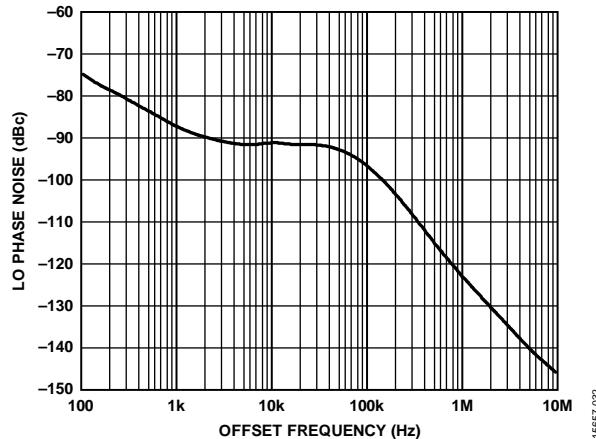
15657-029



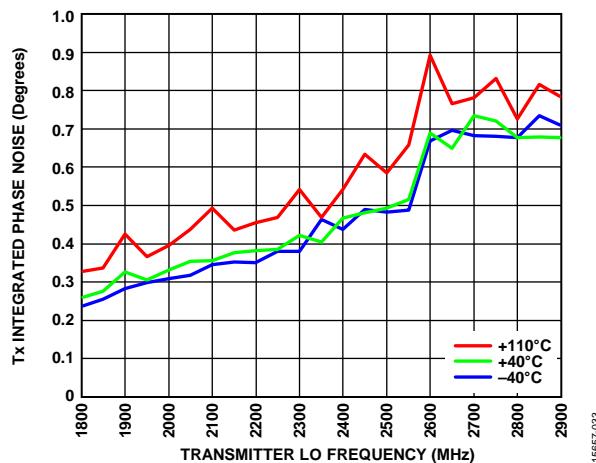
15657-030



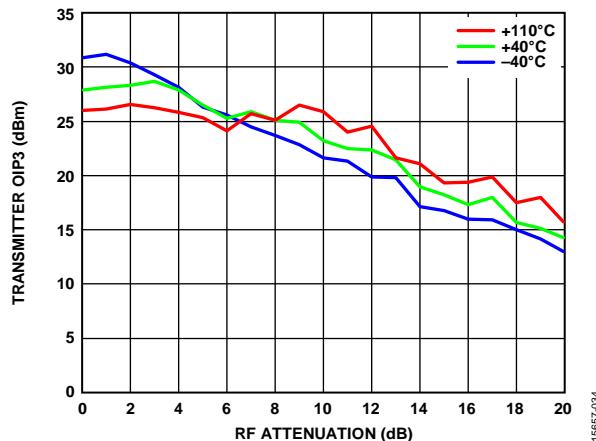
15657-031



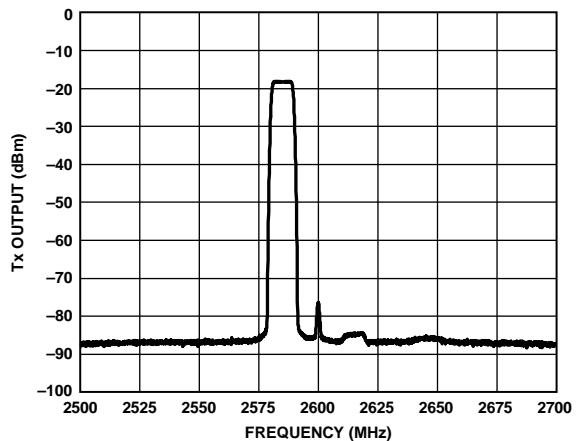
15657-032



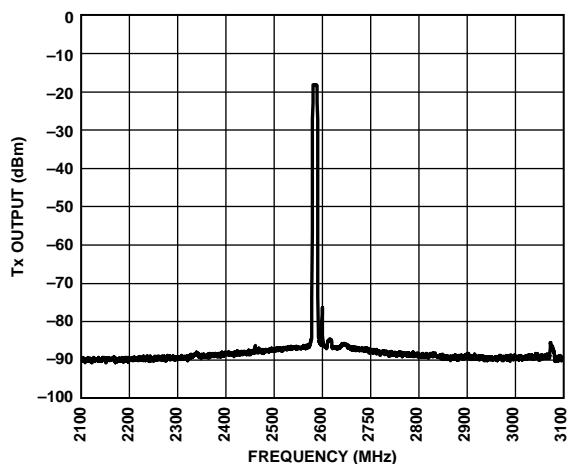
15657-033



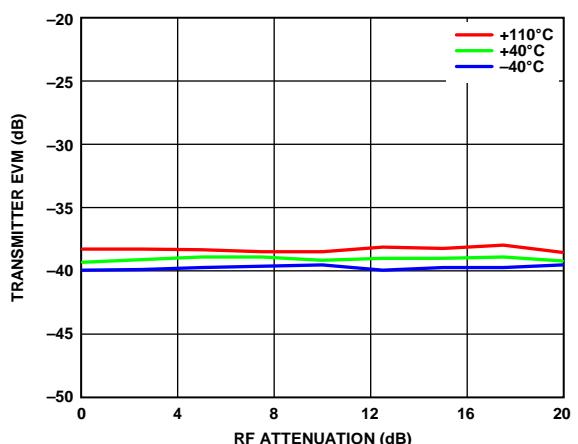
15657-034



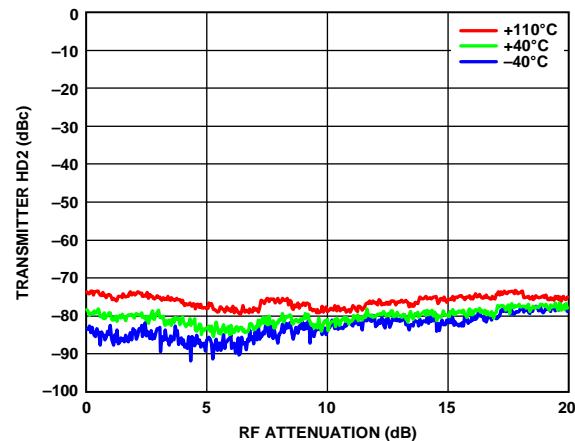
15657-036



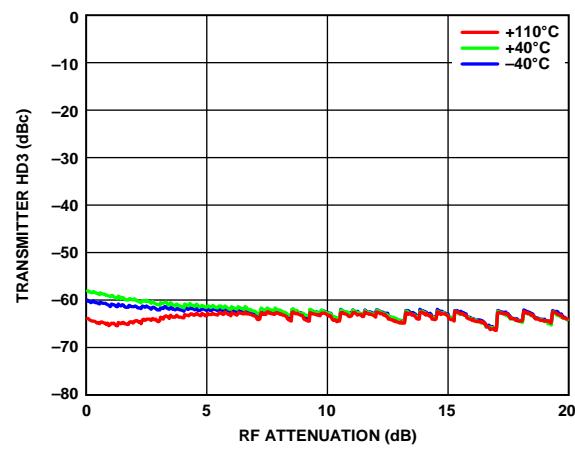
15657-036



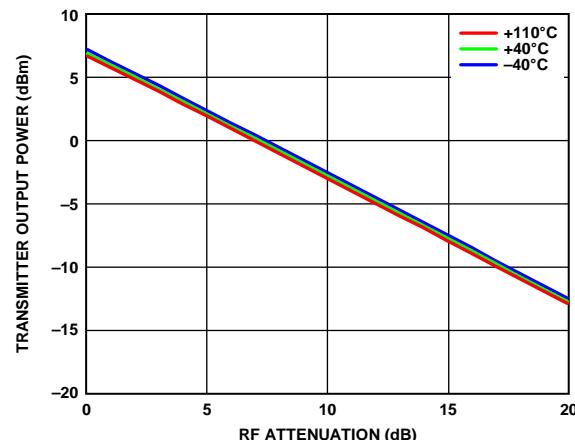
15657-037



15657-038



15657-039



15657-040

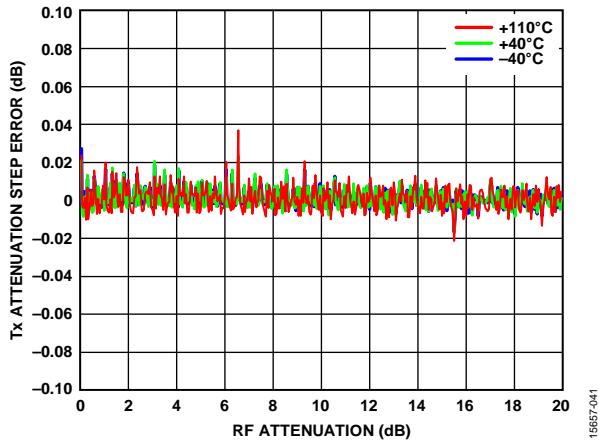


Figure 100. Tx Attenuation Step Error vs. RF Attenuation, 2600 MHz LO, 2610 MHz CW Desired Signal, 40 MHz RF Bandwidth, 245.76 MSPS Sample Rate

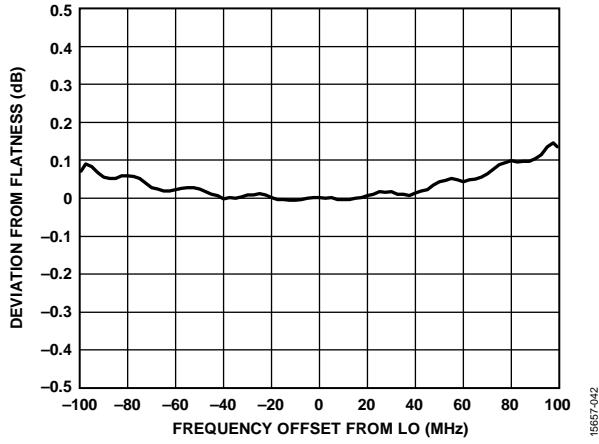


Figure 101. Transmitter Frequency Response Deviation from Flatness vs. Frequency Offset from LO, 2600 MHz LO, 100 MHz RF Bandwidth, 6 dB Digital Backoff, 245.76 MSPS Sample Rate

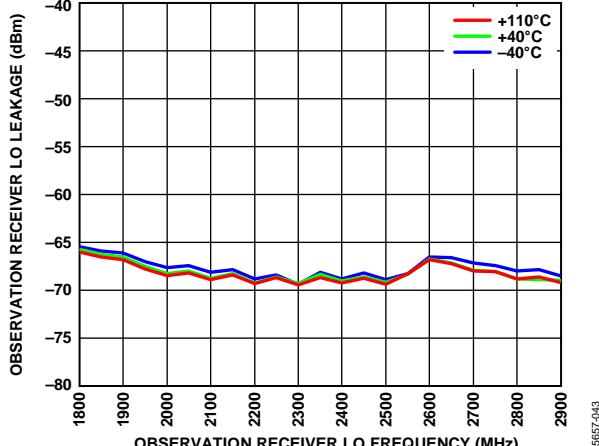


Figure 102. Observation Receiver LO Leakage vs. Observation Receiver LO Frequency, 0 dB Receiver Attenuation, 200 MHz RF Bandwidth, 245.76 MSPS Sample Rate

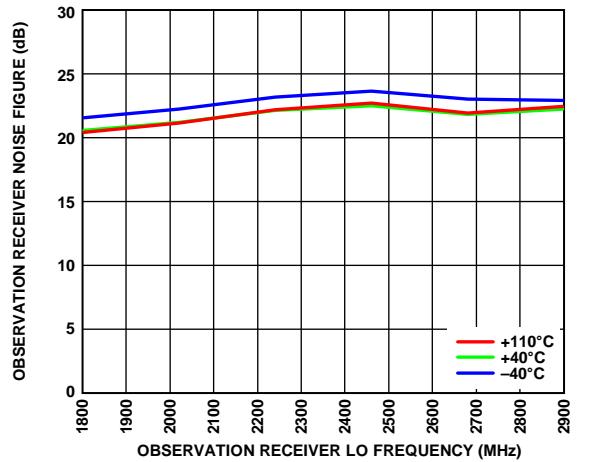


Figure 103. Observation Receiver Noise Figure vs. Observation Receiver LO Frequency, 0 dB Receiver Attenuation, 200 MHz RF Bandwidth, 245.76 MSPS Sample Rate, 100 MHz Integration Bandwidth

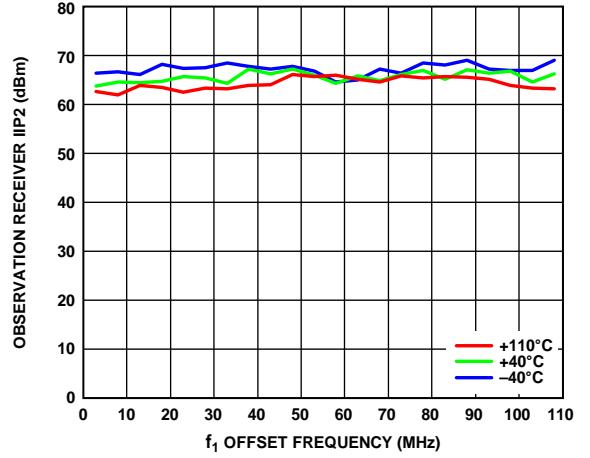


Figure 104. Observation Receiver IIP2 vs. f<sub>1</sub> Offset Frequency, 2600 MHz LO, 0 dB Attenuation, 200 MHz RF Bandwidth, f<sub>2</sub> = f<sub>1</sub> + 1 MHz, 245.76 MSPS Sample Rate

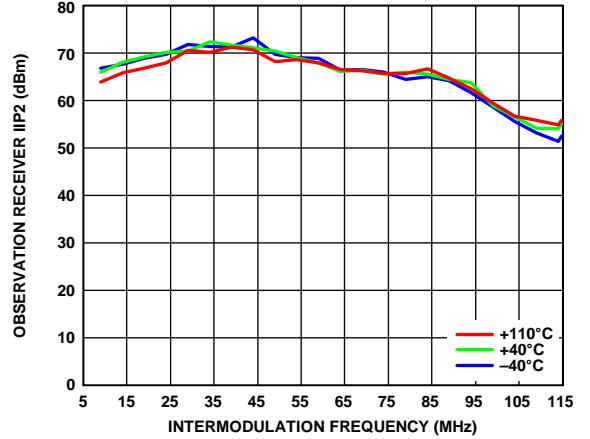
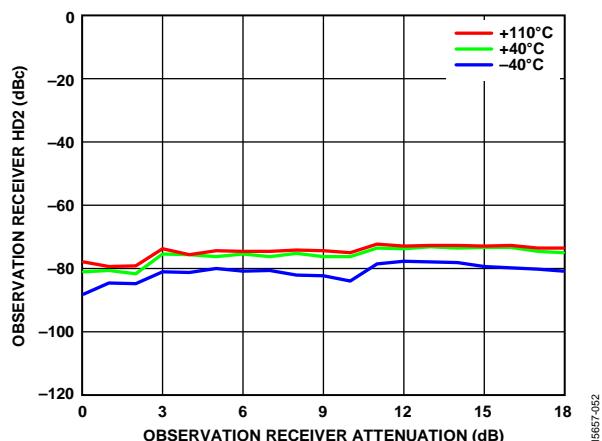
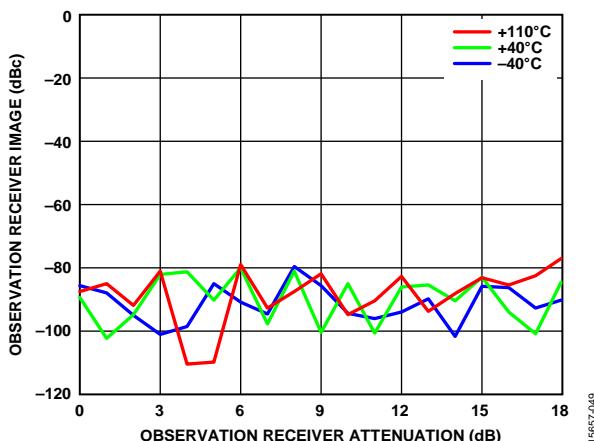
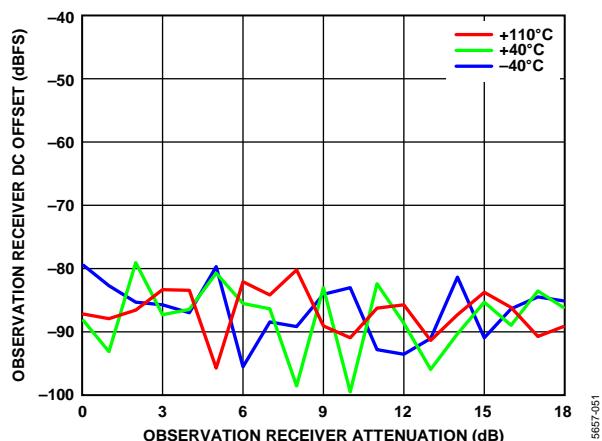
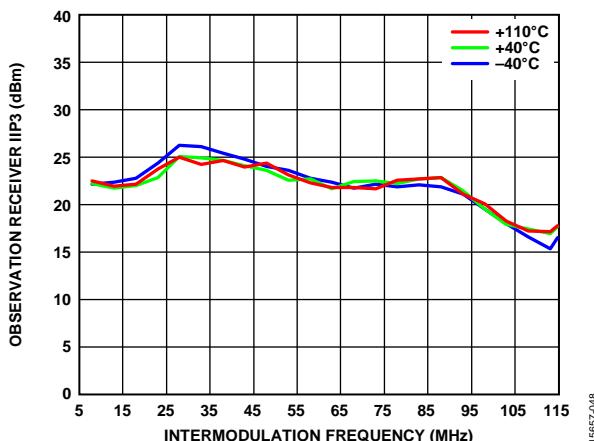
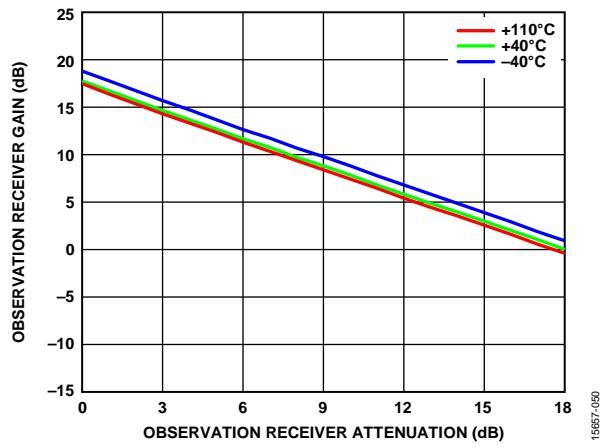
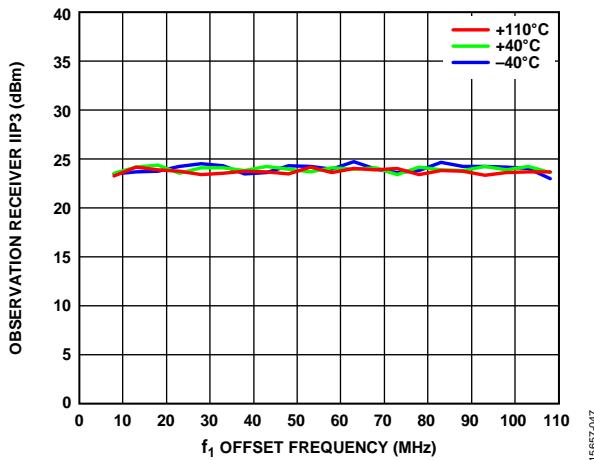


Figure 105. Observation Receiver IIP2 vs. Intermodulation Frequency (f<sub>2</sub> - f<sub>1</sub>), 2600 MHz LO, 0 dB Attenuation, 200 MHz RF Bandwidth, 245.76 MSPS Sample Rate



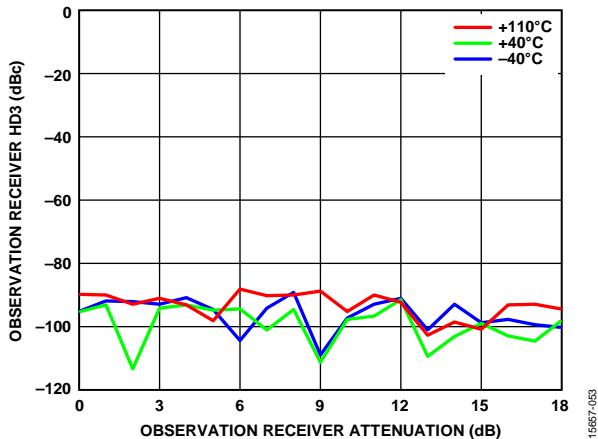


Figure 112. Observation Receiver HD3 vs. Observation Receiver Attenuation,  
2600 MHz LO, CW Signal 25 MHz Offset, -20 dBm at 0 dB Attenuation,  
Input Power Increasing Decibel for Decibel with Attenuation,  
200 MHz RF Bandwidth, 245.76 MSPS Sample Rate

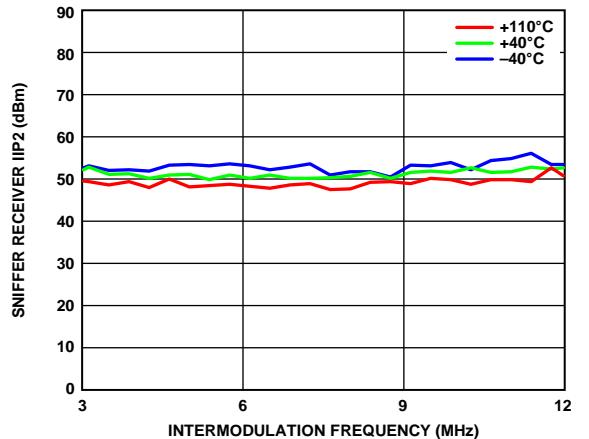


Figure 115. Sniffer Receiver IIP2 vs. Intermodulation Frequency ( $f_2 - f_1$ ),  
2600 MHz LO, 0 dB Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

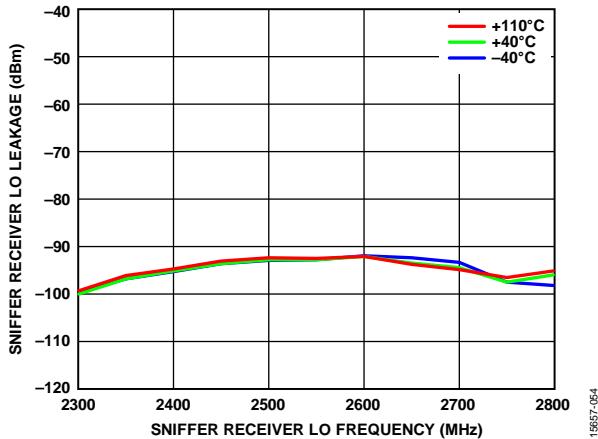


Figure 113. Sniffer Receiver LO Leakage vs. Sniffer Receiver LO Frequency,  
0 dB Receiver Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

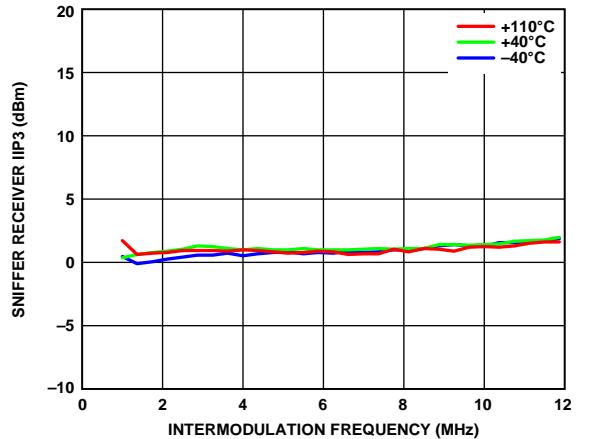


Figure 116. Sniffer Receiver IIP3 vs. Intermodulation Frequency ( $f_2 - 2f_1$ ), 2600 MHz  
LO, 0 dB Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

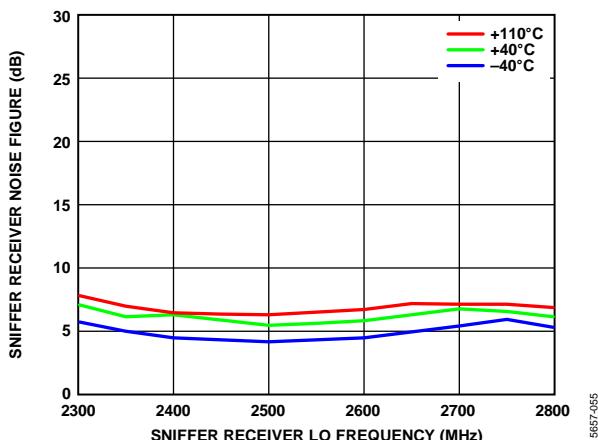


Figure 114. Sniffer Receiver Noise Figure vs. Sniffer Receiver LO Frequency,  
0 dB Receiver Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate,  
20 MHz Integration Bandwidth

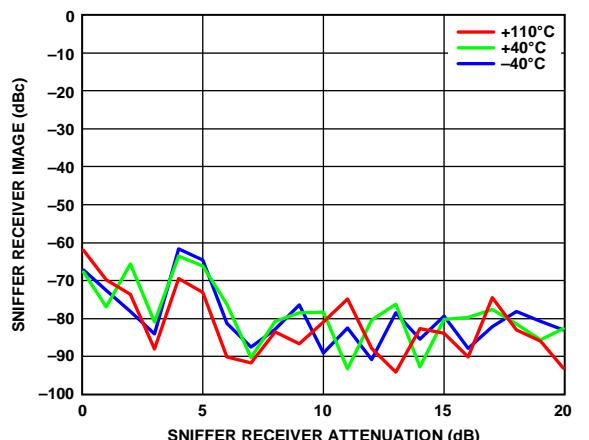


Figure 117. Sniffer Receiver Image vs. Sniffer Receiver Attenuation, 2600 MHz  
LO, CW Signal 1 MHz Offset, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

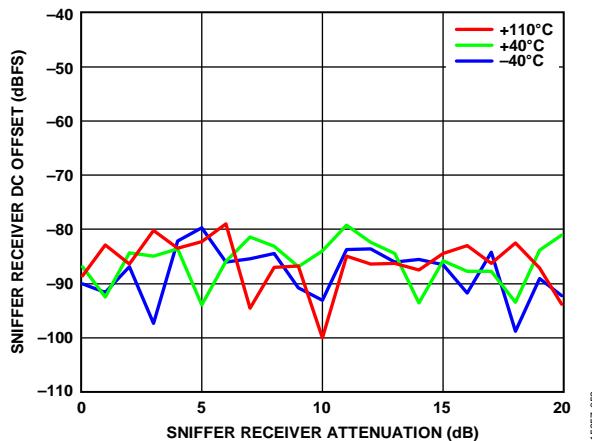


Figure 118. Sniffer Receiver DC Offset vs. Sniffer Receiver Attenuation, 2600 MHz LO, CW Signal 1 MHz Offset,  $-35 \text{ dBm}$  at  $0 \text{ dB}$  Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

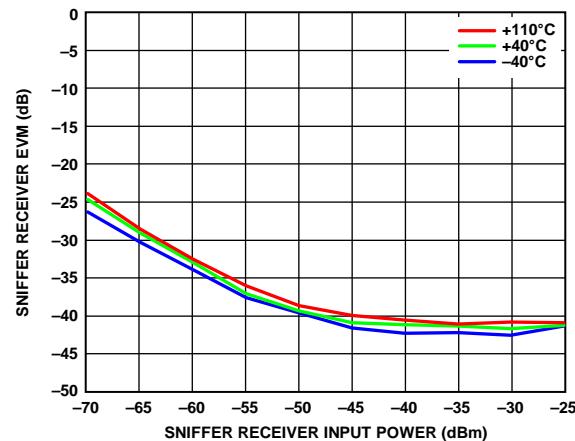


Figure 121. Sniffer Receiver EVM vs. Sniffer Receiver Input Power, 2600 MHz LO, 20 MHz RF Bandwidth, LTE 20 MHz Uplink Centered at DC, BTC Active, 30.72 MSPS Sample Rate

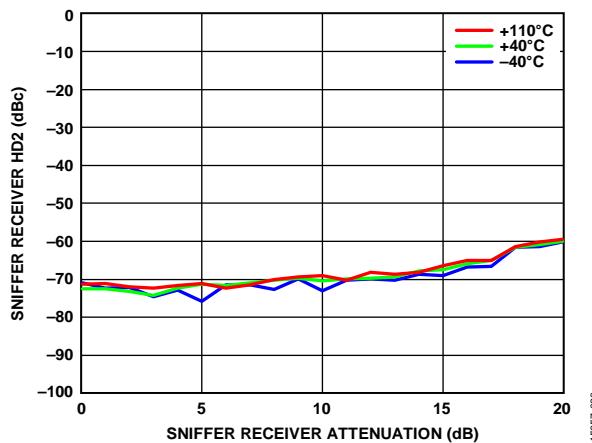


Figure 119. Sniffer Receiver HD2 vs. Sniffer Receiver Attenuation, 2600 MHz LO, CW Signal 1 MHz Offset,  $-35 \text{ dBm}$  at  $0 \text{ dB}$  Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

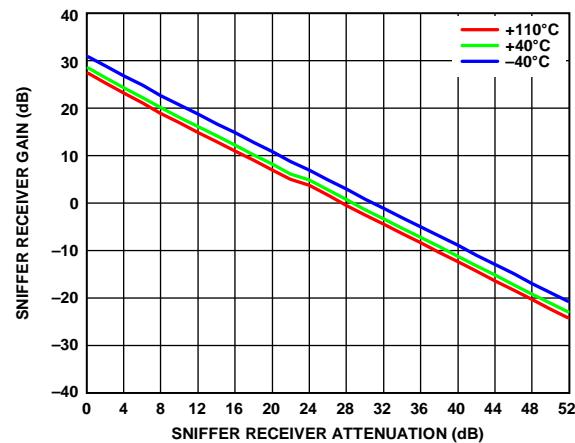


Figure 122. Sniffer Receiver Gain vs. Sniffer Receiver Attenuation, 2600 MHz LO, CW Signal 1 MHz Offset, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

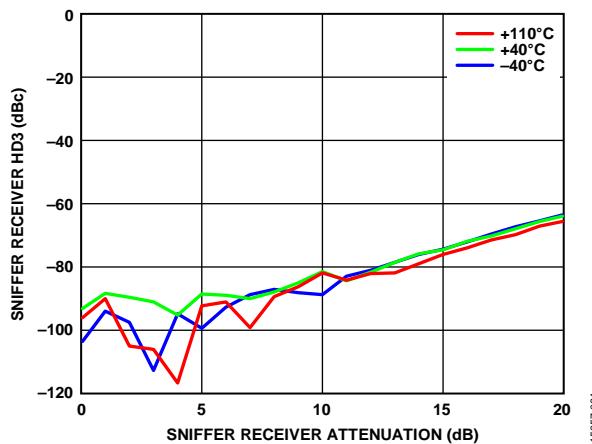


Figure 120. Sniffer Receiver HD3 vs. Sniffer Receiver Attenuation, 2600 MHz LO, CW Signal 1 MHz Offset,  $-35 \text{ dBm}$  at  $0 \text{ dB}$  Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 20 MHz RF Bandwidth, 30.72 MSPS Sample Rate

## 3.5 GHz BAND

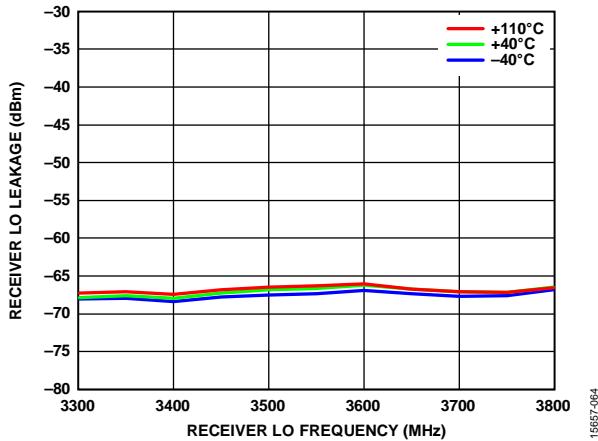


Figure 123. Receiver Local Oscillator (LO) Leakage vs. Receiver LO Frequency, 0 dB Receiver Attenuation, 100 MHz RF Bandwidth, 153.6 MSPS Sample Rate

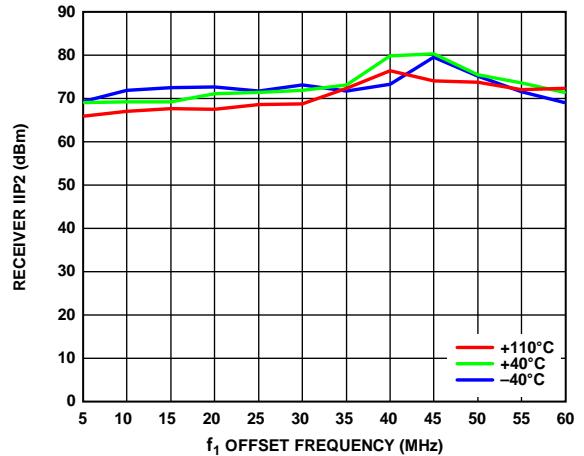


Figure 126. Receiver IIP2 vs.  $f_1$  Offset Frequency, 3500 MHz LO, 0 dB Attenuation, 100 MHz RF Bandwidth,  $f_2 = f_1 + 1$  MHz, 153.6 MSPS Sample Rate

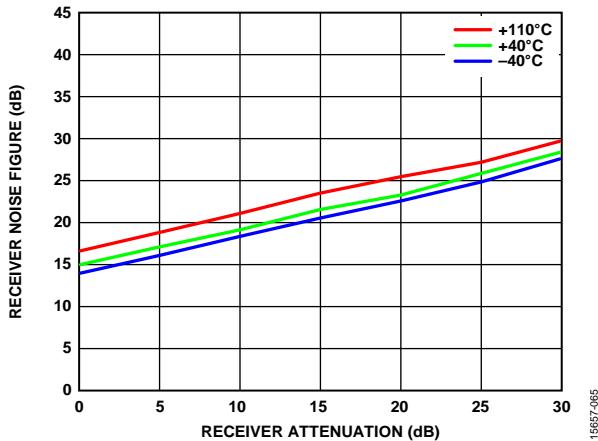


Figure 124. Receiver Noise Figure vs. Receiver Attenuation, 3500 MHz LO, 100 MHz Bandwidth, 153.6 MSPS Sample Rate, 50 MHz Integration Bandwidth (Includes 1 dB Matching Circuit Loss)

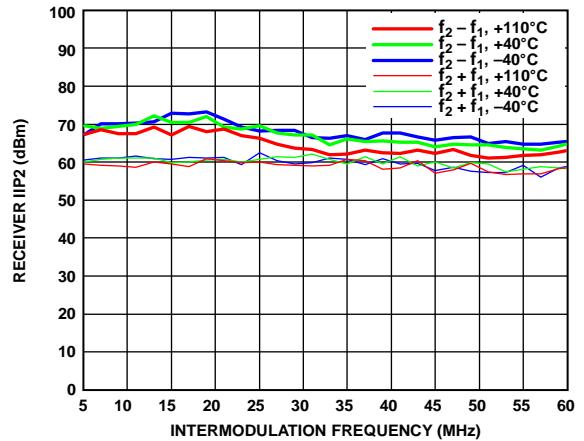


Figure 127. Receiver IIP2 vs. Intermodulation Frequency, 3500 MHz LO, 0 dB Attenuation, 100 MHz RF Bandwidth, 153.6 MSPS Sample Rate

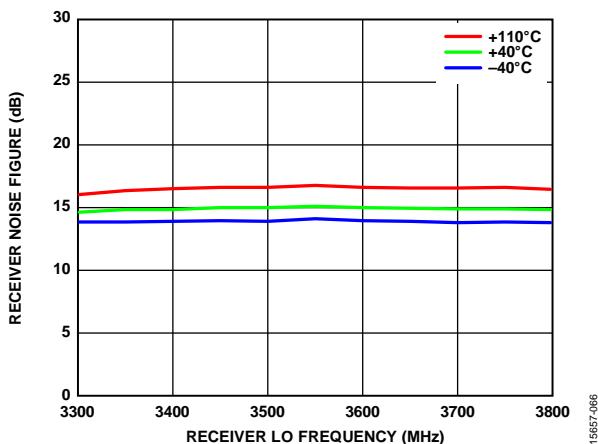


Figure 125. Receiver Noise Figure vs. Receiver LO Frequency, 0 dB Receiver Attenuation, 100 MHz RF Bandwidth, 153.6 MSPS Sample Rate, 50 MHz Integration Bandwidth (Includes 1 dB Matching Circuit Loss)

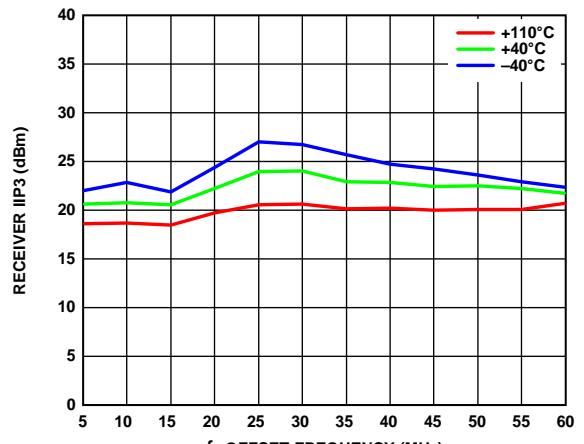


Figure 128. Receiver IIP3 vs.  $f_1$  Offset Frequency, 3500 MHz LO, 0 dB Attenuation, 100 MHz RF Bandwidth,  $f_2 = 2f_1 + 1$  MHz, 153.6 MSPS Sample Rate

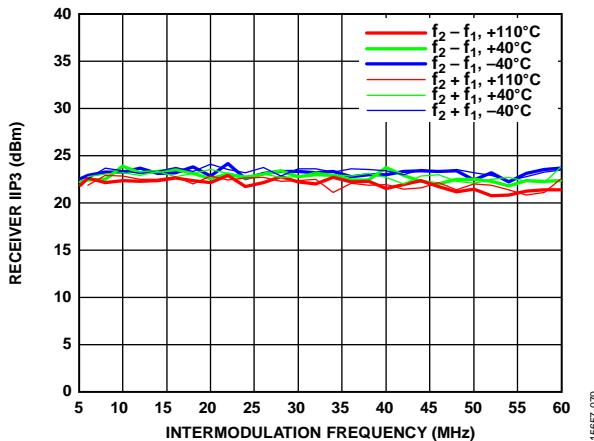


Figure 129. Receiver IIP3 vs. Intermodulation Frequency, 3500 MHz LO, 0 dB Attenuation, 100 MHz RF Bandwidth, 153.6 MSPS Sample Rate

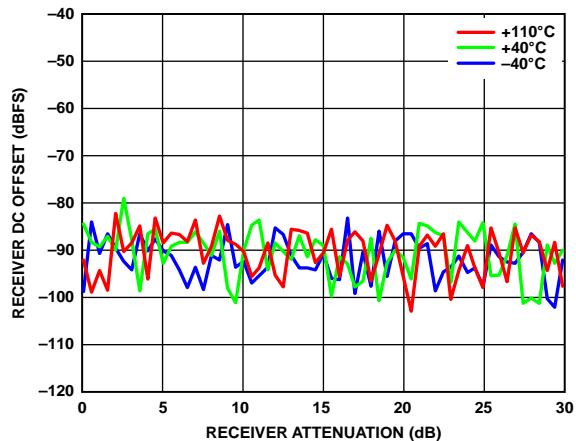


Figure 132. Receiver DC Offset vs. Receiver Attenuation, 3500 MHz LO, 100 MHz RF Bandwidth, 153.6 MSPS Sample Rate

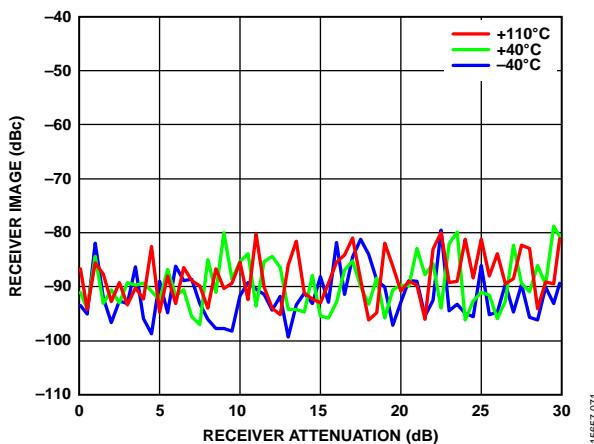


Figure 130. Receiver Image vs. Receiver Attenuation, 3500 MHz LO, Continuous Wave (CW) Signal 17 MHz Offset, 100 MHz RF Bandwidth, Background Tracking Calibration (BTC) Active, 153.6 MSPS Sample Rate

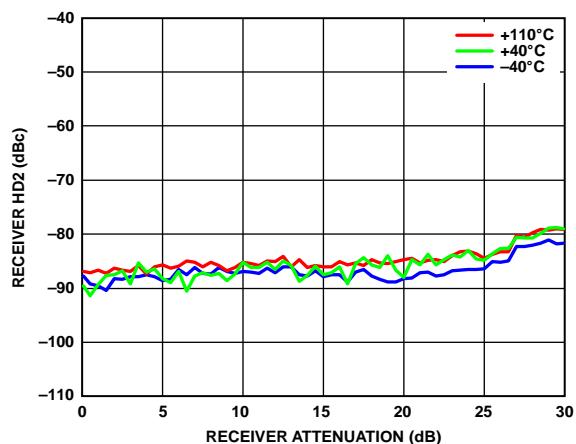


Figure 133. Receiver HD2 vs. Receiver Attenuation, 3500 MHz LO, CW Signal 17 MHz Offset,  $-14\text{ dBm}$  at 0 dB Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 100 MHz RF Bandwidth, 153.6 MSPS Sample Rate

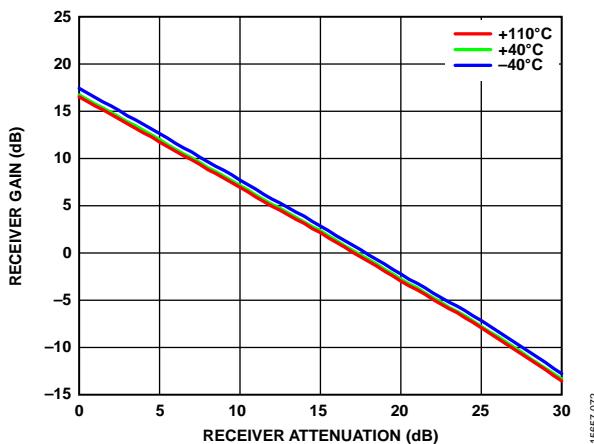


Figure 131. Receiver Gain vs. Receiver Attenuation, 3500 MHz LO, CW Signal 17 MHz Offset, 100 MHz RF Bandwidth, De-Embedded to Receiver Port, 153.6 MSPS Sample Rate

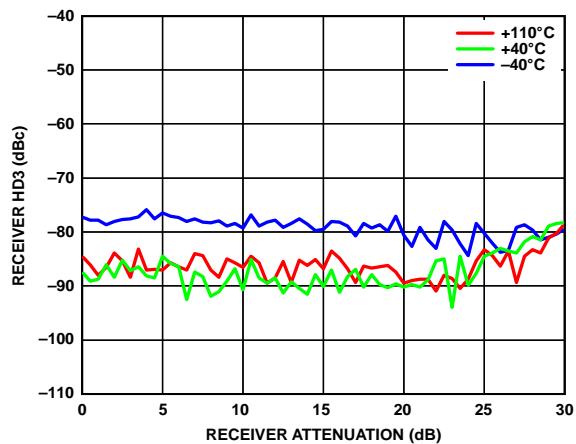


Figure 134. Receiver HD3 vs. Receiver Attenuation, 3500 MHz LO, CW Signal 17 MHz Offset,  $-14\text{ dBm}$  at 0 dB Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 100 MHz RF Bandwidth, 153.6 MSPS Sample Rate

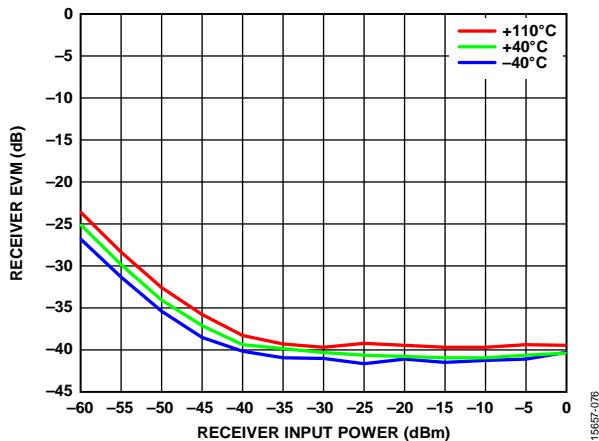


Figure 135. Receiver Error Vector Magnitude (EVM) vs. Receiver Input Power, 3600 MHz LO, 100 MHz RF Bandwidth, LTE 20 MHz Uplink Centered at DC, BTC Active, 153.6 MSPS Sample Rate

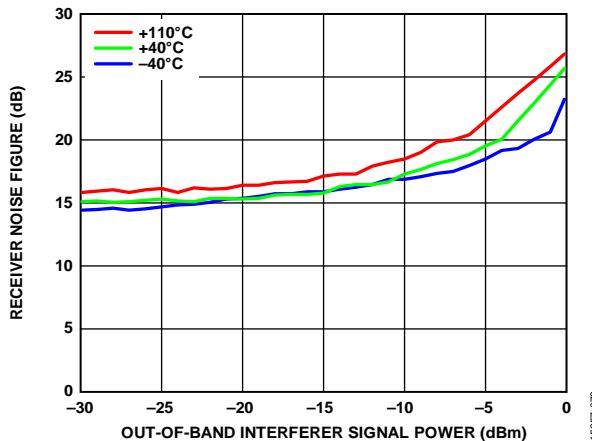


Figure 138. Receiver Noise Figure vs. Out of Band Interferer Signal Power, 3614 MHz LO, 3665 MHz CW Interferer, Noise Figure Integrated over 7 MHz to 10 MHz

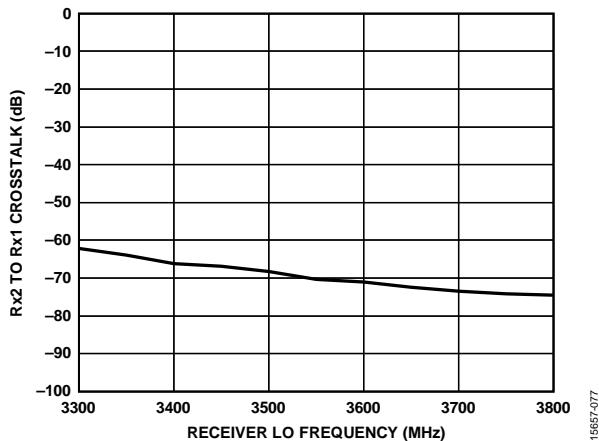


Figure 136. Rx2 to Rx1 Crosstalk vs. Receiver LO Frequency, 100 MHz RF Bandwidth, CW Tone 3 MHz Offset from LO

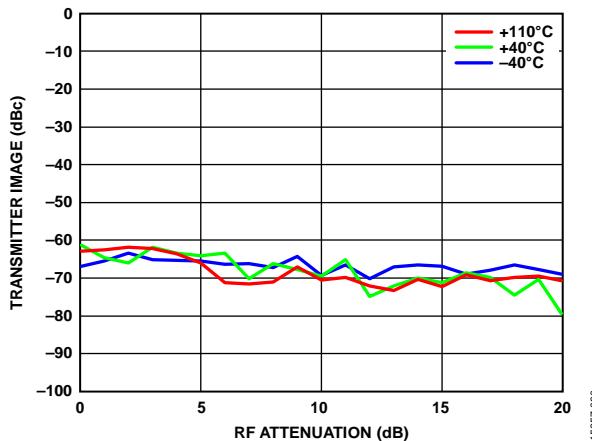


Figure 139. Transmitter Image vs. RF Attenuation, 100 MHz RF Bandwidth, 3550 MHz LO, Transmitter Quadrature Error Correction (QEC) Tracking Run with Two 20 MHz, LTE Downlink Carriers, Then Image Measured with CW 10 MHz Offset from LO, 6 dB Digital Backoff, 307.2 MSPS Sample Rate

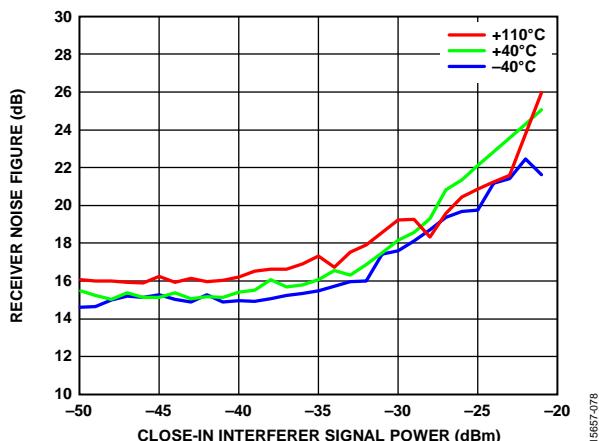


Figure 137. Receiver Noise Figure vs. Close-In Interferer Signal Power, 3614 MHz LO, 3625 MHz CW Interferer, Noise Figure Integrated over 7 MHz to 10 MHz, 100 MHz RF Bandwidth

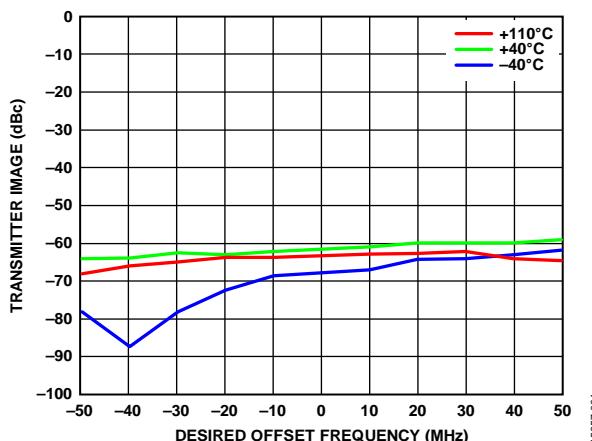
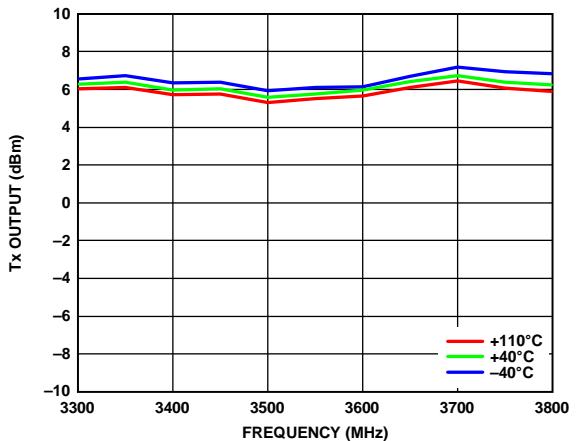
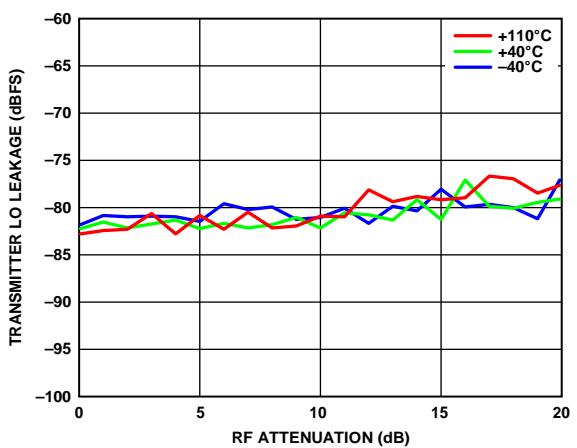


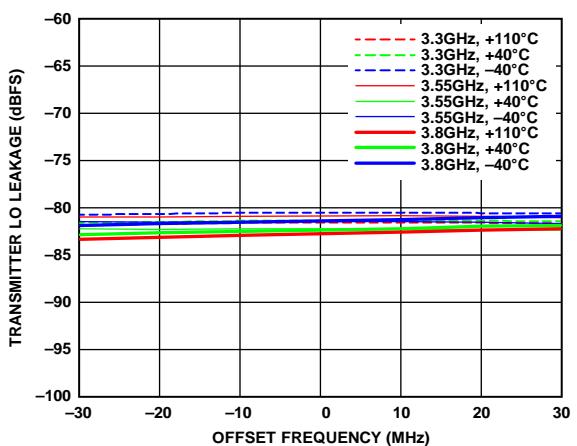
Figure 140. Transmitter Image vs. Desired Offset Frequency, 100 MHz RF Bandwidth, 3550 MHz LO, 0 dB RF Attenuation, Transmitter QEC Tracking Run with Two 20 MHz LTE Downlink Carriers, Then Image Measured with CW Signal, 6 dB Digital Backoff, 307.2 MSPS Sample Rate



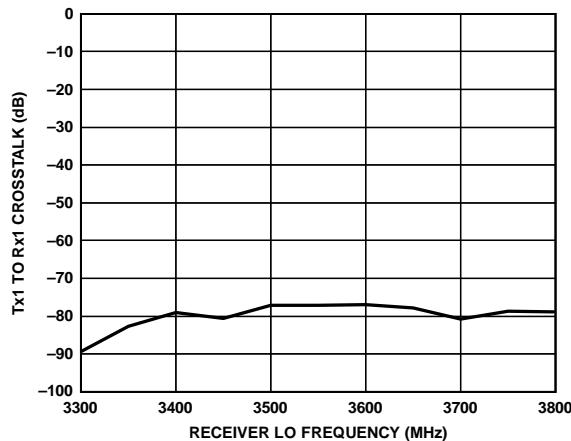
15657-082



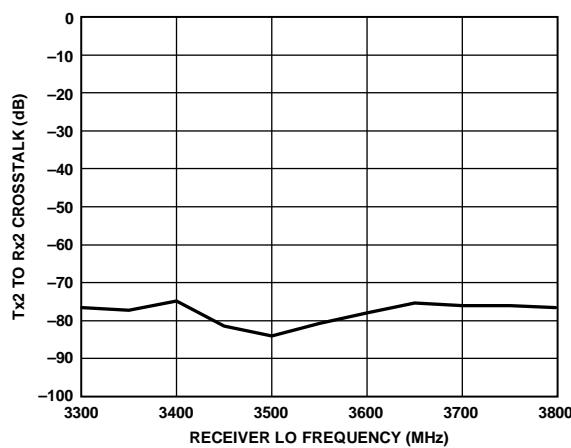
15657-083



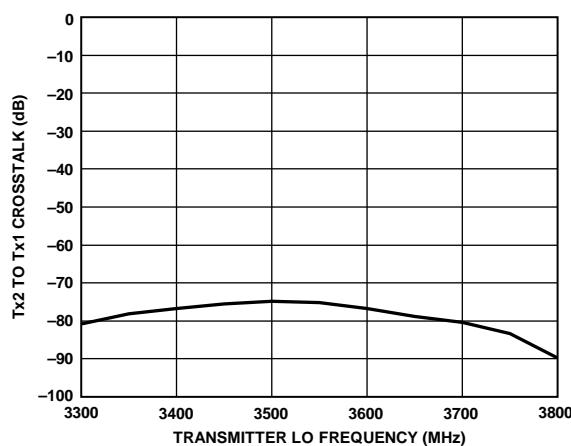
15657-084



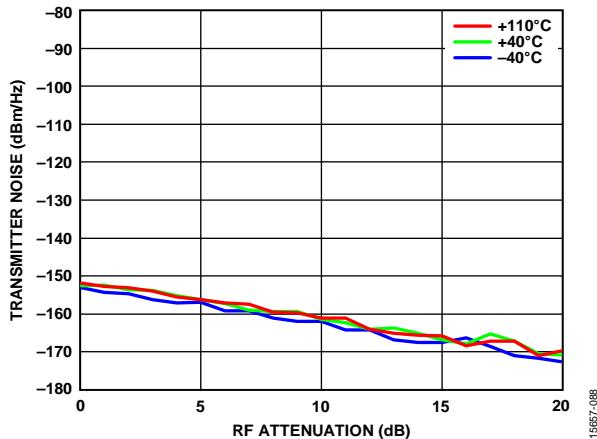
15657-085



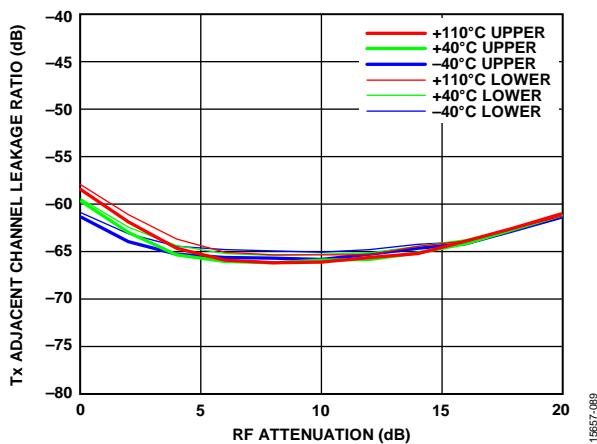
15657-086



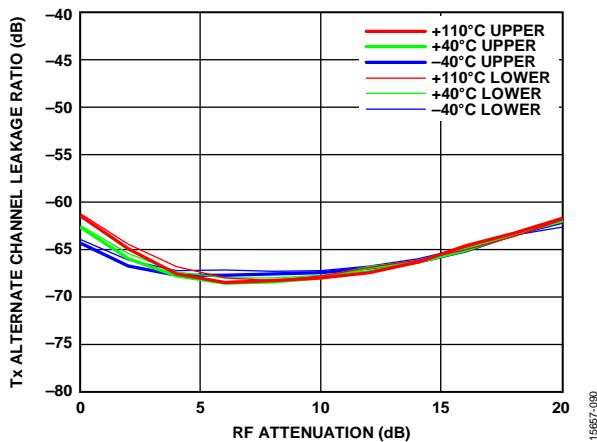
15657-087



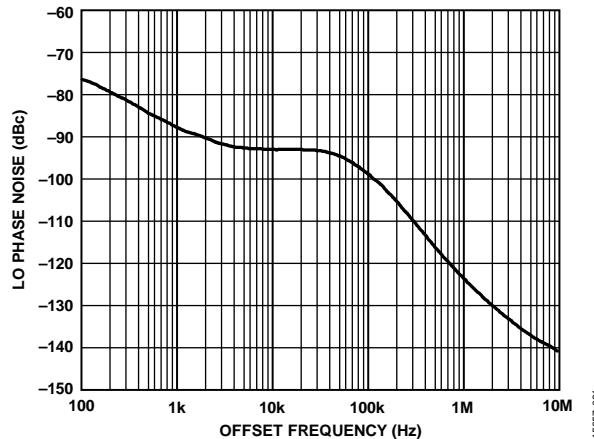
15657-088



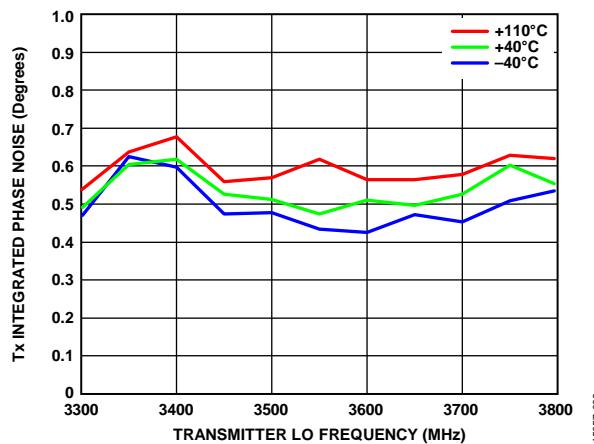
15657-089



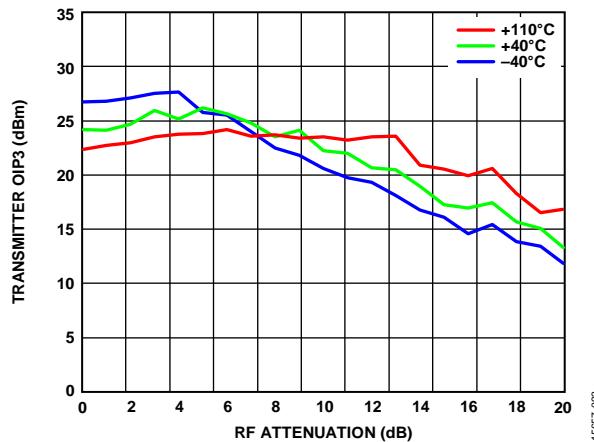
15657-090



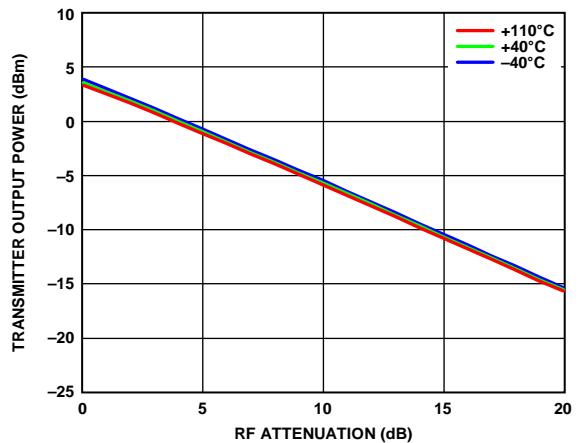
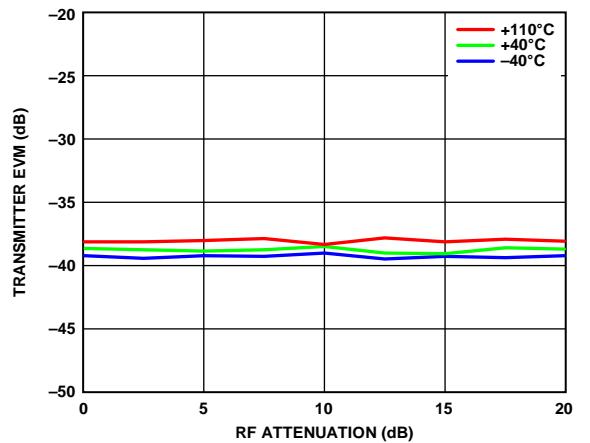
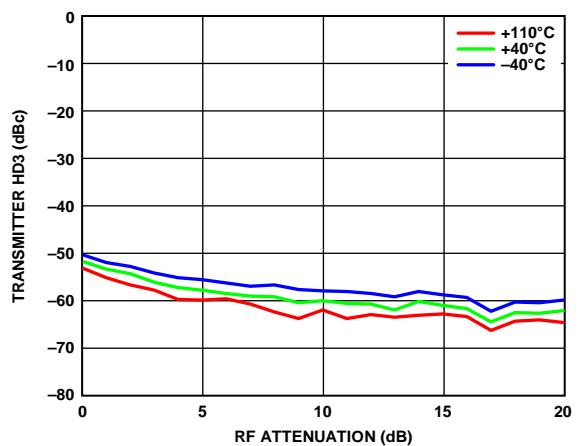
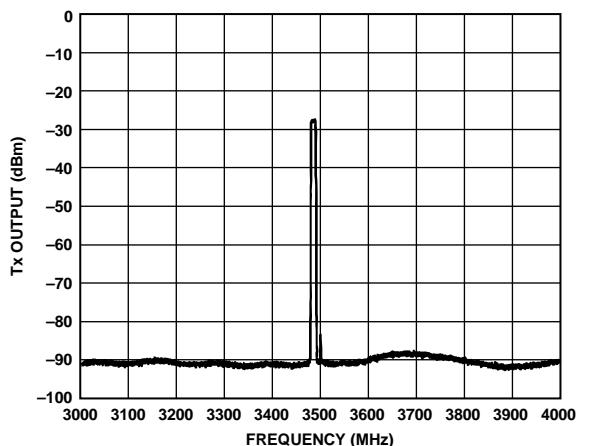
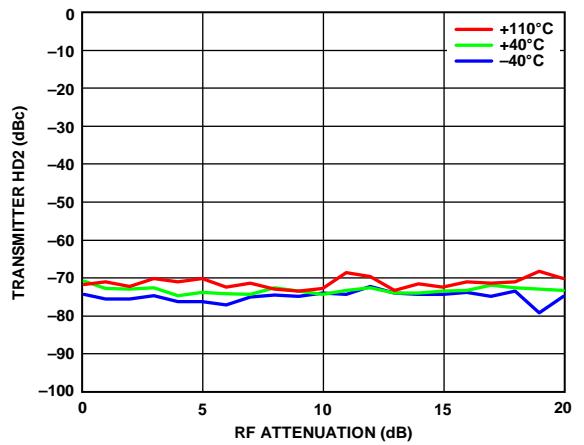
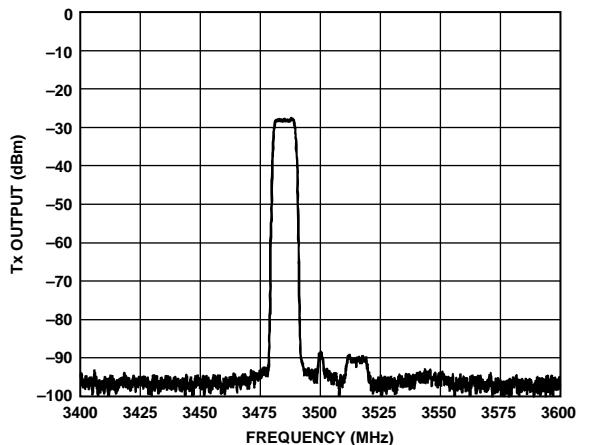
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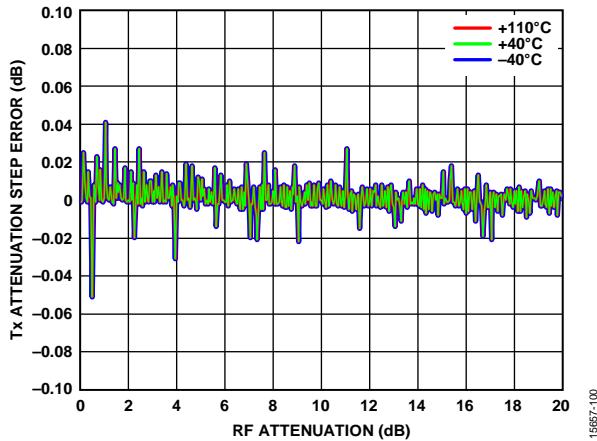


15657-092



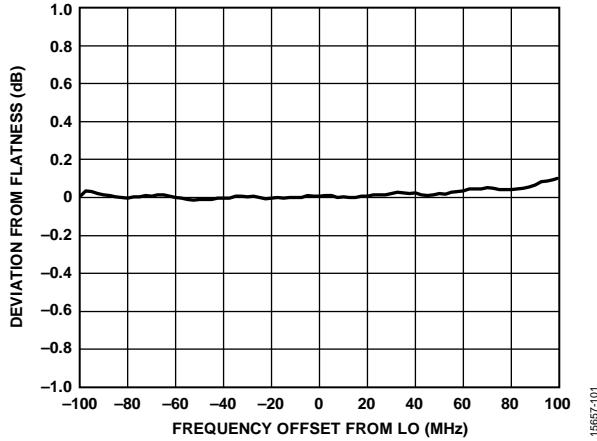
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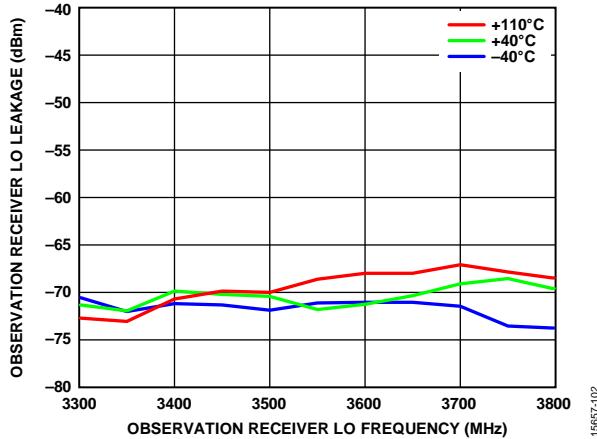
15657-100

Figure 159. Tx Attenuation Step Error vs. RF Attenuation, 3500 MHz LO, 3510 MHz CW Desired Signal, 100 MHz RF Bandwidth, De-Embedded to Transmitter Port, 307.2 MSPS Sample Rate



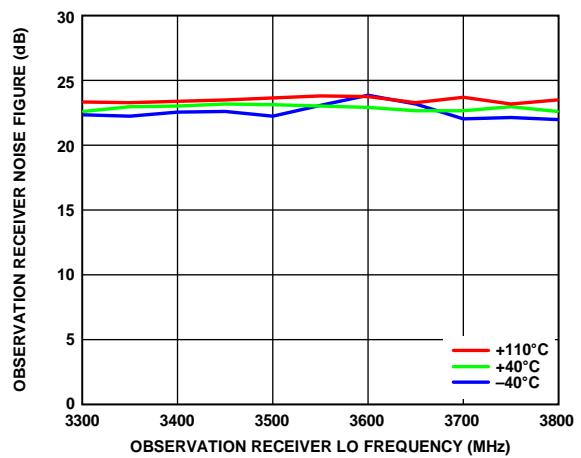
15657-101

Figure 160. Transmitter Frequency Response Deviation from Flatness vs. Frequency Offset from LO, 3500 MHz LO, 100 MHz RF Bandwidth, 6 dB Digital Backoff, 307.2 MSPS Sample Rate



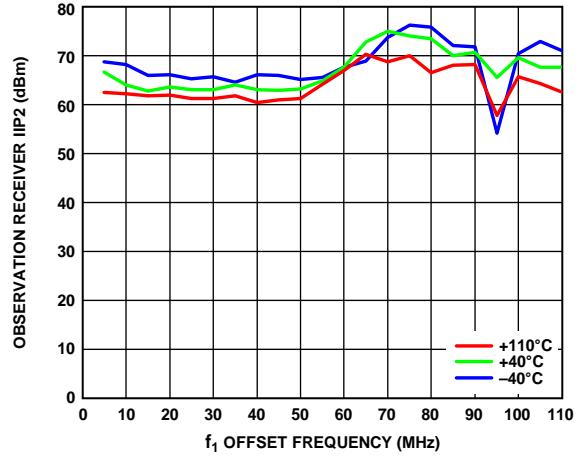
15657-102

Figure 161. Observation Receiver LO Leakage vs. Observation Receiver LO Frequency, 0 dB Receiver Attenuation, 240 MHz RF Bandwidth, 307.2 MSPS Sample Rate



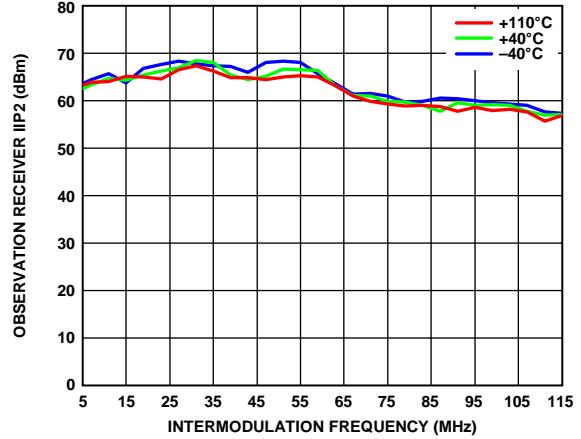
15657-103

Figure 162. Observation Receiver Noise Figure vs. Observation Receiver LO Frequency, 0 dB Receiver Attenuation, 240 MHz RF Bandwidth, 307.2 MSPS Sample Rate, 120 MHz Integration Bandwidth



15657-104

Figure 163. Observation Receiver IIP2 vs. f<sub>1</sub> Offset Frequency, 3600 MHz LO, 0 dB Attenuation, 240 MHz RF Bandwidth, f<sub>2</sub> = f<sub>1</sub> + 1 MHz, 307.2 MSPS Sample Rate



15657-105

Figure 164. Observation Receiver IIP2 vs. Intermodulation Frequency (f<sub>2</sub> - f<sub>1</sub>), 3500 MHz LO, 0 dB Attenuation, 240 MHz RF Bandwidth, 307.2 MSPS Sample Rate

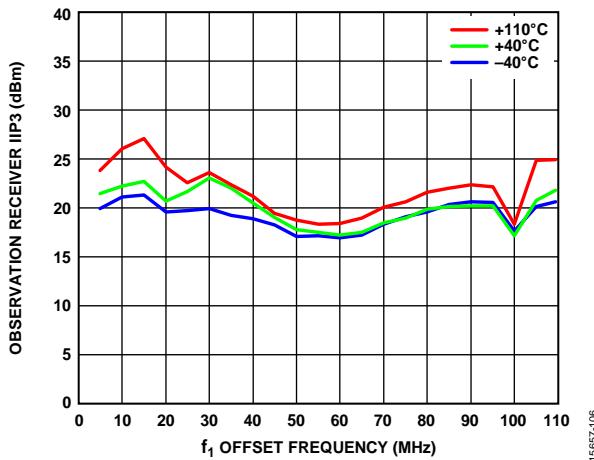


Figure 165. Observation Receiver IIP3 vs.  $f_1$  Offset Frequency, 3600 MHz LO, 0 dB Attenuation, 240 MHz RF Bandwidth,  $f_2 = 2f_1 + 1$  MHz, 307.2 MSPS Sample Rate

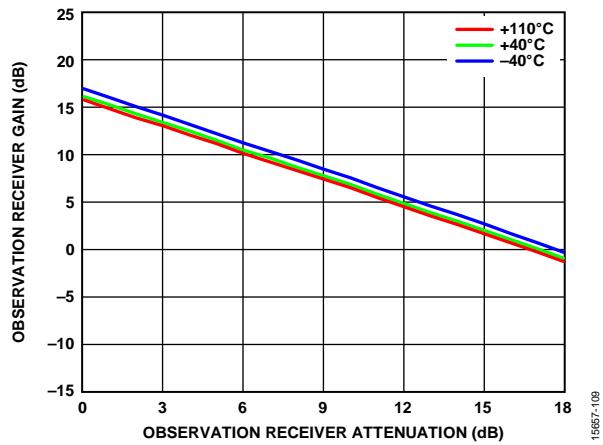


Figure 168. Observation Receiver Gain vs. Observation Receiver Attenuation, 3500 MHz LO, CW Signal 25 MHz Offset, 240 MHz RF Bandwidth, De-Embedded to Receiver Port, 307.2 MSPS Sample Rate

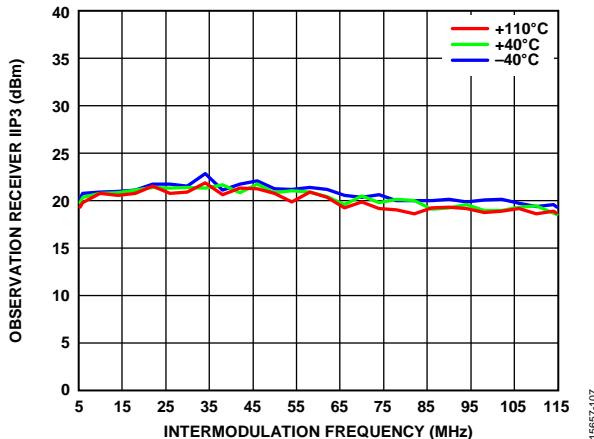


Figure 166. Observation Receiver IIP3 vs. Intermodulation Frequency ( $f_2 - 2f_1$ ), 3500 MHz LO, 0 dB Attenuation, 240 MHz RF Bandwidth, 307.2 MSPS Sample Rate

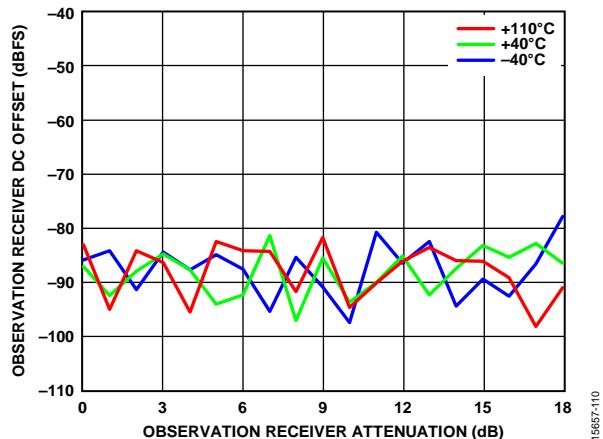


Figure 169. Observation Receiver DC Offset vs. Observation Receiver Attenuation, 3500 MHz LO, 240 MHz RF Bandwidth, 307.2 MSPS Sample Rate

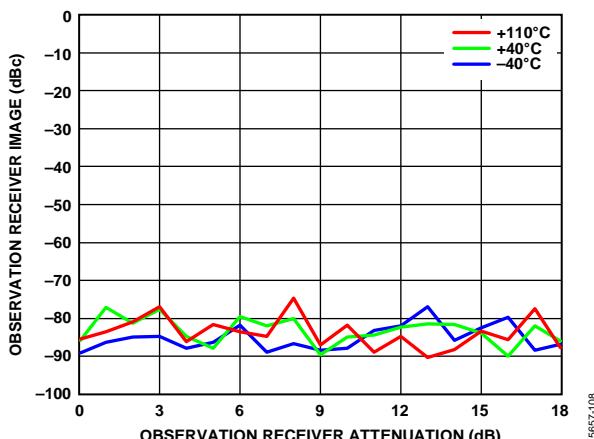


Figure 167. Observation Receiver Image vs. Observation Receiver Attenuation, 3500 MHz LO, CW Signal 25 MHz Offset, 240 MHz RF Bandwidth, BTC Active, 307.2 MSPS Sample Rate

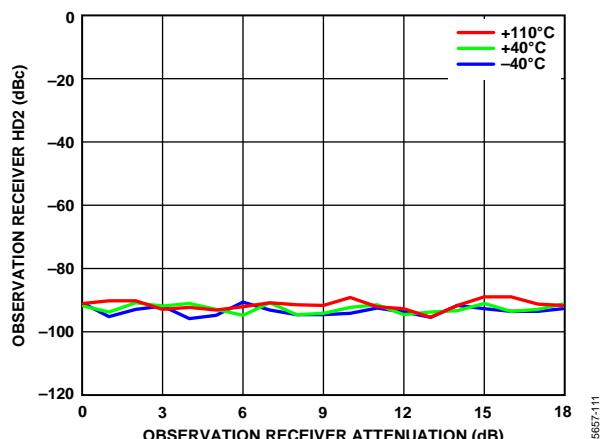
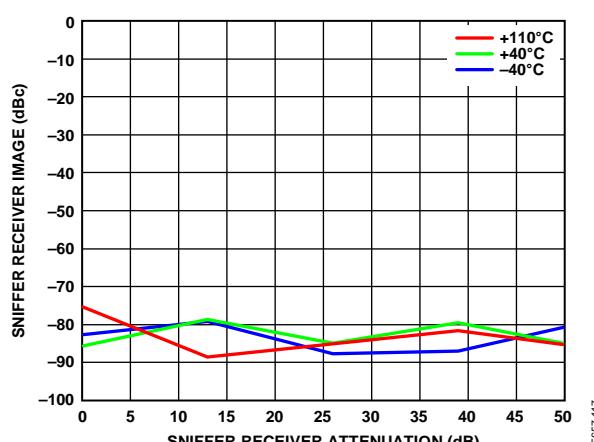
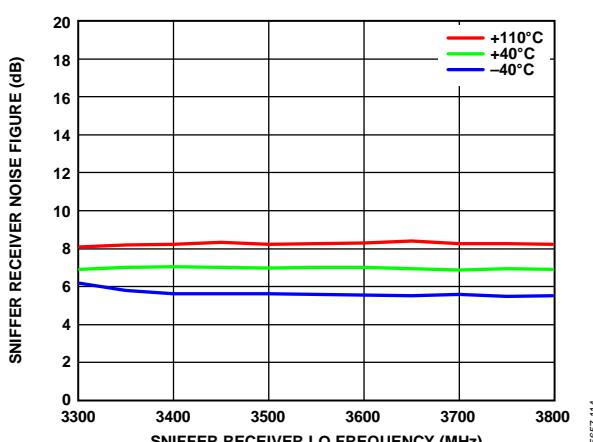
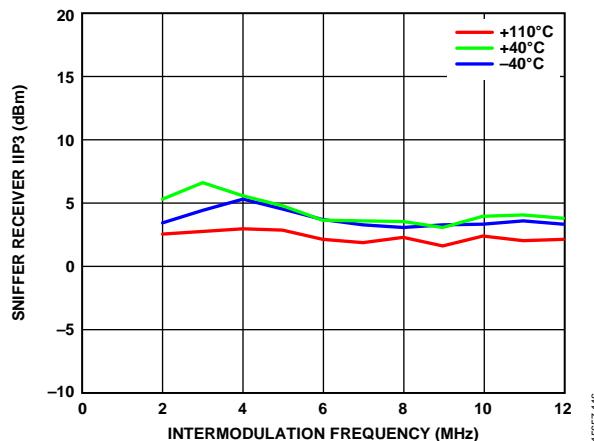
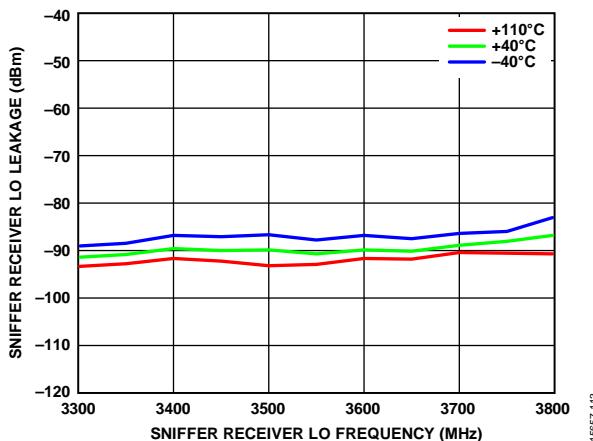
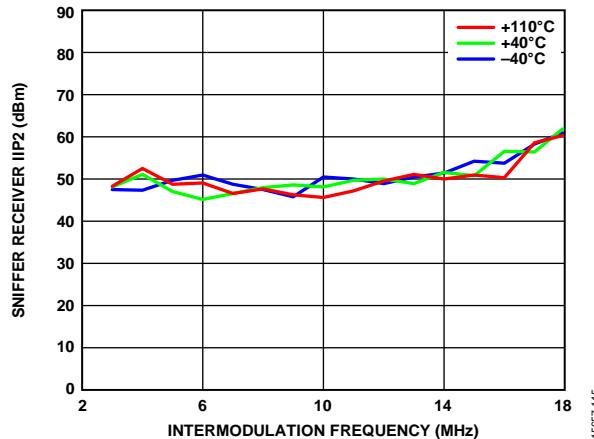
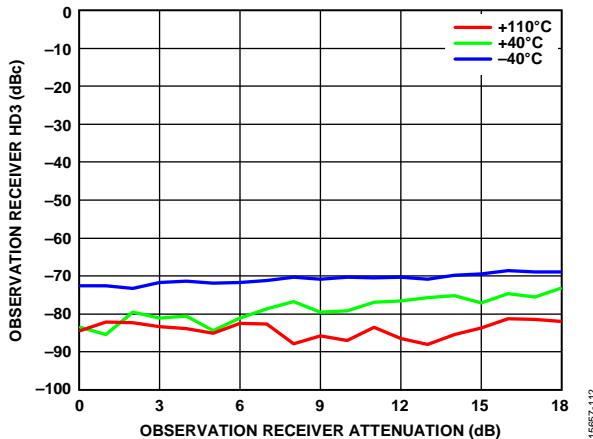


Figure 170. Observation Receiver HD2 vs. Observation Receiver Attenuation, 3500 MHz LO, CW Signal 25 MHz Offset, -20 dBm at 0 dB Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 240 MHz RF Bandwidth, 307.2 MSPS Sample Rate



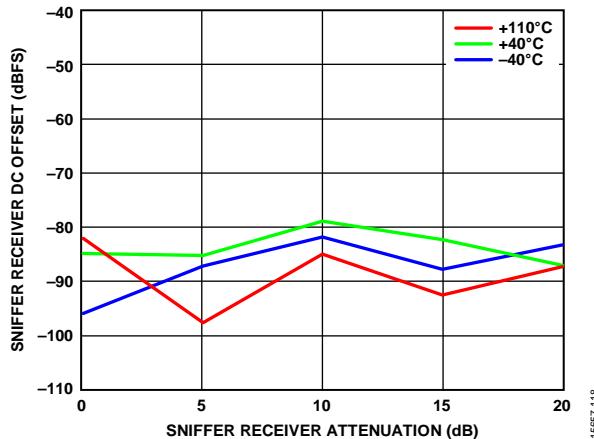


Figure 177. Sniffer Receiver DC Offset vs. Sniffer Receiver Attenuation, 3500 MHz LO, CW Signal 5 MHz Offset, –35 dBm at 0 dB Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 20 MHz RF Bandwidth, 38.4 MSPS Sample Rate

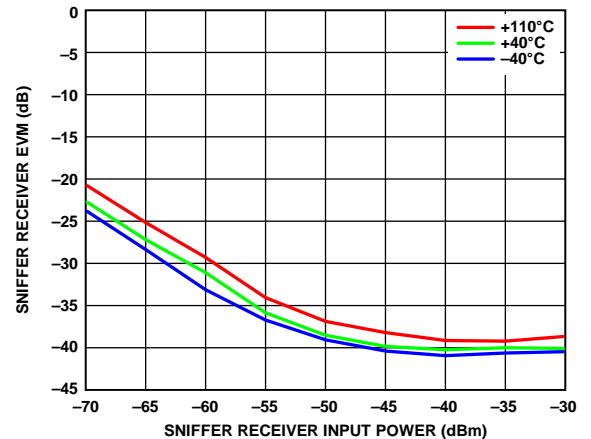


Figure 180. Sniffer Receiver EVM vs. Sniffer Receiver Input Power, 3600 MHz LO, 20 MHz RF Bandwidth, LTE 20 MHz Uplink Centered at DC, BTC Active, 38.4 MSPS Sample Rate

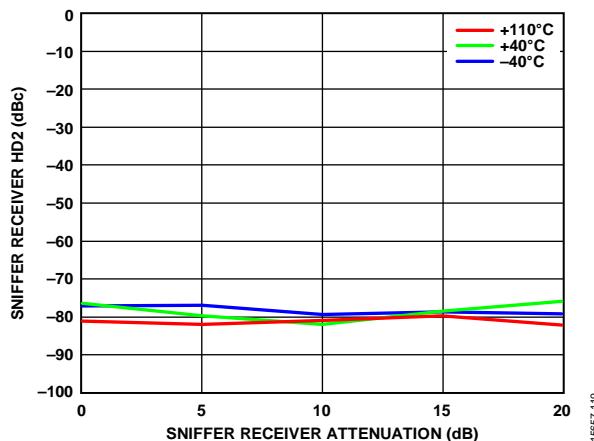


Figure 178. Sniffer Receiver HD2 vs. Sniffer Receiver Attenuation, 3500 MHz LO, CW Signal 5 MHz Offset, –35 dBm at 0 dB Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 20 MHz RF Bandwidth, 38.4 MSPS Sample Rate

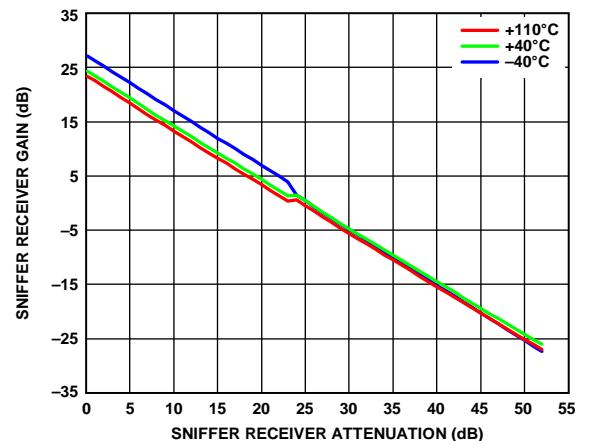


Figure 181. Sniffer Receiver Gain vs. Sniffer Receiver Attenuation, 3600 MHz LO, CW Signal 5 MHz Offset, 20 MHz RF Bandwidth, De-Embedded to Receiver Port, 38.4 MSPS Sample Rate

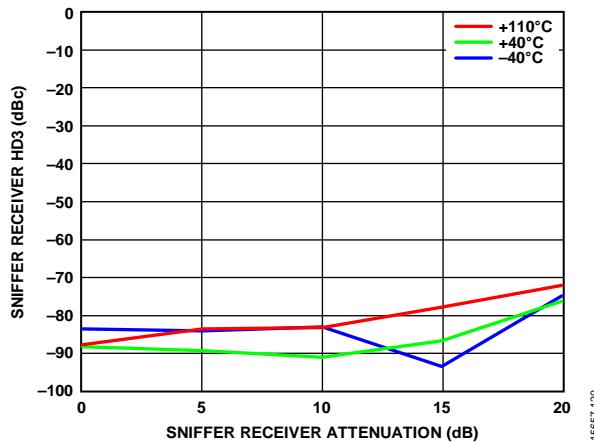


Figure 179. Sniffer Receiver HD3 vs. Sniffer Receiver Attenuation, 3500 MHz LO, CW Signal 5 MHz Offset, –35 dBm at 0 dB Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 20 MHz RF Bandwidth, 38.4 MSPS Sample Rate

## 5.5 GHz BAND

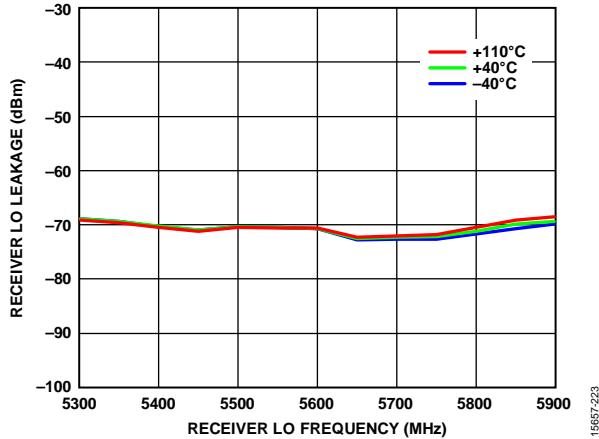


Figure 182. Receiver Local Oscillator (LO) Leakage vs. Receiver LO Frequency, 0 dB Receiver Attenuation, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate

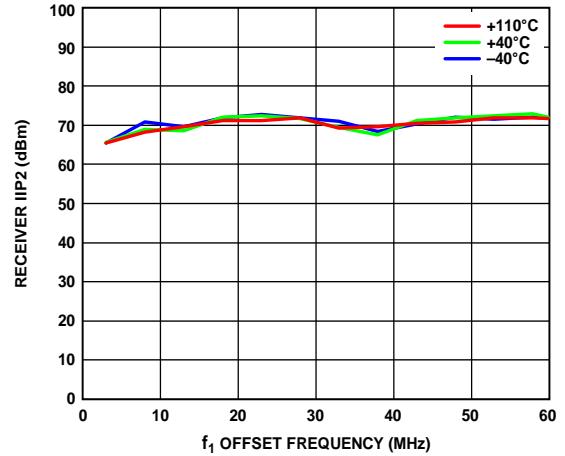


Figure 185. Receiver IIP2 vs.  $f_1$  Offset Frequency, 5600 MHz LO, 0 dB Attenuation, 100 MHz RF Bandwidth,  $f_2 = f_1 + 1$  MHz, 122.88 MSPS Sample Rate

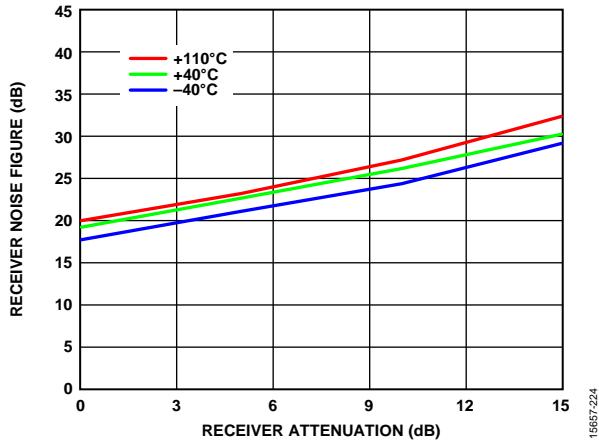


Figure 183. Receiver Noise Figure vs. Receiver Attenuation, 5600 MHz LO, 100 MHz Bandwidth, 122.88 MSPS Sample Rate, 50 MHz Integration Bandwidth (Includes 1.2 dB Matching Circuit Loss)

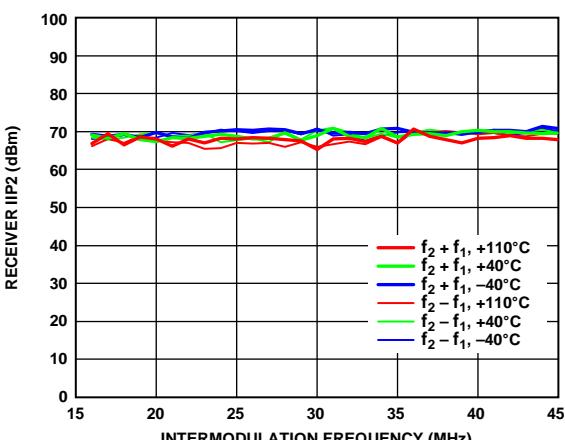


Figure 186. Receiver IIP2 vs. Intermodulation Frequency, 5600 MHz LO, 0 dB Attenuation, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate

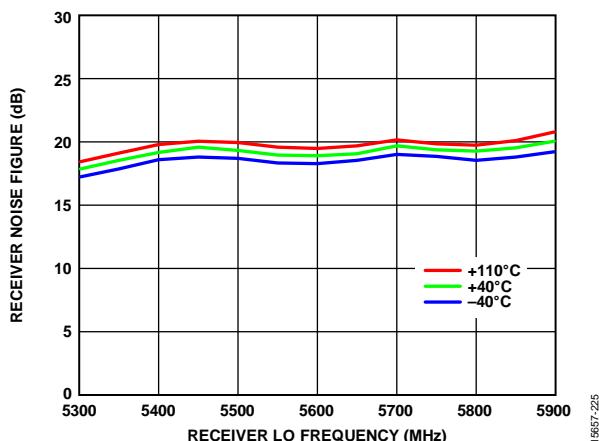


Figure 184. Receiver Noise Figure vs. Receiver LO Frequency, 0 dB Receiver Attenuation, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate, 50 MHz Integration Bandwidth (Includes 1.2 dB Matching Circuit Loss)

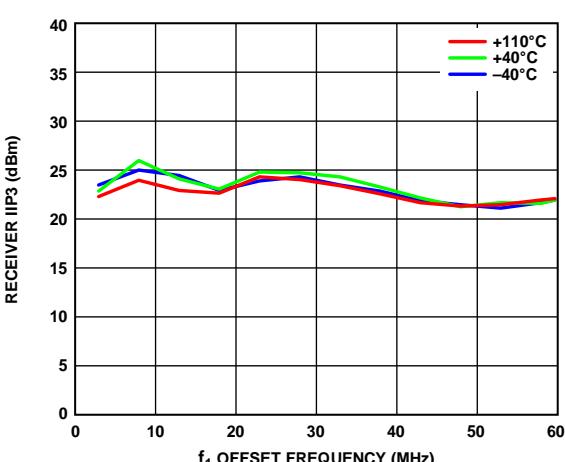


Figure 187. Receiver IIP3 vs.  $f_1$  Offset Frequency, 5600 MHz LO, 0 dB Attenuation, 100 MHz RF Bandwidth,  $f_2 = 2f_1 + 2$  MHz, 122.88 MSPS Sample Rate

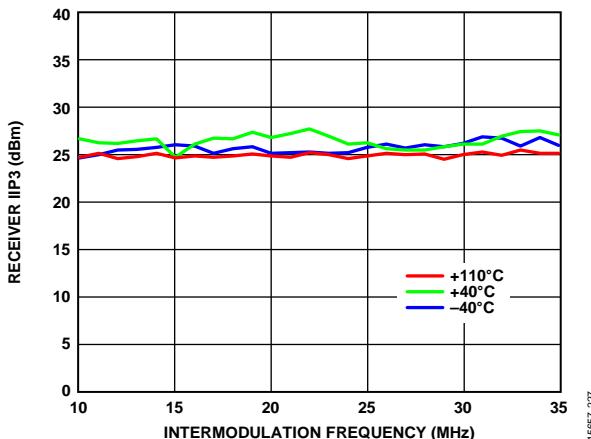


Figure 188. Receiver IIP3 vs. Intermodulation Frequency, 5600 MHz LO, 0 dB Attenuation, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate

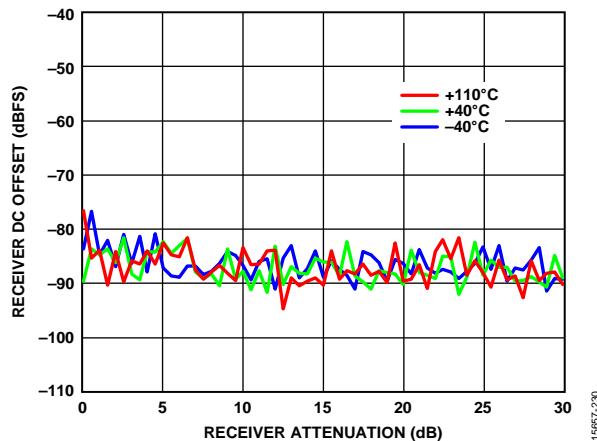


Figure 191. Receiver DC Offset vs. Receiver Attenuation, 5850 MHz LO, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate

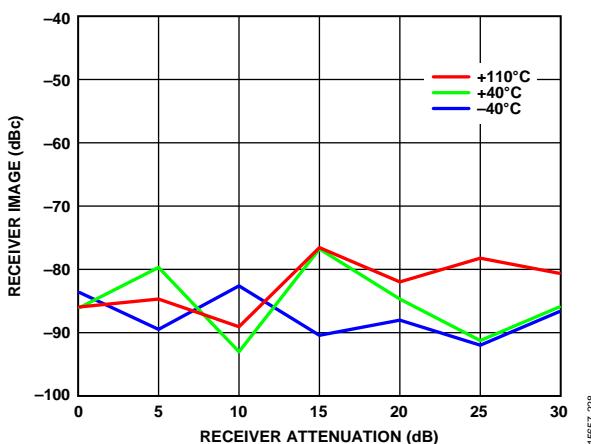


Figure 189. Receiver Image vs. Receiver Attenuation, 5600 MHz LO, Continuous Wave (CW) Signal 10 MHz Offset, 100 MHz RF Bandwidth, Background Tracking Calibration (BTC) Active, 122.88 MSPS Sample Rate

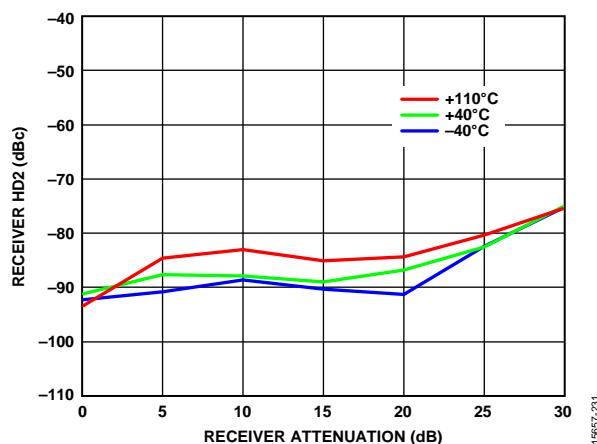


Figure 192. Receiver HD2 vs. Receiver Attenuation, 5600 MHz LO, CW Signal 10 MHz Offset, -20 dBm at 0 dB Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate

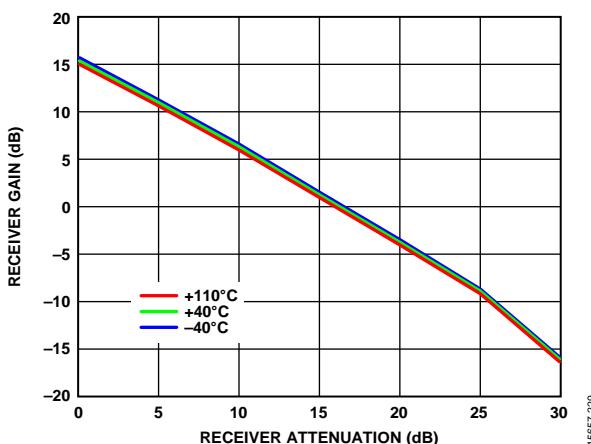


Figure 190. Receiver Gain vs. Receiver Attenuation, 5600 MHz LO, CW Signal 10 MHz Offset, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate

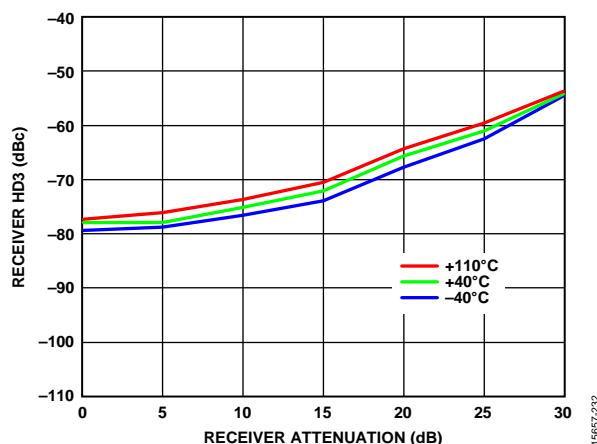


Figure 193. Receiver HD3 vs. Receiver Attenuation, 5600 MHz LO, CW Signal 10 MHz Offset, -20 dBm at 0 dB Attenuation, Input Power Increasing Decibel for Decibel with Attenuation, 100 MHz RF Bandwidth, 122.88 MSPS Sample Rate

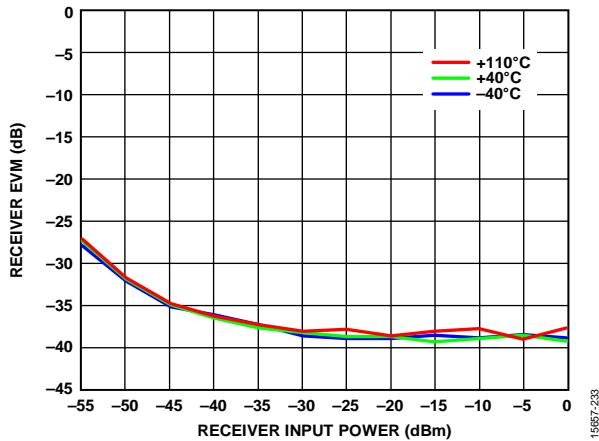


Figure 194. Receiver Error Vector Magnitude (EVM) vs. Receiver Input Power, 5600 MHz LO, 100 MHz RF Bandwidth LTE, 20 MHz Uplink Centered at DC, BTC Active, 122.88 MSPS Sample Rate

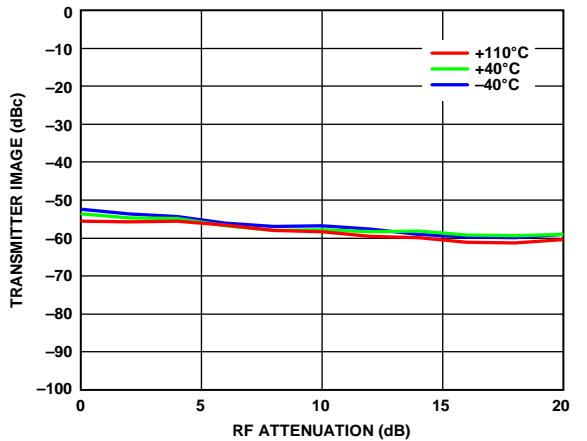


Figure 197. Transmitter Image vs. RF Attenuation, 75 MHz RF Bandwidth, 5600 MHz LO, 0 dB RF Attenuation, Transmitter Quadrature Error Correction (QEC) Tracking Run with Two 20 MHz LTE Downlink Carriers, Then Image Measured with CW 10 MHz Offset from LO, 3 dB Digital Backoff, 245.76 MSPS Sample Rate

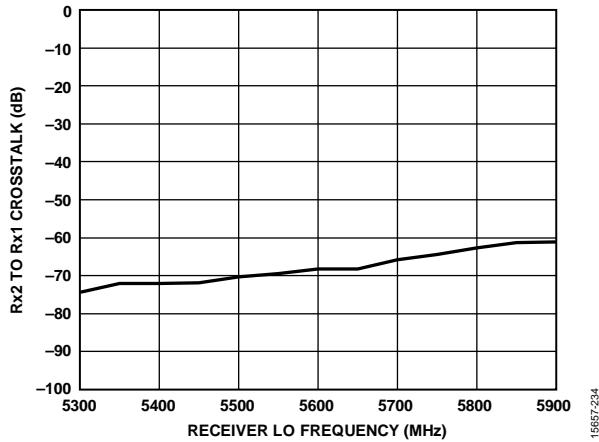


Figure 195. Rx2 to Rx1 Crosstalk vs. Receiver LO Frequency, 100 MHz RF Bandwidth, CW Tone 3 MHz Offset from LO

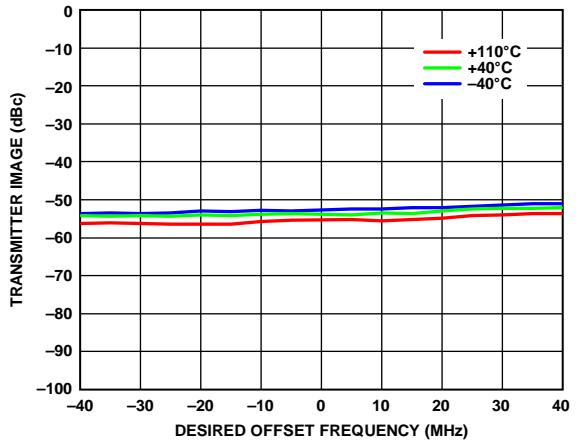


Figure 198. Transmitter Image vs. Desired Offset Frequency, 75 MHz RF Bandwidth, 5600 MHz LO, 0 dB RF Attenuation, Transmitter QEC Tracking Run with Two 20 MHz LTE Downlink Carriers, Then Image Measured with CW Signal, 3 dB Digital Backoff, 245.76 MSPS Sample Rate

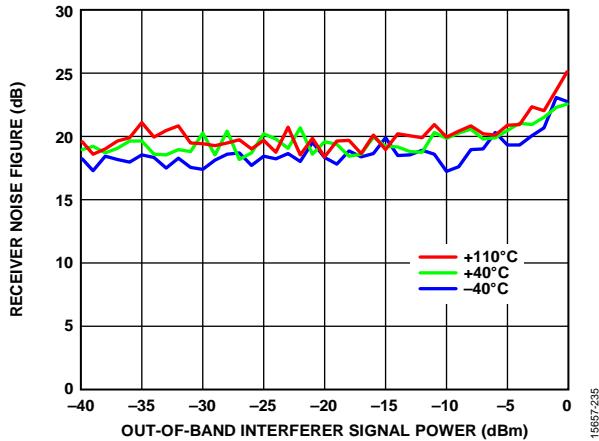


Figure 196. Receiver Noise Figure vs. Out-of-Band Interferer Signal Power, 5400 MHz LO, 5600 MHz CW Interferer, NF Integrated over 7 MHz to 10 MHz

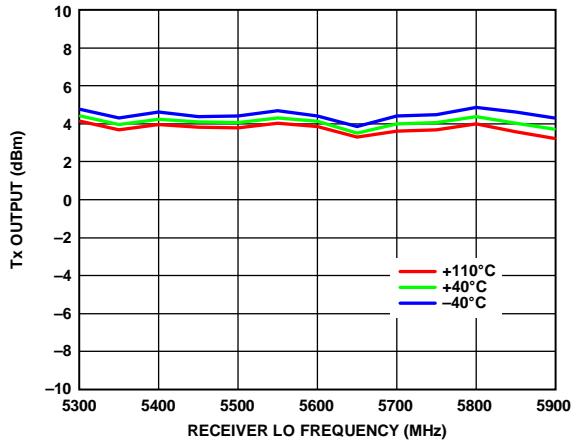


Figure 199. Tx Output Power, Transmitter QEC, and External LO Leakage Active, 5 MHz CW Offset Signal, 1 MHz Resolution Bandwidth, 245.76 MSPS Sample Rate

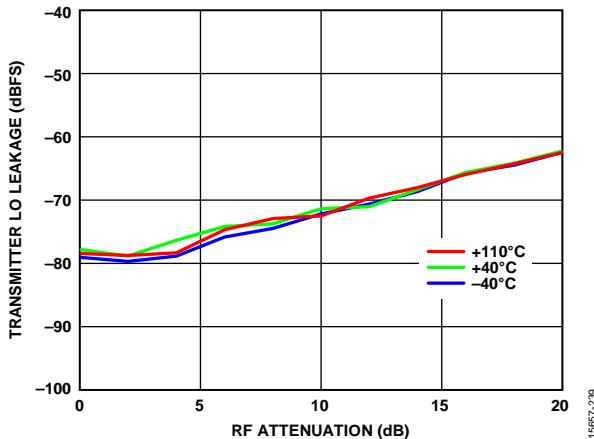


Figure 200. Transmitter LO Leakage vs. RF Attenuation, 5600 MHz LO, External Transmitter QEC, and LO Leakage Tracking Active, CW Signal 10 MHz Offset from LO, 6 dB Digital Backoff, 1 MHz Measurement Bandwidth

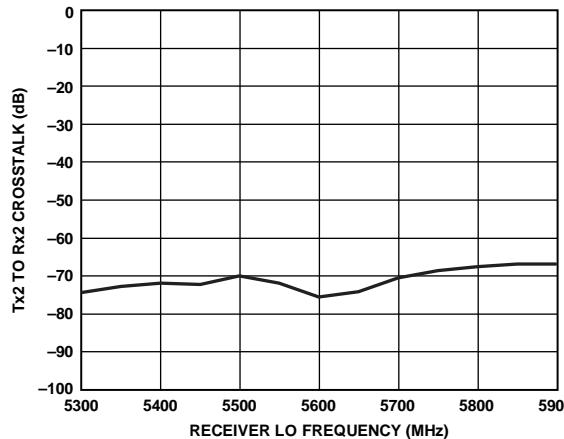


Figure 203. Tx2 to Rx2 Crosstalk vs. Receiver LO Frequency, 100 MHz Receiver RF Bandwidth, 75 MHz Transmitter RF Bandwidth, CW Signal 3 MHz Offset from LO

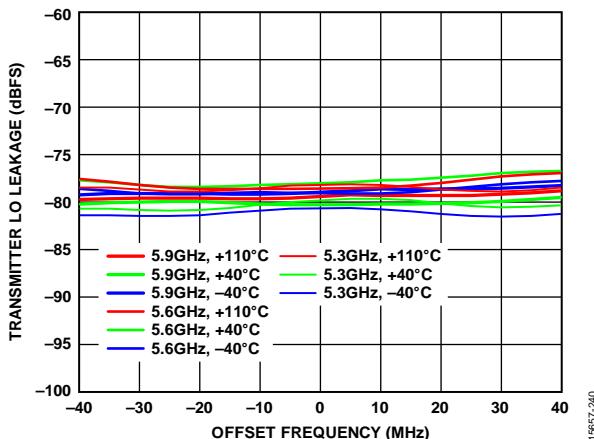


Figure 201. Transmitter LO Leakage vs. Offset Frequency, External Transmitter QEC and LO Leakage Tracking Active, 6 dB Digital Backoff, 1 MHz Measurement Bandwidth

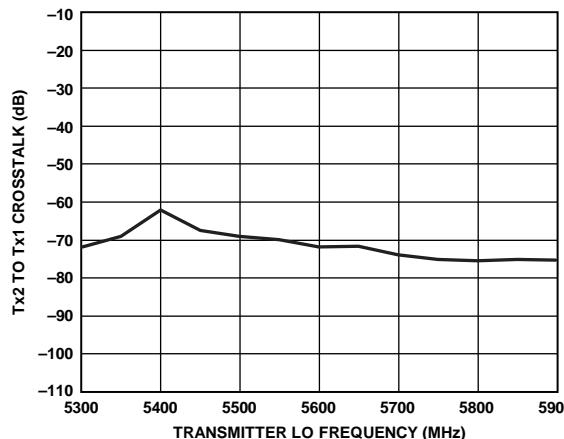


Figure 204. Tx2 to Tx1 Crosstalk vs. Transmitter LO Frequency, 75 MHz RF Bandwidth, CW Signal 3 MHz Offset from LO

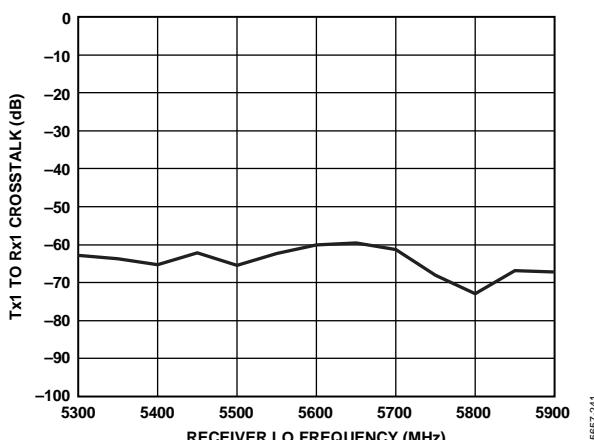


Figure 202. Tx1 to Rx1 Crosstalk vs. Receiver LO Frequency, 100 MHz Receiver RF Bandwidth, 75 MHz Transmitter RF Bandwidth, CW Signal 3 MHz Offset from LO

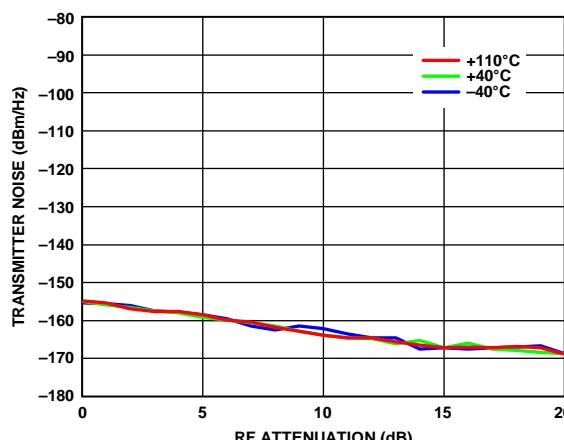
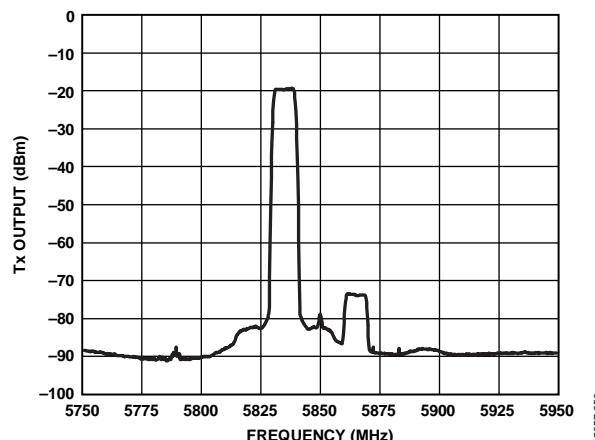
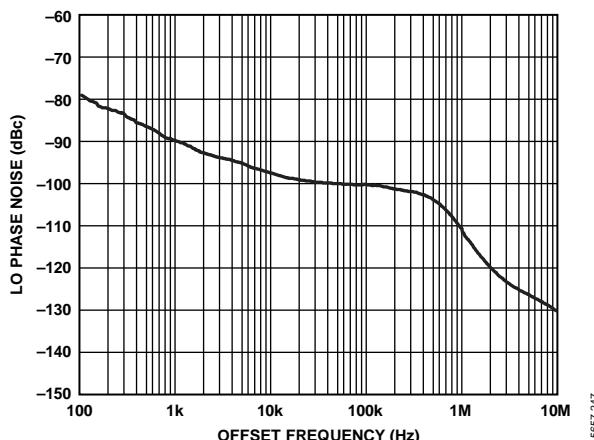
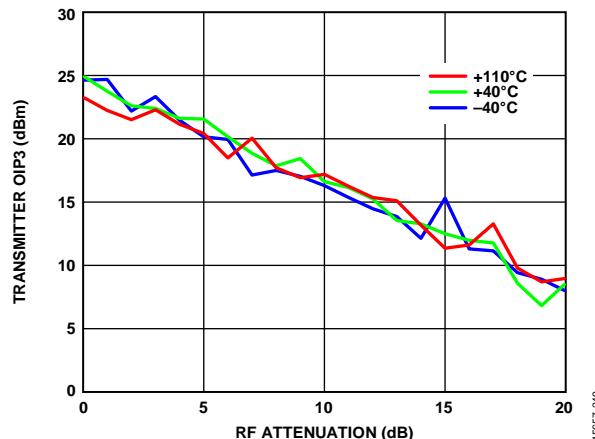
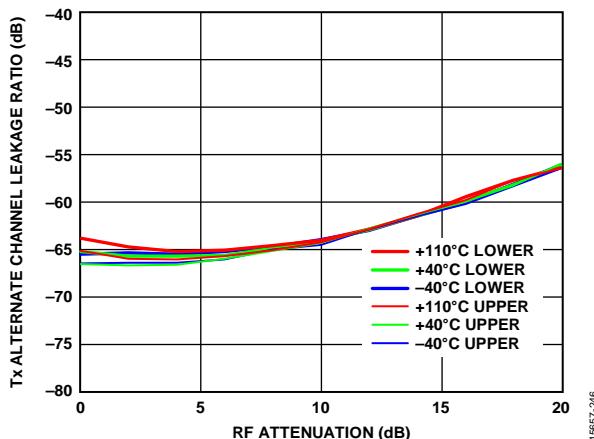
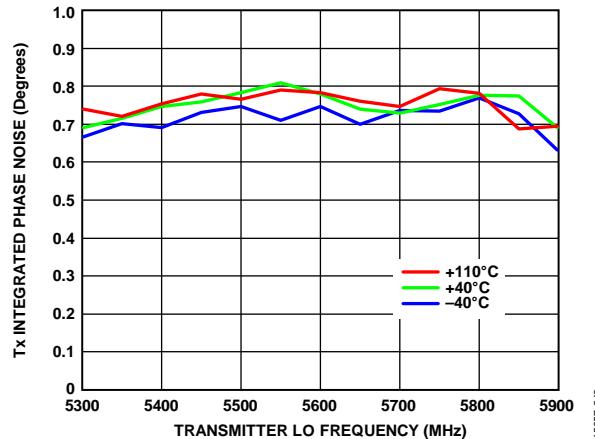
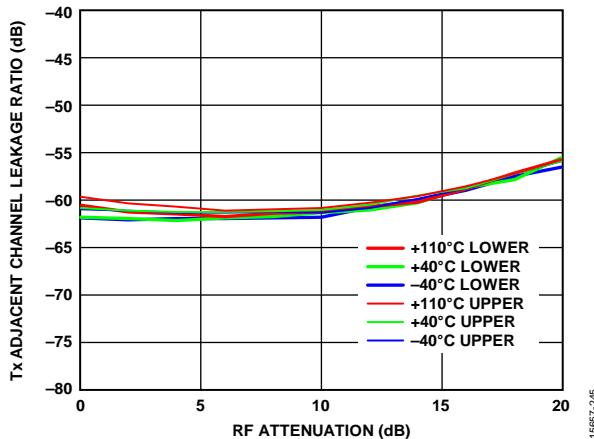


Figure 205. Transmitter Noise vs. RF Attenuation, 5600 MHz LO, 1 MHz Offset Frequency



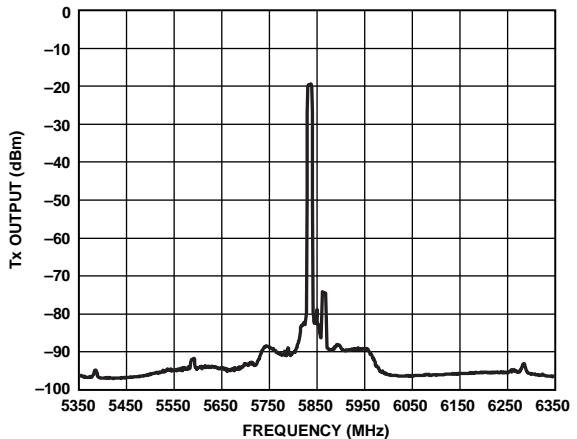


Figure 212. Tx Output Power Spectrum, 3 dB Digital and 1 dB RF Backoff, 40 MHz RF Bandwidth, Transmitter QEC, and Internal LO Leakage Active, LTE 10 MHz Signal, 5850 MHz LO, 1 MHz Resolution Bandwidth, 122.88 MSPS Sample Rate, Expanded Frequency View, Test Equipment Noise Floor De-Embedded

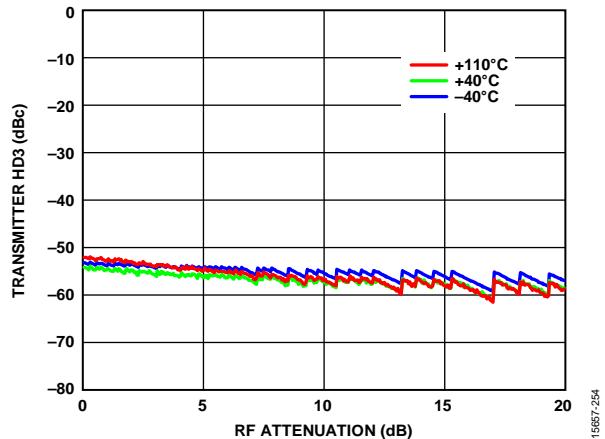


Figure 215. Transmitter HD3 vs. RF Attenuation, 5850 MHz LO, 5855 MHz CW Desired Signal, 75 MHz RF Bandwidth, 245.76 MSPS Sample Rate

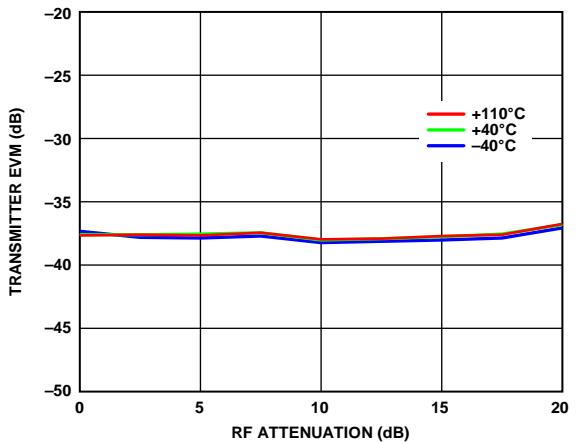


Figure 213. Transmitter EVM vs. RF Attenuation, 5600 MHz LO, Transmitter LO Leakage, and Transmitter QEC Tracking Active, 75 MHz RF Bandwidth, LTE 20 MHz Downlink Signal, 245.76 MSPS Sample Rate

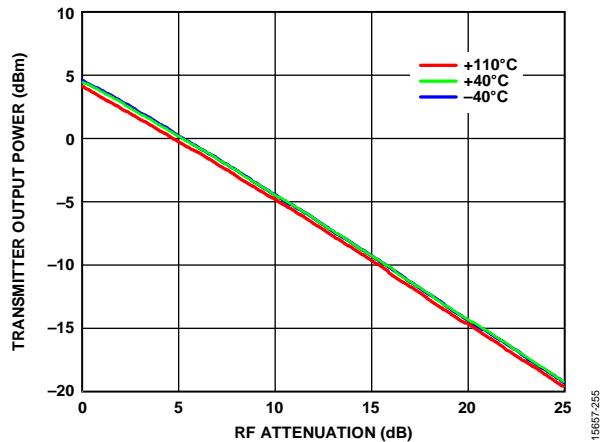


Figure 216. Transmitter Output Power vs. RF Attenuation, 5850 MHz LO, 5855 MHz CW Desired Signal, 75 MHz RF Bandwidth, 245.76 MSPS Sample Rate

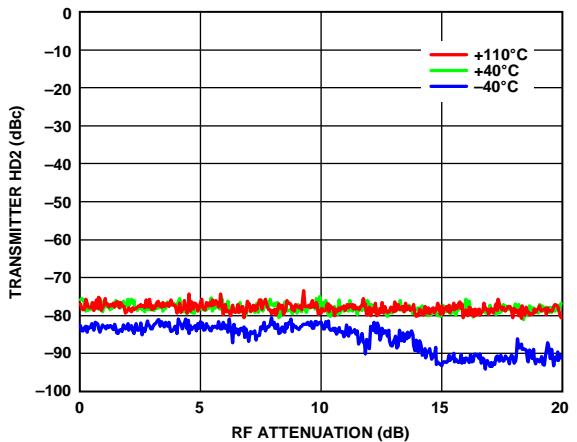


Figure 214. Transmitter HD2 vs. RF Attenuation, 5850 MHz LO, 5855 MHz CW Desired Signal, 75 MHz RF Bandwidth, 245.76 MSPS Sample Rate

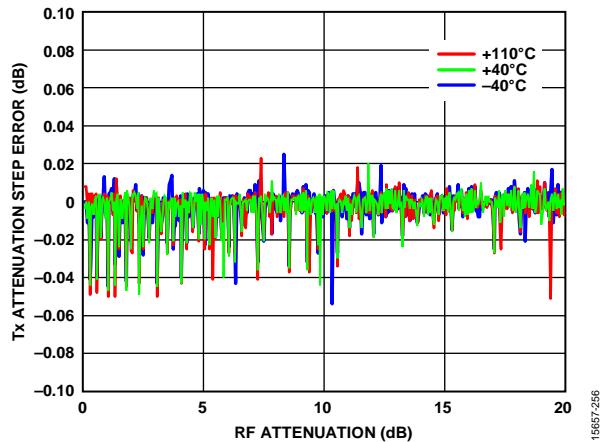


Figure 217. Tx Attenuation Step Error vs. RF Attenuation, 5850 MHz LO, 5855 MHz CW Desired Signal, 75 MHz RF Bandwidth, 245.76 MSPS Sample Rate

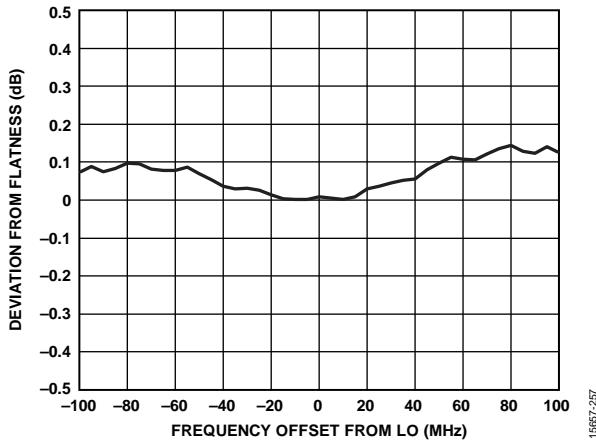


Figure 218. Transmitter Frequency Response Deviation from Flatness vs. Frequency Offset from LO, 5850 MHz LO, 200 MHz Synthesis Bandwidth, 6 dB Digital Backoff, 245.76 MSPS Sample Rate

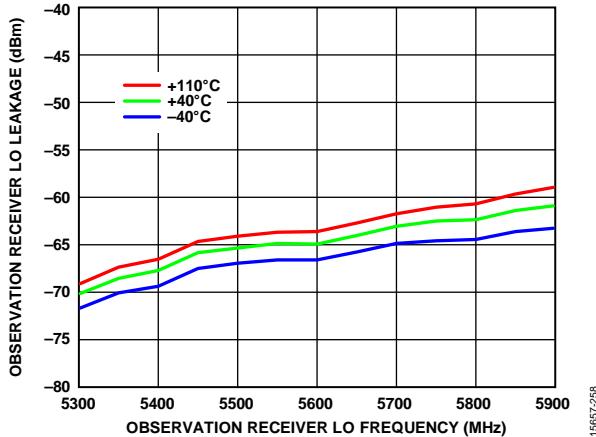


Figure 219. Observation Receiver LO Leakage vs. Observation Receiver LO Frequency, 0 dB Receiver Attenuation, 200 MHz RF Bandwidth, 245.76 MSPS Sample Rate

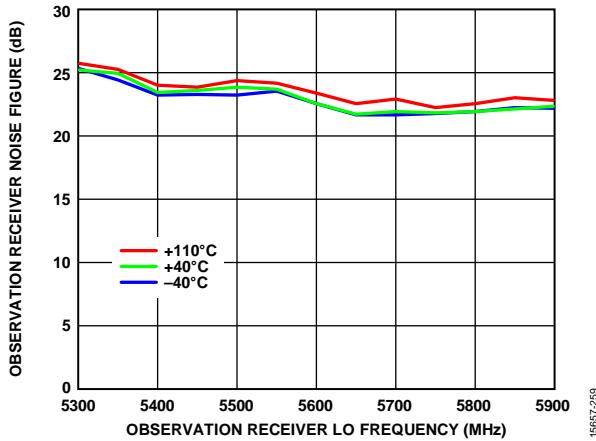


Figure 220. Observation Receiver Noise Figure vs. Observation Receiver LO Frequency, 0 dB Receiver Attenuation, 200 MHz RF Bandwidth, 245.76 MSPS Sample Rate, 100 MHz Integration Bandwidth

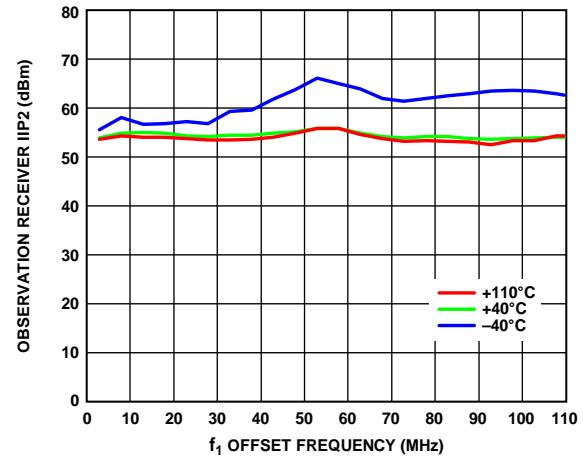


Figure 221. Observation Receiver IIP2 vs.  $f_1$  Offset Frequency, 5600 MHz LO, 0 dB Attenuation, 200 MHz RF Bandwidth,  $f_2 = f_1 + 1$  MHz, 245.76 MSPS Sample Rate

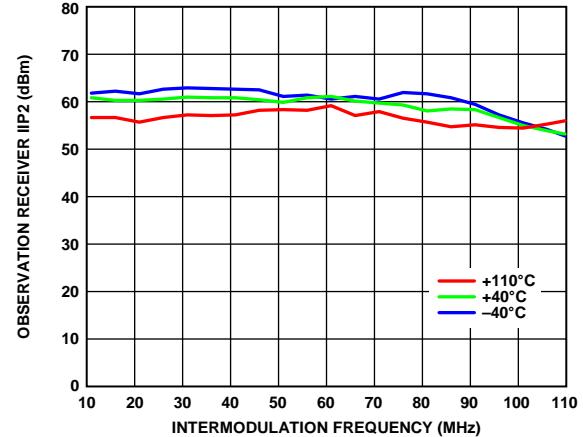


Figure 222. Observation Receiver IIP2 vs. Intermodulation Frequency ( $f_2 - f_1$ ), 5600 MHz LO, 0 dB Attenuation, 200 MHz RF Bandwidth, 245.76 MSPS Sample Rate

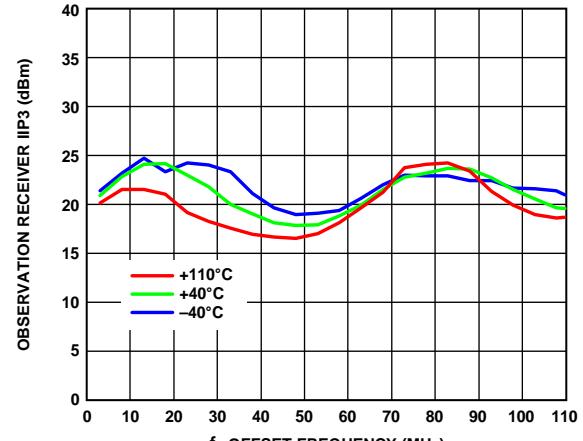


Figure 223. Observation Receiver IIP3 vs.  $f_1$  Offset Frequency, 5600 MHz LO, 0 dB Attenuation, 200 MHz RF Bandwidth,  $f_2 = 2f_1 + 1$  MHz, 245.76 MSPS Sample Rate

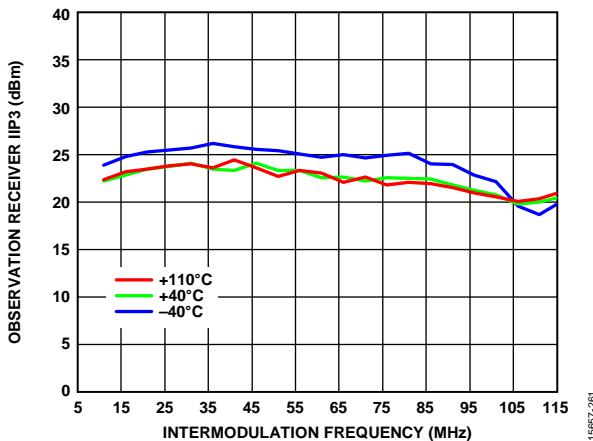


Figure 224. Observation Receiver IIP3 vs. Intermodulation Frequency ( $f_2 - 2f_1$ ),  
5600 MHz LO, 0 dB Attenuation, 200 MHz RF Bandwidth,  
245.76 MSPS Sample Rate

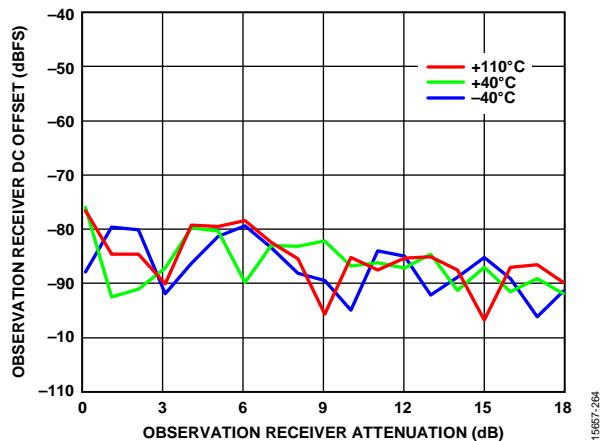


Figure 227. Observation Receiver DC Offset vs. Observation Receiver Attenuation, 5850 MHz LO, CW Signal 30 MHz Offset, -15 dBm Input, 200 MHz RF Bandwidth, 245.76 MSPS Sample Rate

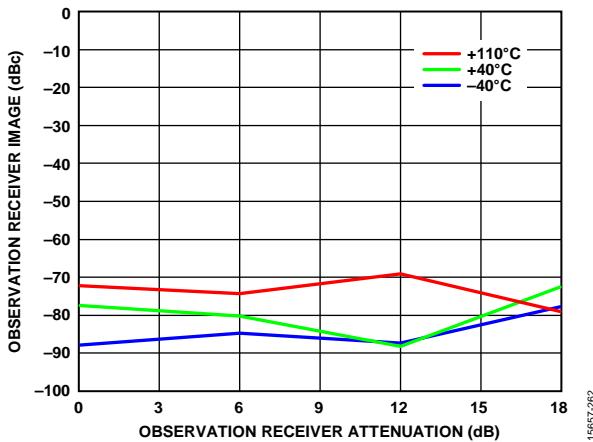


Figure 225. Observation Receiver Image vs. Observation Receiver Attenuation, 5600 MHz LO, CW Signal 30 MHz Offset, 200 MHz RF Bandwidth, BTC Active, 245.76 MSPS Sample Rate

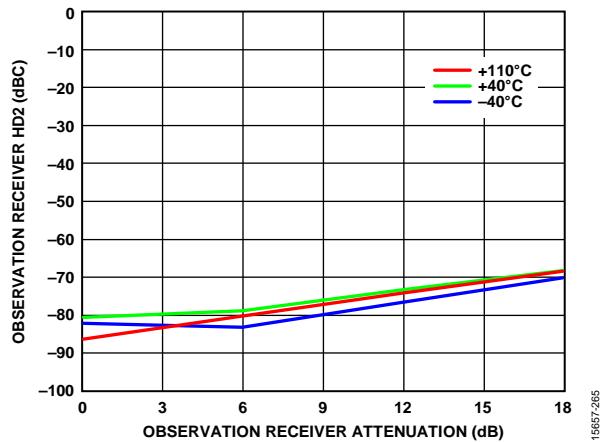


Figure 228. Observation Receiver HD2 vs. Observation Receiver Attenuation, 5600 MHz LO, CW Signal 30 MHz Offset, -15 dBm Input, Input Power Increasing Decibel for Decibel with Attenuation, 200 MHz RF Bandwidth, 245.76 MSPS Sample Rate

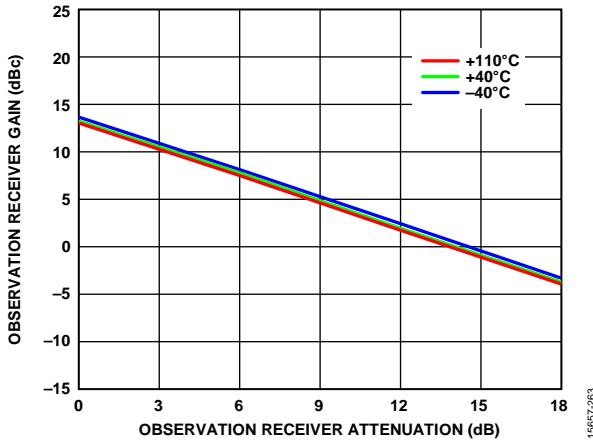


Figure 226. Observation Receiver Gain vs. Observation Receiver Attenuation, 5600 MHz LO, CW Signal 30 MHz Offset, 200 MHz RF Bandwidth, 245.76 MSPS Sample Rate

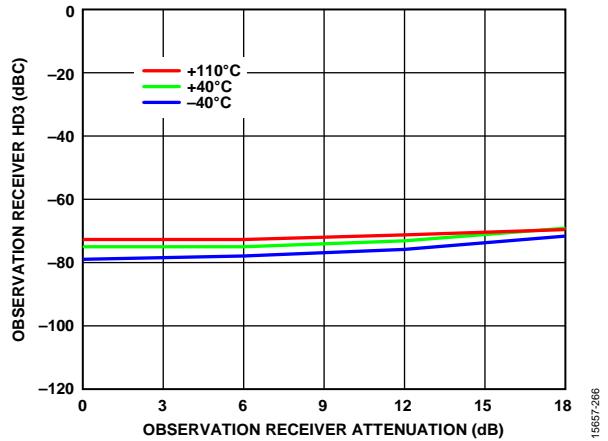


Figure 229. Observation Receiver HD3 vs. Observation Receiver Attenuation, 5600 MHz LO, CW Signal 30 MHz Offset, -15 dBm Input, Input Power Increasing Decibel for Decibel with Attenuation, 200 MHz RF Bandwidth, 245.76 MSPS Sample Rate

## THEORY OF OPERATION

The AD9375 is a highly integrated RF transceiver that can be configured for a wide range of applications. The device integrates all the RF, mixed-signal, and digital blocks necessary to provide transmit and receive functions in a single device. Programmability allows the two receiver channels and two transmitter channels to be used in TDD and FDD systems for 3G and 4G cellular standards.

The observation receiver channel has two inputs for use in monitoring the transmitter outputs. This channel has a wide channel bandwidth that receives the entire transmit band and feeds it back to the digital section for error correction purposes. In addition, three sniffer receiver inputs can monitor different radio frequency bands (one at a time). These channels share the baseband ADC and digital processing with the two ORx inputs.

The AD9375 contains four high speed serial interface links for the transmit chain and four high speed serial interface links shared by the Rx, ORx, and SnRx channels (JESD204B, Subclass 1 compliant), providing a low pin count and reliable data interface to a field-programmable gate array (FPGA) or other custom integrated baseband solutions.

The AD9375 also provides self calibration for dc offset and quadrature error correction to maintain a high performance level under varying temperatures and input signal conditions. The device includes test modes that allow system designers to debug designs during prototyping and optimize radio configurations.

### TRANSMITTER (Tx)

The AD9375 employs a direct conversion transmitter architecture consisting of two identical and independently controlled channels that provide all the digital processing, mixed-signal, and RF blocks necessary to implement a direct conversion system. Both channels share a common frequency synthesizer.

The digital data from the JESD204B lanes pass through a fully programmable 96-tap FIR filter with optional interpolation. The FIR output is sent to a series of conversion filters that provide additional filtering and data rate interpolation prior to reaching the DAC. Each DAC has an adjustable sample rate and is linear up to full scale.

Once converted to baseband analog signals, the in-phase (I) and quadrature (Q) signals are filtered to remove sampling artifacts, and then the signals are fed to the upconversion mixers. At the mixer stage, the I and Q signals are recombined and modulated onto the carrier frequency for transmission to the output stage. Each transmit chain provides a wide attenuation adjustment range with fine granularity to help designers optimize SNR.

### RECEIVER (Rx)

The AD9375 contains dual receiver channels. Each Rx channel is a direct conversion system that contains a programmable attenuator stage, followed by matched I and Q mixers that downconvert received signals to baseband for digitization.

To achieve gain control, a programmed gain index map is implemented. This gain map distributes attenuation among the various Rx blocks for optimal performance at each power level. In addition, support is available for both automatic and manual gain control modes.

The receiver includes Σ-Δ ADCs and adjustable sample rates that produce data streams from the received signals. The signals can be conditioned further by a series of decimation filters and a fully programmable 72-tap FIR filter with additional decimation settings. The sample rate of each digital filter block is adjustable by changing the decimation factors to produce the desired output data rate.

### OBSERVATION RECEIVER (ORx)

The ORx operates in a similar manner to the main receivers. Each input is differential and uses a dedicated mixer. The ORx inputs share a baseband ADC and baseband section; therefore, only one can be active at any time. The mixed signal and digital section is identical in design and operation to the main receiver channels. This channel can monitor the Tx channels and implement error correction functions. It can also be used as a general-purpose receiver.

### SNIFFER RECEIVER (SnRx)

The sniffer receiver provides three differential inputs that can monitor different frequency bands. Each input has a low noise amplifier (LNA) that is multiplexed to feed a single mixer. The output of this mixer stage is multiplexed with the ORx receiver mixers to feed the same baseband section. The SnRx bandwidth is limited to 20 MHz. This receiver can also be used as a general-purpose receiver if the bandwidth and RF performance are acceptable for a given application. The sniffer channel is also limited to operation from 300 MHz to 4000 MHz. Performance cannot be guaranteed for LO settings above 4000 MHz.

These receiver inputs also provide an LNA bypass mode that removes the gain of the LNA when large signals are present. Note that no requirements for the LNA bypass mode are included in Table 1; performance specifications are only relative to the scenario in which the LNA is enabled.

### CLOCK INPUT

The AD9375 requires a differential clock connected to the DEV\_CLK\_IN+/DEV\_CLK\_IN- pins. The frequency of the clock input must be between 10 MHz and 320 MHz, and it must have very low phase noise because this signal generates the RF local oscillator and internal sampling clocks.

## SYNTHEZERS

### RF PLL

The AD9375 contains three fractional-N PLLs to generate the RF LOs used by the transmitter, receiver, and observation receiver. The PLL incorporates an internal VCO and loop filter that require no external components. The internal VCO LDO regulators eliminate the need for additional external power supplies for the PLLs. These regulators only require an external bypass capacitor for each supply.

### Clock PLL

The AD9375 contains a PLL synthesizer that generates all of the baseband related clock signals and SERDES clocks. This PLL is programmed based on the data rate and sample rate requirements of the system.

## SERIAL PERIPHERAL INTERFACE (SPI)

The AD9375 uses a SPI to communicate with the baseband processor (BBP). This interface can be configured as a 4-wire interface with dedicated receive and transmit ports, or it can be configured as a 3-wire interface with a bidirectional data communications port. This bus allows the BBP to set all device control parameters using a simple address data serial bus protocol.

Write commands follow a 24-bit format. The first bit sets the bus direction of the bus transfer. The next 15 bits set the address where data is written. The final eight bits are the data being transferred to the specific register address.

Read commands follow a similar format with the exception that the first 16 bits are transferred on the SDIO pin, and the final eight bits are read from the AD9375, either on the SDO pin in 4-wire mode or on the SDIO pin in 3-wire mode.

## GPIO\_x AND GPIO\_3P3\_x PINS

The AD9375 general-purpose input/output signals referenced to the VDD\_IF supply can be configured for numerous functions. Some of these pins, when configured as outputs, are used by the BBP as real-time signals to provide a number of internal settings and measurements. This configuration allows the BBP to monitor receiver performance in different situations. A pointer register selects the information that is output to these pins. Signals used for manual gain mode, calibration flags, state machine states, and various receiver parameters are among the outputs that can be monitored on these pins. In addition, certain pins can be configured as inputs and used in various functions such as setting the receiver gain in real time.

The GPIO\_3P3\_x pins are referenced to the VDDA\_3P3 supply. These pins can provide control signals to other components such as voltage gain amplifiers (VGAs) or attenuators in the RF section that typically use a higher reference voltage.

## AUXILIARY CONVERTERS

### Auxiliary ADC Inputs (AUXADC\_x)

The AD9375 contains an auxiliary ADC that is multiplexed to four input pins (AUXADC\_0 through AUXADC\_3). This block can monitor system voltages without adding additional components. The auxiliary ADC is 12 bits with an input voltage range of 0.05 V to VDDA\_3P3 – 0.05 V. When enabled, the auxiliary ADC is free running. Software reads of the output value provide the last value latched at the ADC output.

### Auxiliary DACs (AUXDAC\_x)

The AD9375 contains 10 identical auxiliary DACs (AUXDAC\_0 to AUXDAC\_9) that can supply bias voltages, analog control voltages, or other system functionality. The inputs of these auxiliary DACs (AUXDAC\_0 to AUXDAC\_9) are multiplexed with the GPIO\_3P3\_x pins according to Table 7. The auxiliary DACs are 10 bits, have an output voltage range of approximately 0.5 V to 3.0 V, and have a current drive of 10 mA.

**Table 7. AUXDAC Input Pin Assignments**

AUXDAC_x Output	GPIO_3P3_x Pin
AUXDAC_0	GPIO_3P3_9
AUXDAC_1	GPIO_3P3_7
AUXDAC_2	GPIO_3P3_6
AUXDAC_3	GPIO_3P3_10
AUXDAC_4	GPIO_3P3_0
AUXDAC_5	GPIO_3P3_1
AUXDAC_6	GPIO_3P3_3
AUXDAC_7	GPIO_3P3_4
AUXDAC_8	GPIO_3P3_5
AUXDAC_9	GPIO_3P3_8

## JESD204B DATA INTERFACE

The digital data interface for the AD9375 uses JEDEC Standard JESD204B Subclass 1. The serial interface operates at speeds of up to 6144 Mbps. The benefits of the JESD204B interface include a reduction in required board area for data interface routing and smaller package options due to the need for fewer pins. Digital filtering is included in all receiver and transmitter paths to provide proper signal conditioning and sampling rates to meet the JESD204B data requirements. Examples of the digital filtering configurations for the Tx and Rx paths are shown in Figure 230 and Figure 231, respectively.

## POWER SUPPLY SEQUENCE

The AD9375 requires a specific power-up sequence to avoid undesired power-up currents. The optimal power-on sequence starts the process by powering up the VDIG and the VDDA\_1P3 (analog) supplies simultaneously. If they cannot power up simultaneously, the VDIG supply must power up first. The VDDA\_3P3, VDDA\_1P8, and JESD\_VTT\_DES supplies must then power up after the VDIG and VDDA\_1P3 supplies. Note that the VDD\_IF supply can power up at any time. It is also recommended to toggle the RESET signal after power has stabilized prior to configuration. Follow the reverse order of the power-up sequence to power down.

**Table 8. Example Rx/Tx Interface Rates (Two Rx/Two Tx Channels, Maximum JESD204B Lane Rates)**

Tx/Tx Synthesis/ Rx Bandwidth (MHz)	Tx Input Rate (MSPS)	Rx Output Rate (MSPS)	JESD204B Lane Rate (Mbps), Two Tx/Two Rx	JESD204B (No. of Lanes) Tx/Rx	Reference Clock Options (MHz)
100/250/100	307.2	153.6	6144	4/2	122.88, 153.6, 245.76, 307.2
75/200/100	245.76	122.88	4915.2	4/2	122.88, 245.76
20/100/40	122.88	61.44	2457.6	4/2	122.88, 245.76
20/100/20	122.88	30.72	2457.6	4/1	122.88, 245.76

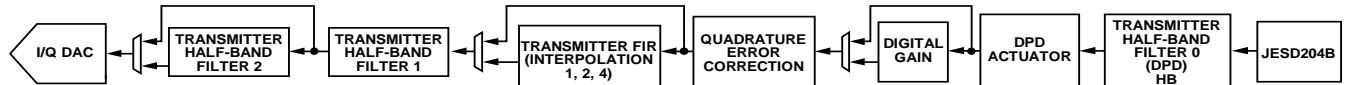


Figure 230. Example Tx Data Path Filter Implementation

15657-125

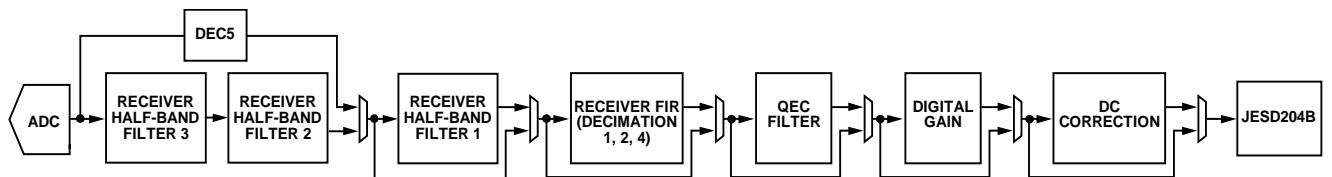


Figure 231. Data Rx Data Path Filter Implementation

15657-126

## DIGITAL PREDISTORTION (DPD)

This device provides a fully integrated DPD function that linearizes the output of the power amplifier (PA) of the transmit system by altering the digital waveform to compensate for nonlinearities in the PA response. Both the DPD actuator and coefficient calculation engine are integrated. This functionality uses the ORx channel to monitor the output of the PA and calculates the appropriate predistortion to linearize the output. The integrated DPD capability allows the system to drive the PA closer to saturation, enabling a higher efficiency PA while maintaining linearity. The DPD is optimized for small cell PAs with rms output powers in the 250 mW to 10 W range and for a maximum occupied signal bandwidth of 40 MHz. The additional power consumed by the DPD block when enabled is less than 100 mW.

Performance enhancement is shown in Figure 232 for a 20 MHz LTE signal and in Figure 233 for a 40 MHz LTE output. In both cases, a Band 7 Skyworks SKY66297 high efficiency PA is used to demonstrate the adjacent channel level reduction (ACLR) improvement for a particular device. Table 9 and Table 10 show the details of ACLR improvement that are achieved for these two scenarios when DPD is activated. Note that the magnitude of improvement in ACLR is heavily PA dependent and generally degrades as signal bandwidth increases.

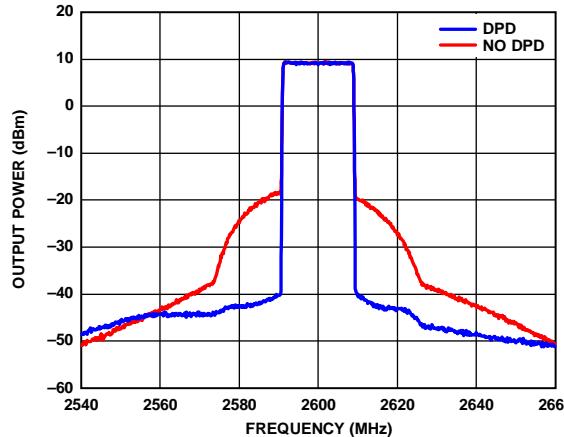


Figure 232. Output Spectrum for Normal Operation (Red) and with DPD Activated (Blue) for a 20 MHz LTE Signal

15657-532

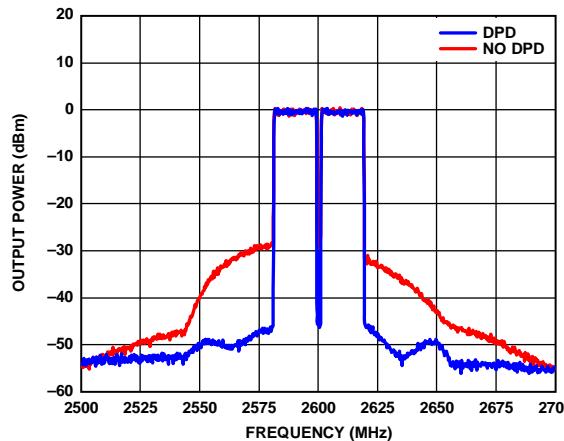


Figure 233. Output Spectrum for Normal Operation (Red) and with DPD Activated (Blue) for a 40 MHz LTE Output

15657-533

Table 9. ACLR Comparison With and Without DPD for a 20 MHz LTE Waveform

Mode <sup>1</sup>	20 MHz Offset (dBc)		40 MHz Offset (dBc)		60 MHz Offset (dBc)	
	Lower	Upper	Lower	Upper	Lower	Upper
Normal Operation	-32.15	-34.18	-51.71	-51.16	-59.29	-58.99
DPD Activated	-50.89	-51.90	-52.63	-56.57	-57.23	-59.49

<sup>1</sup> Waveform is 10 ms (full-frame) LTE evolved universal terrestrial radio access (E-UTRA) Test Model 1.1 (E-TM 1.1) at 7.5 dB peak to average ratio (PAR), with crest factor reduction (CFR), 28 dBm output, and 18.02 MHz occupied bandwidth.

Table 10. ACLR Comparison With and Without DPD for a 40 MHz LTE Waveform

Mode <sup>1</sup>	20 MHz Offset (dBc)		40 MHz Offset (dBc)		60 MHz Offset (dBc)	
	Lower	Upper	Lower	Upper	Lower	Upper
Normal Operation	-29.74	-33.69	-37.45	-41.65	-48.31	-47.95
DPD Activated	-47.42	-48.22	-49.84	-49.62	-52.06	-54.38

<sup>1</sup> Waveform is 10 ms (full frame) LTE E-UTRA Test Model 1.1 (E-TM 1.1) at 7.5 dB PAR (with CFR), 27 dBm output, and 36.04 MHz occupied bandwidth.

## JTAG BOUNDARY SCAN

The AD9375 provides support for a JTAG boundary scan. Five dual-function pins are associated with the JTAG interface. These pins, listed in Table 11, are used to access the on-chip test access port. To enable the JTAG functionality, set the GPIO\_0 through GPIO\_3 pins according to Table 12 depending on how the desired JESD204B sync pin (that is, SYNCINB0+, SYNCINB0-, SYNCINB1+, SYNCINB1-, SYNCOUTB0+, or SYNCOUTB0-) is configured in the software (LVDS or CMOS mode). Pull the TEST pin high to enable the JTAG mode.

**Table 11. Dual-Function Boundary Scan Test Pins**

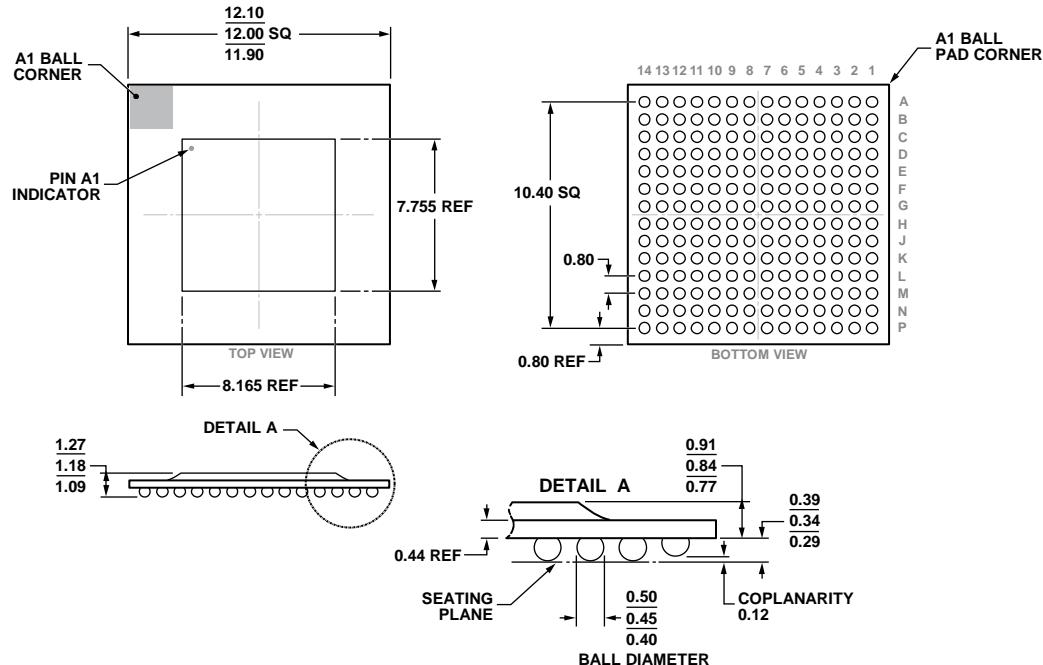
Mnemonic	JTAG Mnemonic	Description
GPIO_4	TRST	Test access port reset
GPIO_5	TDO	Test data output
GPIO_6	TDI	Test data input
GPIO_7	TMS	Test access port mode select
GPIO_18	TCK	Test clock

**Table 12. JTAG Modes**

Test Pin Level	GPIO_0 to GPIO_3	Description
0	XXXX <sup>1</sup>	Normal operation
1	1001	JTAG mode with LVDS JESD204B sync signals
1	1011	JTAG mode with CMOS JESD204B sync signals

<sup>1</sup> X means don't care.

## OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-275-GGAB-1.

Figure 234. 196-Ball Chip Scale Package Ball Grid Array [CSP\_BGA]  
(BC-196-12)  
Dimensions shown in millimeters

PIG04104B  
03-02-2015-A

## ORDERING GUIDE

Model <sup>1</sup>	Temperature Range <sup>2</sup>	Package Description	Package Option
AD9375BBCZ	-40°C to +85°C	196-Ball Chip Scale Package Ball Grid Array [CSP_BGA]	BC-196-12
AD9375BBCZ-REEL	-40°C to +85°C	196-Ball Chip Scale Package Ball Grid Array [CSP_BGA]	BC-196-12
ADRV9375-N/PCBZ		Evaluation Board, 2600 MHz Matching Circuits	

<sup>1</sup> Z = RoHS-Compliant Part.

<sup>2</sup> See the Thermal Resistance section.